



Test report No. : 10499187S-G
Page : 1 of 98
FCC ID : EW4DWMW314
Issued date : November 19, 2014
Revised date : November 26, 2014

RADIO TEST REPORT

Test Report No.: 10499187S-G

Applicant : MITSUMI ELECTRIC CO., LTD.

Type of Equipment : Wireless LAN + BT/BLE Module

Model No. : DWM-W314

FCC ID : EW4DWMW314

Test regulation : FCC Part15 Subpart C: 2014

Test result : Complied

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with the limits of the above regulation.
4. The test results in this test report are traceable to the national or international standards.
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6. The opinions and the interpretations to the result of the description in this report are outside scopes where UL Japan has been accredited.

Date of test: October 13 to 30, 2014

Representative test engineer:

Shinichi Takano
Engineer
Consumer Technology Division

Approved by :

Toyokazu Imamura
Leader
Consumer Technology Division



- The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.
 There is no testing item of "Non-accreditation".

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Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

13-EM-F0429

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SECTION 1: Customer information

Company Name : MITSUMI ELECTRIC CO., LTD.
Address : 2-11-2, Tsurumaki, Tama-shi, Tokyo, 206-8567 JAPAN
Telephone Number : +81-42-310-5801
Facsimile Number : +81-42-310-5598
Contact Person : Yuki Takakura

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of equipment : Wireless LAN + BT/BLE Module
Model No. : DWM-W314
Serial No. : Refer to 4.2 in this report.
Rating : DC3.3V
Country of Mass-production : Philippines
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No modification by the test lab.
Receipt Date of Sample : September 26, 2014

2.2 Product description

Model: DWM-W314 (referred to as the EUT in this report) is Wireless LAN + BT/BLE Module.

Clock frequency(ies) in the system : 32.768kHz, 26MHz
Antenna type : Monopole type chip antenna
Antenna gain : -9.2dBi
Antenna connector type : None (It exist the connector for only the tests of shipment.)
Operation temperature range : -20 to +70 deg.C

<Bluetooth part>

Equipment type : Transceiver
Frequency of operation : 2402-2480MHz
Bandwidth / channel spacing : 79MHz / 1MHz (BDR/EDR) & 2MHz (Low Energy)
Type of modulation : FHSS (GFSK, $\pi/4$ -DQPSK, 8DPSK), DSSS (GFSK)
ITU code : F1D, G1D

<Wireless LAN part>

Equipment type : Transceiver
Frequency of operation : 2412-2462MHz
Bandwidth / channel spacing : 20MHz / 5MHz
Type of modulation : DSSS, OFDM
ITU code : D1D, G1D

* For Bluetooth BDR/EDR part, refer to the test report: 10499187S-H.

FCC 15.31 (e) / 212

The Wireless LAN + BT/BLE Module has its own regulator.

The module is constantly provided voltage (DC1.8V) through the regulator regardless of input voltage. Therefore, this EUT complies with the requirement.

FCC 15.203 / 212

It is impossible for end users to replace the antenna, because it is soldered on the circuit board.
Therefore the equipment complies with the requirement of 15.203/212.

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SECTION 3: Test specification, procedures & results

3.1 Test specification

Test specification : FCC Part 15 Subpart C: 2014, final revised on August 15, 2014 and effective October 14, 2014
 Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
 Section 15.207 Conducted limits
 Section 15.209 Radiated emission limits, general requirements
 Section 15.247 Operation within the bands 902-928MHz, 2400-2483.5MHz,
 and 5725-5850MHz

* The revision on August 15, 2014 does not affect the test specification applied to the EUT.

3.2 Procedures & Results

Item	Test Procedure *1)	Specification	Remarks	Deviation	Worst Margin	Results
Conducted emission	ANSI C63.10:2009	FCC 15.207	-	N/A	20.6dB Freq.: 0.43708MHz Detection: Quasi-Peak Phase: L1 Mode: Tx 11g 2412MHz	Complied
6dB bandwidth	ANSI C63.10:2009	FCC 15.247 (a)(2)	Conducted	N/A	* See data	Complied
Maximum peak output power	ANSI C63.10:2009	FCC 15.247 (b)(3)	Conducted	N/A		Complied
Out of band emission & Restricted band edges	ANSI C63.10:2009	FCC 15.109, 15.247 (d) & 15.209	Conducted / Radiated	N/A	0.5 dB Freq.: 7320.000 MHz Polarization: Vertical Detection: Average Mode: Tx, Bluetooth Low Energy 2440 MHz	Complied
Power density	ANSI C63.10:2009	FCC 15.247 (e)	Conducted	N/A	* See data	Complied

Note: UL Japan's EMI Work Procedures No.13-EM-W0420 and 13-EM-W0422.
 *1) These tests were also referred to KDB 558074 v03 r02 (FCC), "Guidance for Performing Compliance Measurements on Digital Transmission Systems (DTS) Operating Under §15.247".

3.3 Addition to standard

Item	Test Procedure	Specification	Remarks	Worst Margin	Results
Occupied Bandwidth (99%)	ANSI C63.10:2009, RSS-Gen 4.6.1	-	Conducted	-	-

Note: UL Japan's Work Procedures No. 13-EM-W0420 and 13-EM-W0422

* Other than above, no addition, exclusion nor deviation has been made from the standard.

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3.4 Uncertainty

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Item	Frequency range	No.1 SAC ^{*1} /SR ^{*2} (±)	No.2 SAC/SR (±)	No.3 SAC/SR (±)
Conducted emission (AC Mains) LISN	150kHz-30MHz	3.6 dB	3.4 dB	3.4 dB
Radiated emission (Measurement distance: 3m)	9kHz-30MHz	3.7 dB	3.5 dB	3.5 dB
	30MHz-300MHz	4.9 dB	4.9 dB	4.7 dB
	300MHz-1GHz	5.0 dB	5.0 dB	4.8 dB
	1GHz-15GHz	4.9 dB	4.9 dB	4.9 dB
Radiated emission (Measurement distance: 1m)	15GHz-18GHz	5.7 dB	5.7 dB	5.7 dB
	18GHz-40GHz	4.5 dB	4.3 dB	4.3 dB

*1: SAC=Semi-Anechoic Chamber

*2: SR= Shielded Room is applied besides radiated emission

Conducted emission test

The data listed in this test report has enough margin, more than the site margin.

Radiated emission test

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

Antenna port conducted test

Power measurement uncertainty above 1GHz for this test was: (±) 0.68dB

Spurious emission (Conducted) measurement (below 1GHz) uncertainty for this test was: (±) 1.5dB

Spurious emission (Conducted) measurement (1G-3GHz) uncertainty for this test was: (±) 1.7dB

Spurious emission (Conducted) measurement (3G-18GHz) uncertainty for this test was: (±) 2.4dB

Spurious emission (Conducted) measurement (18G-26.5GHz) uncertainty for this test was: (±) 2.5dB

Bandwidth Measurement uncertainty for this test was: (±) 0.66%

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3.5 Test location

UL Japan, Inc. Shonan EMC Lab.
1-22-3, Megumigaoka, Hiratsuka-shi, Kanagawa-ken 259-1220 JAPAN
Telephone number : +81 463 50 6400
Facsimile number : +81 463 50 6401
JAB Accreditation No. : RTL02610

	IC Registration No.	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Maximum measurement distance
<input type="checkbox"/> No.1 Semi-anechoic chamber	2973D-1	20.6 x 11.3 x 7.65	20.6 x 11.3	10m
<input checked="" type="checkbox"/> No.2 Semi-anechoic chamber	2973D-2	20.6 x 11.3 x 7.65	20.6 x 11.3	10m
<input checked="" type="checkbox"/> No.3 Semi-anechoic chamber	2973D-3	12.7 x 7.7 x 5.35	12.7 x 7.7	5m
<input type="checkbox"/> No.4 Semi-anechoic chamber	-	8.1 x 5.1 x 3.55	8.1 x 5.1	-
<input checked="" type="checkbox"/> No.1 Shielded room	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
<input type="checkbox"/> No.2 Shielded room	-	6.8 x 4.1 x 2.7	6.8 x 4.1	-
<input type="checkbox"/> No.3 Shielded room	-	6.3 x 4.7 x 2.7	6.3 x 4.7	-
<input type="checkbox"/> No.4 Shielded room	-	4.4 x 4.7 x 2.7	4.4 x 4.7	-
<input type="checkbox"/> No.5 Shielded room	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
<input checked="" type="checkbox"/> No.6 Shielded room	-	7.8 x 6.4 x 2.7	7.8 x 6.4	-
<input type="checkbox"/> No.7 Shielded room	-	2.76 x 3.76 x 2.4	2.76 x 3.76	-
<input type="checkbox"/> No.8 Shielded room	-	3.45 x 5.5 x 2.4	3.45 x 5.5	-
<input checked="" type="checkbox"/> No.1 Measurement room	-	2.55 x 4.1 x 2.5	2.55 x 4.1	-

3.6 Test setup, Test data & Test instruments

Refer to APPENDIX 1 to 3.

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating mode

Test item	Mode	Tested frequency	Worst data mode *1)	Power setting [dBm] *3)
Conducted emission Radiated emission (below 1GHz)	Transmitting(Tx) IEEE 802.11g *2)	2412MHz *2)	PN9, 2Mbps	12
	Transmitting(Tx) Hopping OFF Low Energy(LE), Payload: PRBS9	2402MHz, 2440MHz, 2480MHz	-	Fixed
Radaited emission (Spurious emission) (Above 1GHz)	Transmitting(Tx) IEEE 802.11b	2412MHz, 2437MHz, 2462MHz	PN9, 2Mbps	12
	Transmitting(Tx) IEEE 802.11g	2412MHz, 2437MHz, 2462MHz	PN9, 48Mbps	12
	Transmitting(Tx) IEEE 802.11n HT20	2412MHz, 2437MHz, 2462MHz	PN9, MCS5	12
	Transmitting(Tx) Hopping OFF Low Energy(LE), Payload: PRBS9	2402MHz, 2440MHz, 2480MHz	-	Fixed
Other items	Transmitting(Tx) IEEE 802.11b	2412MHz, 2437MHz, 2462MHz	PN9, 2Mbps	4, 12
	Transmitting(Tx) IEEE 802.11g	2412MHz, 2437MHz, 2462MHz	PN9, 48Mbps	4, 12
	Transmitting(Tx) IEEE 802.11n HT20	2412MHz, 2437MHz, 2462MHz	PN9, MCS5	4, 12
	Transmitting(Tx) Hopping OFF Low Energy(LE), Payload: PRBS9	2402MHz, 2440MHz, 2480MHz	-	Fixed

*1) The worst condition was determined based on the test result of Maximum Peak Output Power.

*2) Test operating mode was determined as follows according to "Section 1 of 6 802.11 a/b/g/n testing- Managing Complex Regulatory Approvals - " of TCB Council Workshop October 2009.

*3) Lowest power setting mode was performed only worst mode (maximum peak conducted output power mode).

(Wireless LAN mode)

Software : driver1 (for Linux PC): sd87xx (for Wireless LAN) ver.14.66.33.p71
 : bridge tool (for Linux PC):: mfgbridge ver.0.1.0.26
 : DutApiBRIDGEETH8777.exe ver.14.2.33.p37 (for Windows PC):

(Bluetooth Low energy mode)

Software : driver1 (for Linux PC):: sd87xx (for Wireless LAN) ver.14.66.33.p71
 : driver2 (for Linux PC):: bt87xx (for Bluetooth) ver.14.66.33.p71
 : bridge tool (for Linux PC):: mfgbridge ver.0.1.0.26
 : DutApiBRIDGEETH8777.exe ver.14.2.33.p37 (for Windows PC):

Justification: The system was configured in typical fashion (as customer would normally use it) for testing.

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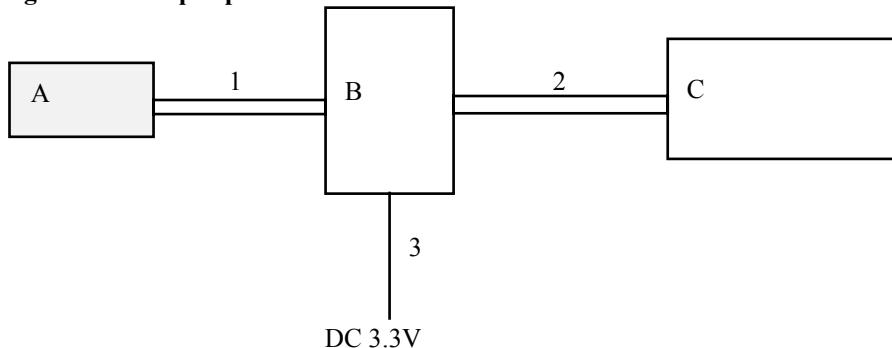
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Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

4.2 Configuration and peripherals



* Test data was taken under worse case conditions.

Description of EUT and support equipment

No.	Item	Model number	Serial number	Manufacturer	Remark
A	Wireless LAN + BT/BLE Module	DWM-W314	2	MITSUMI	EUT
B	Jig	-	-	MITSUMI	-
C	Jig (SD card I/F board)	-	-	MITSUMI	-

List of cable used

No.	Cable name	Length (m)	Shield		Remark
			Cable	Connector	
1	Signal	0.1	Unshielded	Unshielded	-
2	Signal	0.15	Unshielded	Unshielded	-
3	DC cable	1.3	Unshielded	Unshielded	-

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SECTION 5: Conducted emission

5.1 Operating environment

Test place : See test data (APPENDIX 1)
Temperature : See test data (APPENDIX 1)
Humidity : See test data (APPENDIX 1)

5.2 Test configuration

EUT was placed on a platform of nominal size, 1m by 2.0m, raised 0.8m above the conducting ground plane. The table is made of Styrofoam and covered with polyvinyl chloride. That has very low permittivity. The rear of tabletop was located 40cm to the vertical conducting plane. The rear of peripheral was aligned and was flushed with rear of tabletop. All other surfaces of tabletop were at least 80cm from any other grounded conducting surface. EUT was located 80cm from LISN. Each EUT current-carrying power lead, except the ground (safety) lead, was individually connected through a LISN to the input power source. All unused 50ohm connectors of the LISN were resistively terminated in 50ohm when not connected to the measuring equipment. Photographs of the set up are shown in APPENDIX 3.

5.3 Test conditions

Frequency range : 0.15 - 30MHz
EUT position : Table top

5.4 Test procedure

The AC Mains Terminal Continuous disturbance Voltage had been measured with the EUT via DC power supply within a Shielded room. The EUT via DC power supply was connected to a Line Impedance Stabilization Network (LISN).

An overview sweep with peak detection has been performed.

The measurements had been performed with a quasi-peak detector and if required, a CISPR average detector.

The conducted emission measurements were made with the following detection of the test receiver.

Detection Type : Quasi-Peak/ CISPR Average
IF Bandwidth : 9kHz

5.5 Results

Summary of the test results : Pass
Refer to APPENDIX 1

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Facsimile : +81 463 50 6401

SECTION 6: 6dB bandwidth & Occupied bandwidth (99%)

Test procedure

The bandwidth was measured with a spectrum analyzer connected to the antenna port.
The test was measured based on Method 8.1 Option 1 and 8.2 Option 2 of KDB 558074 "Guidance for Performing Compliance Measurements on Digital Transmission Systems (DTS) Operating Under §15.247".

Summary of the test results: Pass

Refer to APPENDIX 1

SECTION 7: Maximum peak output power

Test procedure

The Maximum Output Power was measured with a power meter connected to the antenna port.
The test was measured based on Method 9.1.2 PKPM1 of KDB 558074 "Guidance for Performing Compliance Measurements on Digital Transmission Systems (DTS) Operating Under §15.247".

Detection type: Peak / Average *1)

Summary of the test results: Pass

Refer to APPENDIX 1

*1) Average detector was used only for Reference data.

SECTION 8: Out of band emissions (Antenna port conducted)

Test procedure

The Out of Band Emissions was measured with a spectrum analyzer connected to the antenna port.
The radio frequency power that is produced by the intentional radiator confirmed 20dB below that in the 100kHz bandwidth within the band that contains the highest level of the desired power, based on a radiated measurement.
In the frequency range below 30MHz, RBW was narrowed to separate the noise contents.
Then, wide-band noise near the limit was checked separately, however the noise was not detected as shown in the chart.
(9kHz-150kHz:RBW=200Hz, 150kHz-30MHz:RBW=10kHz)

Summary of the test results: Pass

Refer to APPENDIX 1

SECTION 9: Peak power density

Test procedure

The peak power density was measured with a spectrum analyzer connected to the antenna port.

Instrument used : Spectrum Analyzer
RBW / VBW : 3kHz / 9.1kHz

The test was measured based on Method 10.2 PKPSD of KDB 558074 "Guidance for Performing Compliance Measurements on Digital Transmission Systems (DTS) Operating Under §15.247".

Summary of the test results: Pass

Refer to APPENDIX 1

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Facsimile : +81 463 50 6401

SECTION 10: Radiated emission

10.1 Operating environment

Test place : See test data (APPENDIX 1)
 Temperature : See test data (APPENDIX 1)
 Humidity : See test data (APPENDIX 1)

10.2 Test configuration

EUT was placed on a polystyrene platform of nominal size, 0.5m by 0.5m, raised 0.8m above the conducting ground plane. Photographs of the set up are shown in APPENDIX 3.

10.3 Test conditions

Frequency range : 30MHz to 25GHz
 EUT position : Table top

10.4 Test procedure

The Radiated Electric Field Strength intensity has been measured on a semi-anechoic chamber with a ground plane and at a distance of 3m (below 15GHz) / 1m (above 15GHz) (Refer to Figure 1). Measurements were performed with quasi-peak, peak and average detector. The measuring antenna height was varied between 1 and 4m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity. The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detection.

Frequency	30-1000MHz	1-25GHz	20dBc
Detection type	Quasi-Peak	Peak	Average *1)
IF Bandwidth	120kHz	RBW: 1MHz VBW: 3MHz Detector: Linear Voltage Averaging	RBW: 100kHz VBW: 300kHz

*1) Average Power Measurement was measured based on 12.2.5 of KDB 558074 "Guidance for Performing Compliance Measurements on Digital Transmission Systems (DTS) Operating Under §15.247".

The carrier levels and noise levels were confirmed at each position of X, Y and Z axes to see the position of maximum noise, and the test was made at the position that has the maximum noise.

Wireless LAN mode

Antenna polarization	Carrier	Spurious (Below 1GHz)	Spurious (1-15GHz)	Spurious (15-18GHz)	Spurious (18-25GHz)
Horizontal	X	Z	Y	X	X
Vertical	Z	Z	Z	X	X

Bluetooth Low energy mode

Antenna polarization	Carrier	Spurious (Below 1GHz)	Spurious (1-15GHz)	Spurious (15-18GHz)	Spurious (18-25GHz)
Horizontal	X	Y	Y	Y	Y
Vertical	Z	Y	Y	Y	Y

* The definition of each position is shown in a 'Pre-check of the worst position' in APPENDIX 3.

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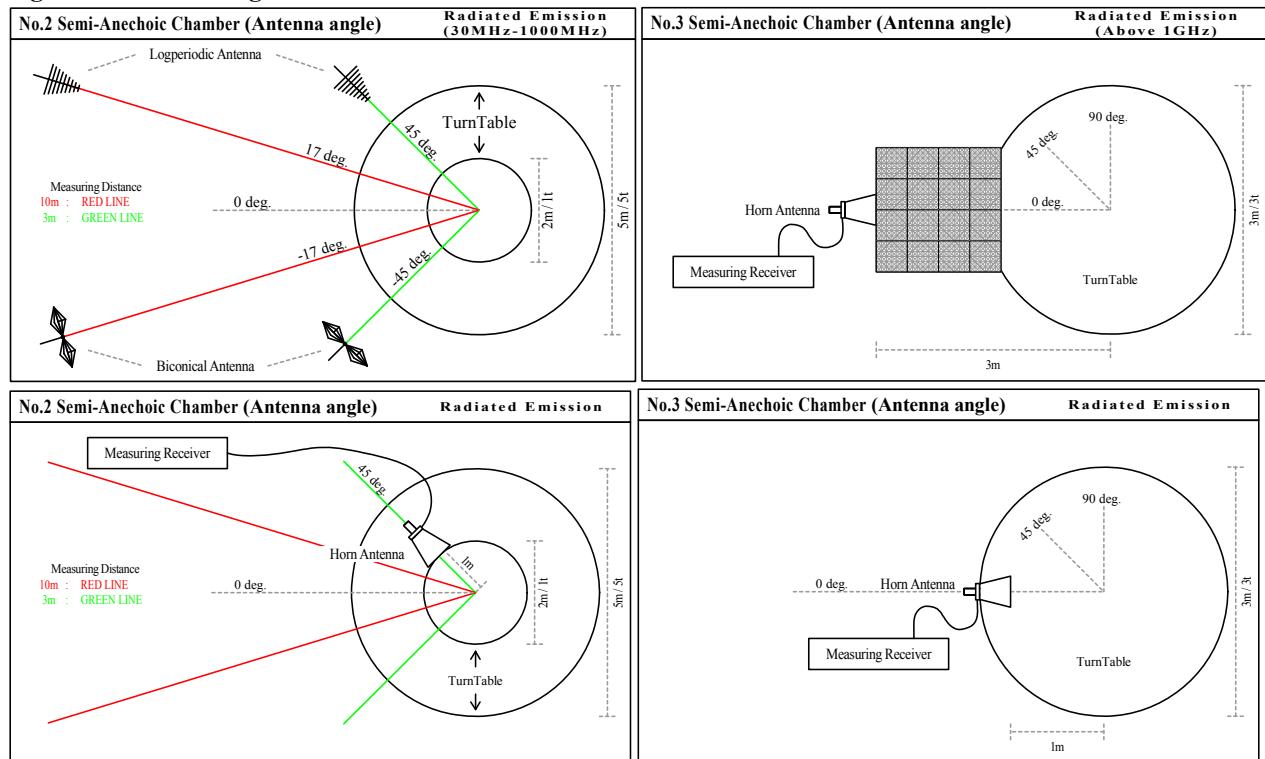
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Faxsimile : +81 463 50 6401

Figure 1. Antenna angle



10.5 Band edge

Band edge level at 2390MHz and 2483.5MHz is below the limits of FCC 15.209 and band edge level at 2400MHz is below the 20dBc. Refer to the data.

10.6 Results

Summary of the test results : Pass
 * No noise was detected above the 5th order harmonics.

Refer to APPENDIX 1

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Facsimile : +81 463 50 6401

Contents of APPENDIXES

APPENDIX 1: Data of Radio tests

Conducted emission
6dB bandwidth
Maximum peak output power
Radiated emission
Spurious emission (Antenna port conducted)
Peak power density
Occupied bandwidth

APPENDIX 2: Test instruments

Test instruments

APPENDIX 3: Photographs of test setup

Conducted emission
Radiated emission
Pre-check of the worst position

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1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa-ken, 259-1220 JAPAN

Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

APPENDIX 1: Data of Radio tests**DATA OF CONDUCTED EMISSION TEST**

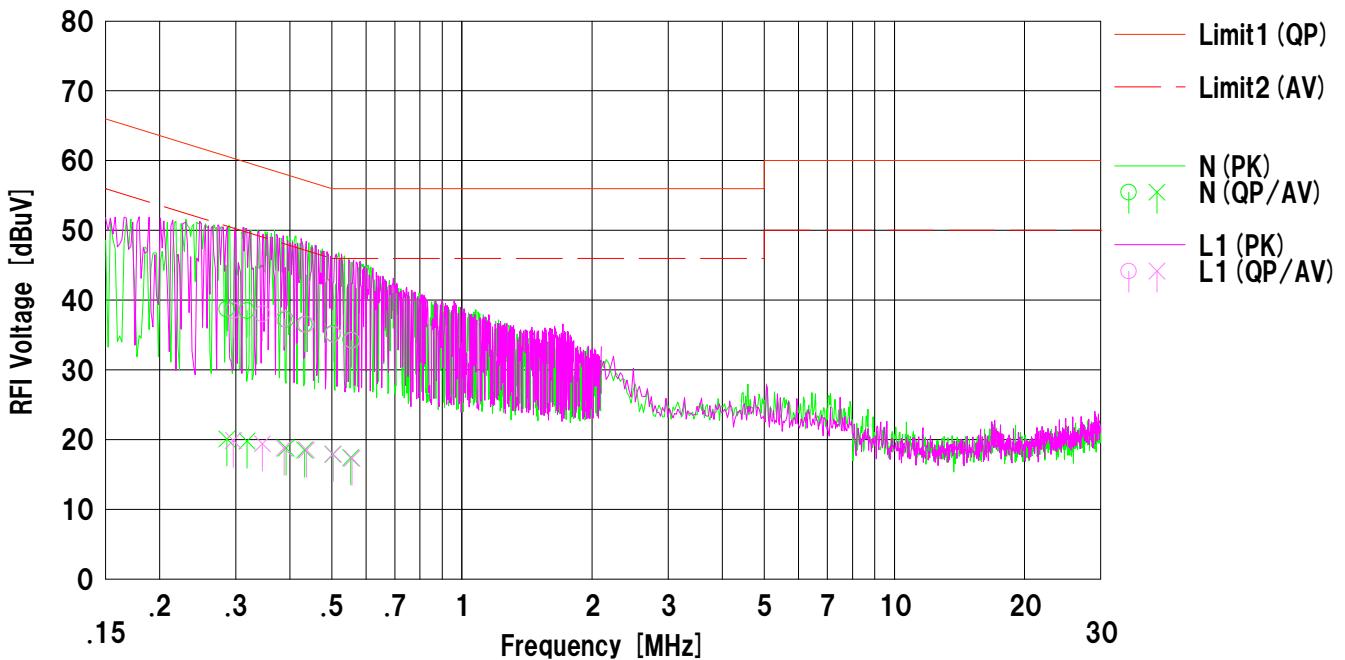
UL Japan, Inc. Shonan EMC Lab. No.1 Shielded Room
Date : 2014/10/30

Company : MITSUMI ELECTRIC CO., LTD.
Kind of EUT : Wireless LAN + BT/BLE Module
Model No. : DWM-W314
Serial No. : 2
Remarks : -

Mode : Tx 11g 2412MHz
Order No. : 10499187S
Power : DC 3.3V
Temp./Humi. : 25deg.C / 43%RH

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Shinichi Takano



No.	Freq. [MHz]	Reading		C.Fac [dB]	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<AV> [dBuV]		<QP> [dBuV]	<AV> [dBuV]	<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]		
1	0.28590	26.1	7.5	12.6	38.7	20.1	60.6	50.6	21.9	30.5	N	
2	0.31874	26.0	7.3	12.5	38.5	19.8	59.7	49.7	21.2	29.9	N	
3	0.39222	24.7	6.3	12.5	37.2	18.8	58.0	48.0	20.8	29.2	N	
4	0.43272	24.0	6.0	12.5	36.5	18.5	57.2	47.2	20.7	28.7	N	
5	0.50278	22.7	5.4	12.5	35.2	17.9	56.0	46.0	20.8	28.1	N	
6	0.55328	21.8	4.9	12.5	34.3	17.4	56.0	46.0	21.7	28.6	N	
7	0.29594	26.0	7.4	12.5	38.5	19.9	60.3	50.3	21.8	30.4	L1	
8	0.34557	25.5	6.9	12.5	38.0	19.4	59.0	49.0	21.0	29.6	L1	
9	0.38780	24.8	6.3	12.5	37.3	18.8	58.1	48.1	20.8	29.3	L1	
10	0.43708	24.0	6.0	12.5	36.5	18.5	57.1	47.1	20.6	28.6	L1	
11	0.50356	22.6	5.4	12.5	35.1	17.9	56.0	46.0	20.9	28.1	L1	
12	0.55728	21.7	4.8	12.5	34.2	17.3	56.0	46.0	21.8	28.7	L1	

Calculation:Result [dBuV] = Reading [dBuV] + C.Fac (LISN+Cable+ATT) [dB]
LISN:SLS-01

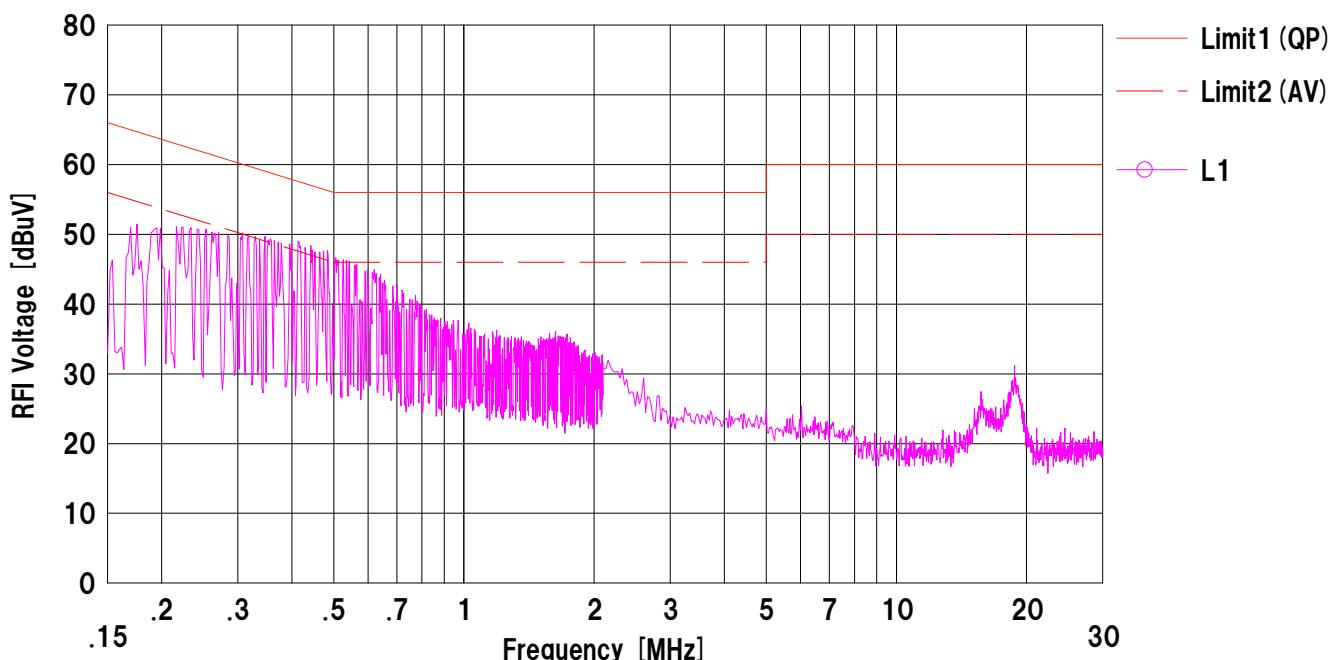
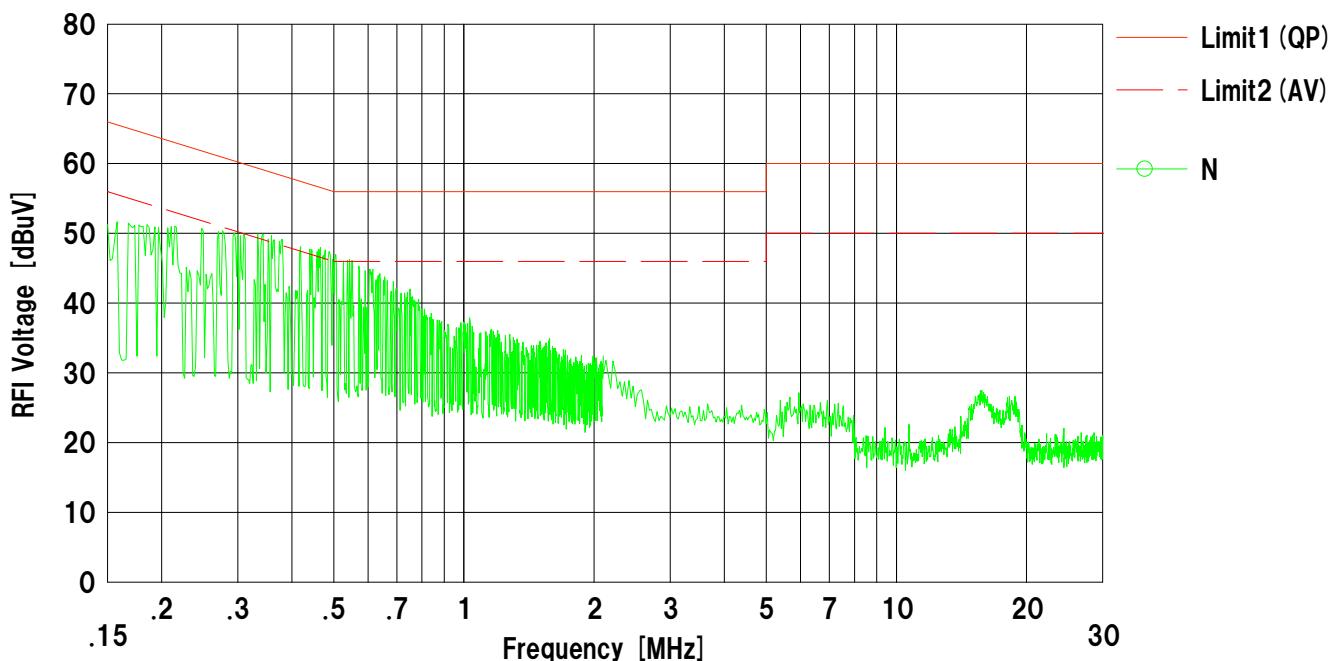
DATA OF CONDUCTED EMISSION TEST

UL Japan,Inc. Shonan EMC Lab. No.1 Shielded Room
Date : 2014/10/30

Company	: MITSUMI ELECTRIC CO., LTD.	Mode	: Tx LE 2402MHz
Kind of EUT	: Wireless LAN + BT / BLE Module	Order No.	: 10499187S
Model No.	: DWM-W314	Power	: DC 3.3V
Serial No.	: 2	Temp./Humi.	: 25deg.C / 43%RH
Remarks	:		

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Shinichi Takano



Calculation:Result [dBuV] =Reading [dBuV] +C.Fac (LISN+Cable+ATT) [dB]
LISN:SLS-01

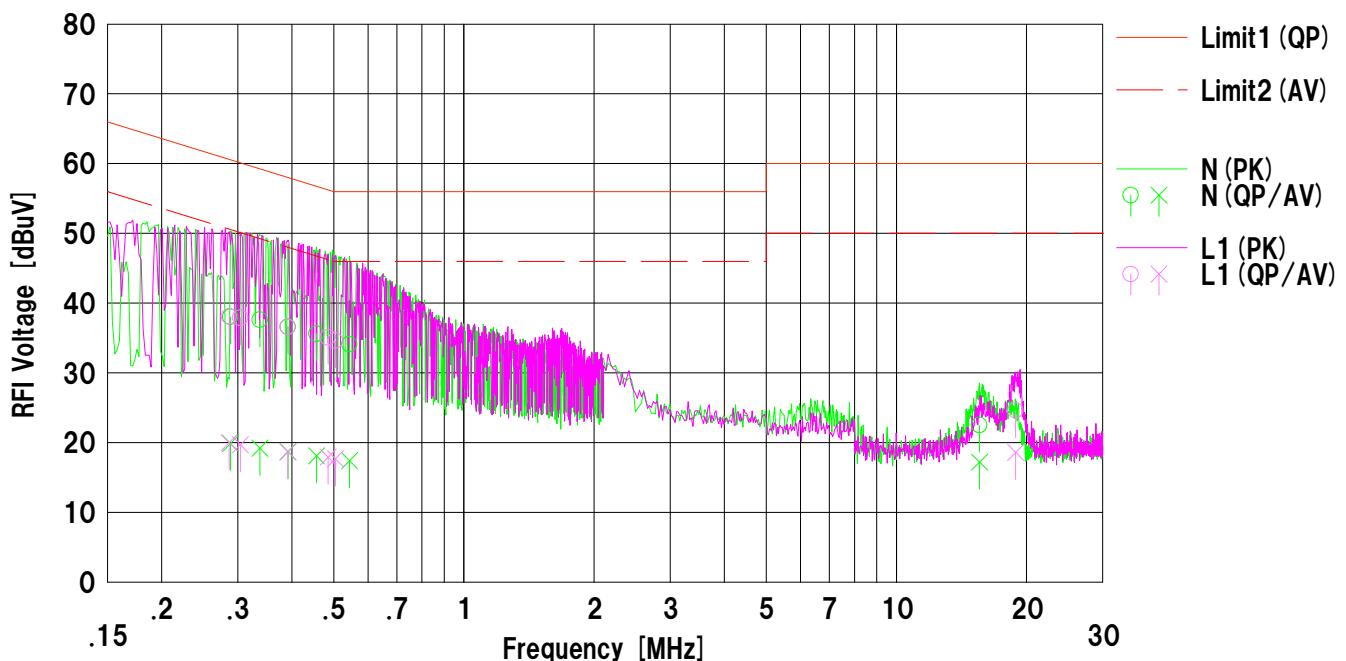
DATA OF CONDUCTED EMISSION TEST

UL Japan,Inc. Shonan EMC Lab. No.1 Shielded Room
Date : 2014/10/30

Company	: MITSUMI ELECTRIC CO., LTD.	Mode	: Tx LE 2440MHz
Kind of EUT	: Wireless LAN + BT/BLE Module	Order No.	: 10499187S
Model No.	: DWM-W314	Power	: DC 3.3V
Serial No.	: 2	Temp./Humi.	: 25deg.C / 43%RH
Remarks	: -		

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Shinichi Takano



No.	Freq. [MHz]	Reading		C.Fac [dB]	Results		Limit		Margin		Phase	Comment
		<QP> [dBuV]	<AV> [dBuV]		<QP> [dBuV]	<AV> [dBuV]	<QP> [dBuV]	<AV> [dBuV]	<QP> [dB]	<AV> [dB]		
1	0.28856	25.4	7.3	12.6	38.0	19.9	60.5	50.5	22.5	30.6	N	
2	0.33752	25.1	6.7	12.5	37.6	19.2	59.2	49.2	21.6	30.0	N	
3	0.39178	24.1	6.2	12.5	36.6	18.7	58.0	48.0	21.4	29.3	N	
4	0.45605	23.1	5.6	12.5	35.6	18.1	56.7	46.7	21.1	28.6	N	
5	0.54398	21.6	4.9	12.5	34.1	17.4	56.0	46.0	21.9	28.6	N	
6	15.57405	9.2	3.9	13.3	22.5	17.2	60.0	50.0	37.5	32.8	N	
7	0.28647	25.5	7.4	12.6	38.1	20.0	60.6	50.6	22.5	30.6	L1	
8	0.30421	25.4	7.2	12.5	37.9	19.7	60.1	50.1	22.2	30.4	L1	
9	0.39139	24.1	6.2	12.5	36.6	18.7	58.0	48.0	21.4	29.3	L1	
10	0.48535	22.6	5.4	12.5	35.1	17.9	56.2	46.2	21.1	28.3	L1	
11	0.50475	22.1	5.2	12.5	34.6	17.7	56.0	46.0	21.4	28.3	L1	
12	18.88198	11.1	5.1	13.5	24.6	18.6	60.0	50.0	35.4	31.4	L1	

Calculation:Result [dBuV] = Reading [dBuV] + C.Fac (LISN+Cable+ATT) [dB]
LISN:SLS-01

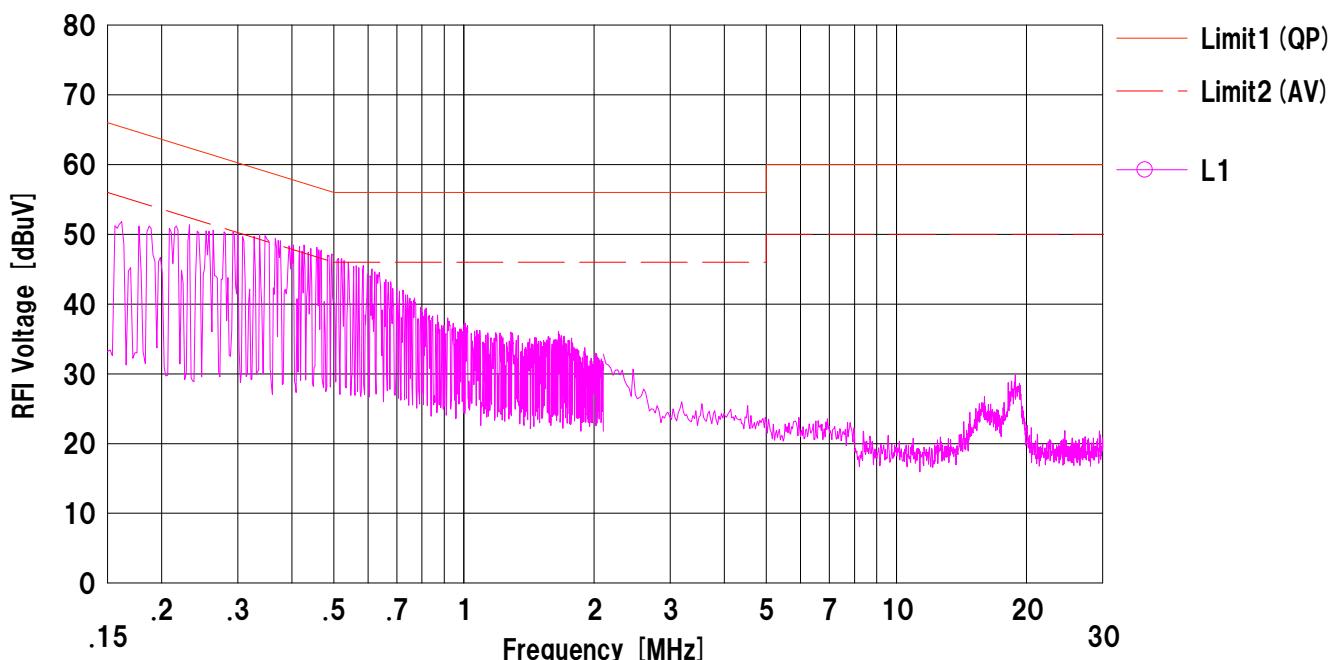
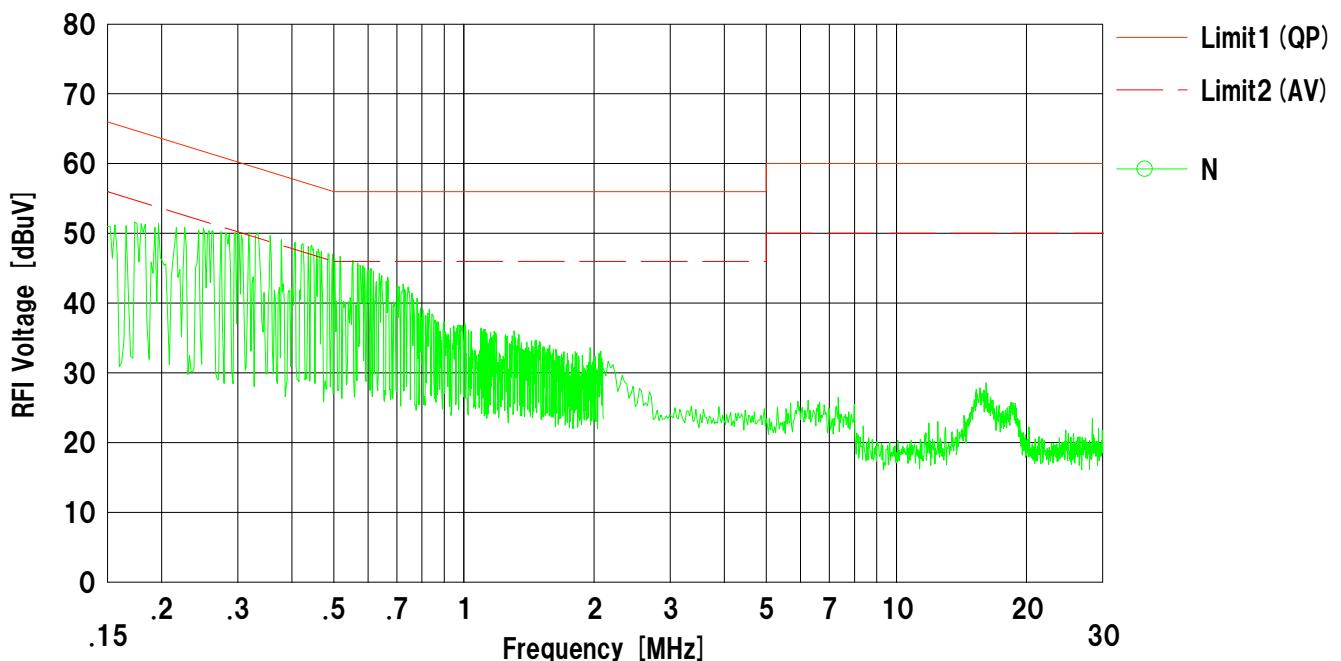
DATA OF CONDUCTED EMISSION TEST

UL Japan,Inc. Shonan EMC Lab. No.1 Shielded Room
Date : 2014/10/30

Company	: MITSUMI ELECTRIC CO., LTD.	Mode	: Tx LE 2480MHz
Kind of EUT	: Wireless LAN + BT/BLE Module	Order No.	: 10499187S
Model No.	: DWM-W314	Power	: DC 3.3V
Serial No.	: 2	Temp./Humi.	: 25deg.C / 43%RH
Remarks	:		

Limit1 : FCC 15C (15.207) QP
Limit2 : FCC 15C (15.207) AV

Engineer : Shinichi Takano

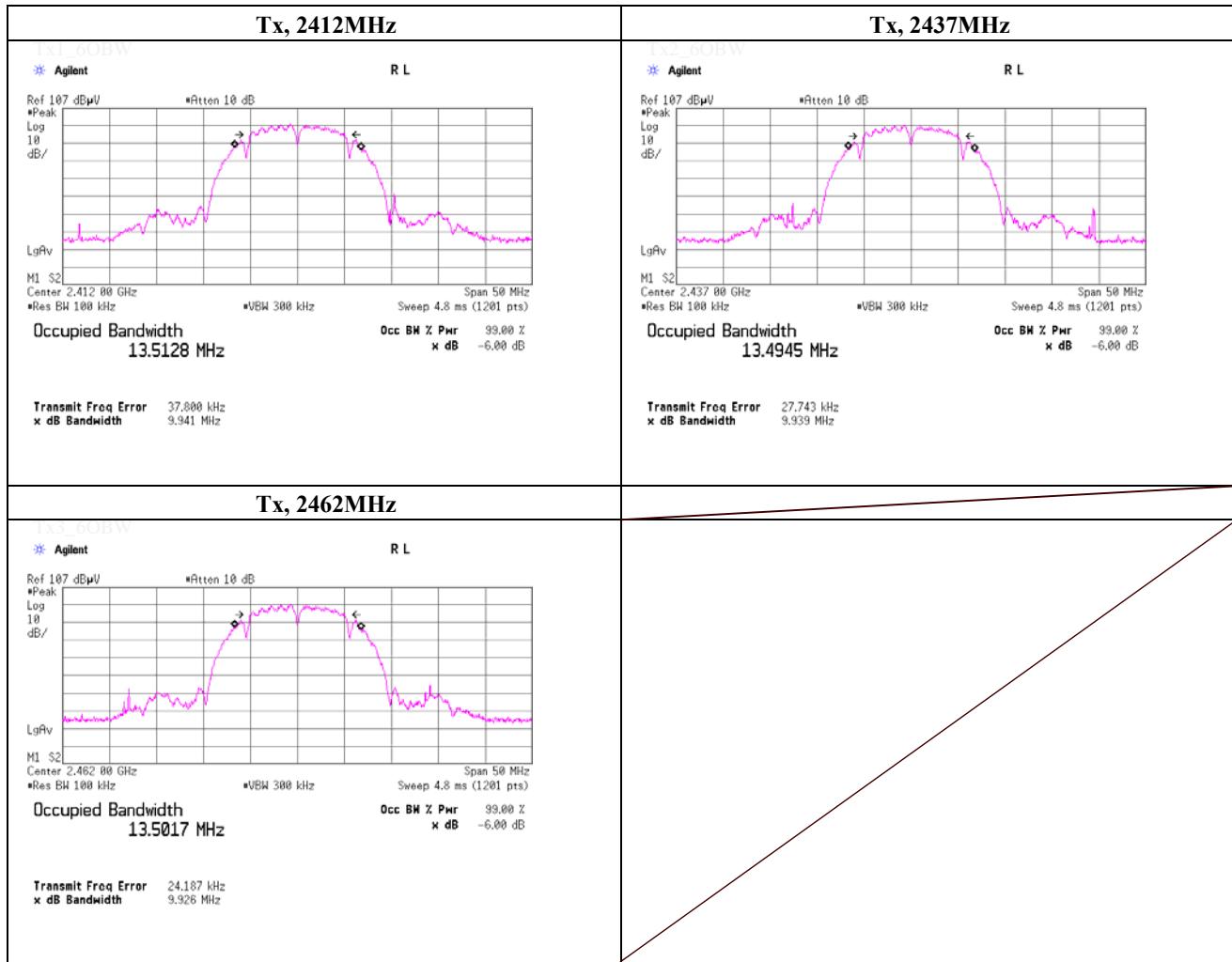


Calculation:Result [dBuV] =Reading [dBuV] +C.Fac (LISN+Cable+ATT) [dB]
LISN:SLS-01

-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11b, power setting 12dBm, PN9, worst data mode 2Mbps

Freq. [MHz]	-6dB Bandwidth [MHz]	Limit [MHz]
2412.0000	9.941	> 0.500
2437.0000	9.939	> 0.500
2462.0000	9.926	> 0.500



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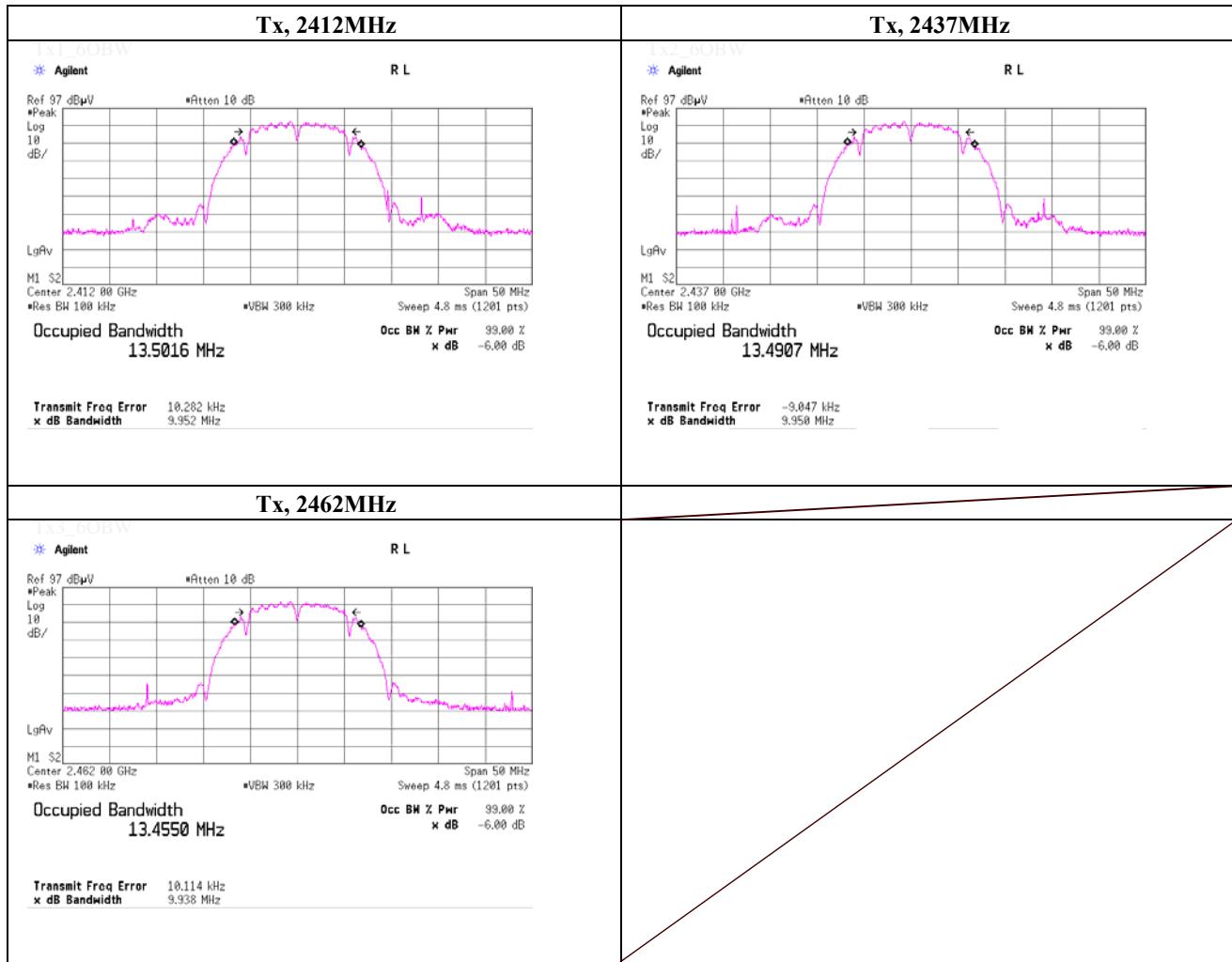
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11b, power setting 4dBm, PN9, worst data mode 2Mbps

Freq. [MHz]	-6dB Bandwidth [MHz]	Limit [MHz]
2412.0000	9.952	> 0.500
2437.0000	9.950	> 0.500
2462.0000	9.938	> 0.500



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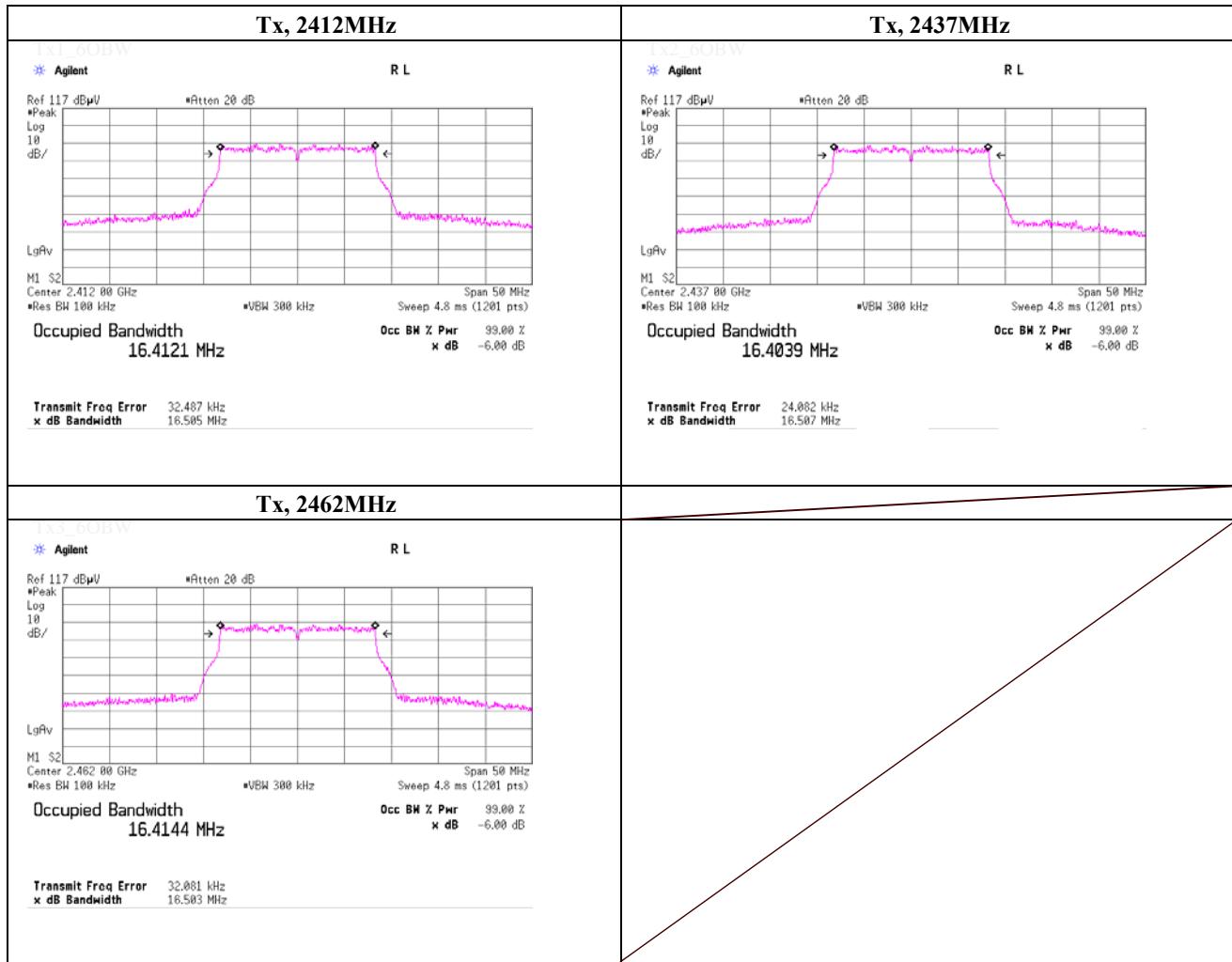
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11g, power setting 12dBm, PN9, worst data mode 48Mbps

Freq. [MHz]	-6dB Bandwidth [MHz]	Limit [MHz]
2412.0000	16.505	> 0.500
2437.0000	16.507	> 0.500
2462.0000	16.503	> 0.500



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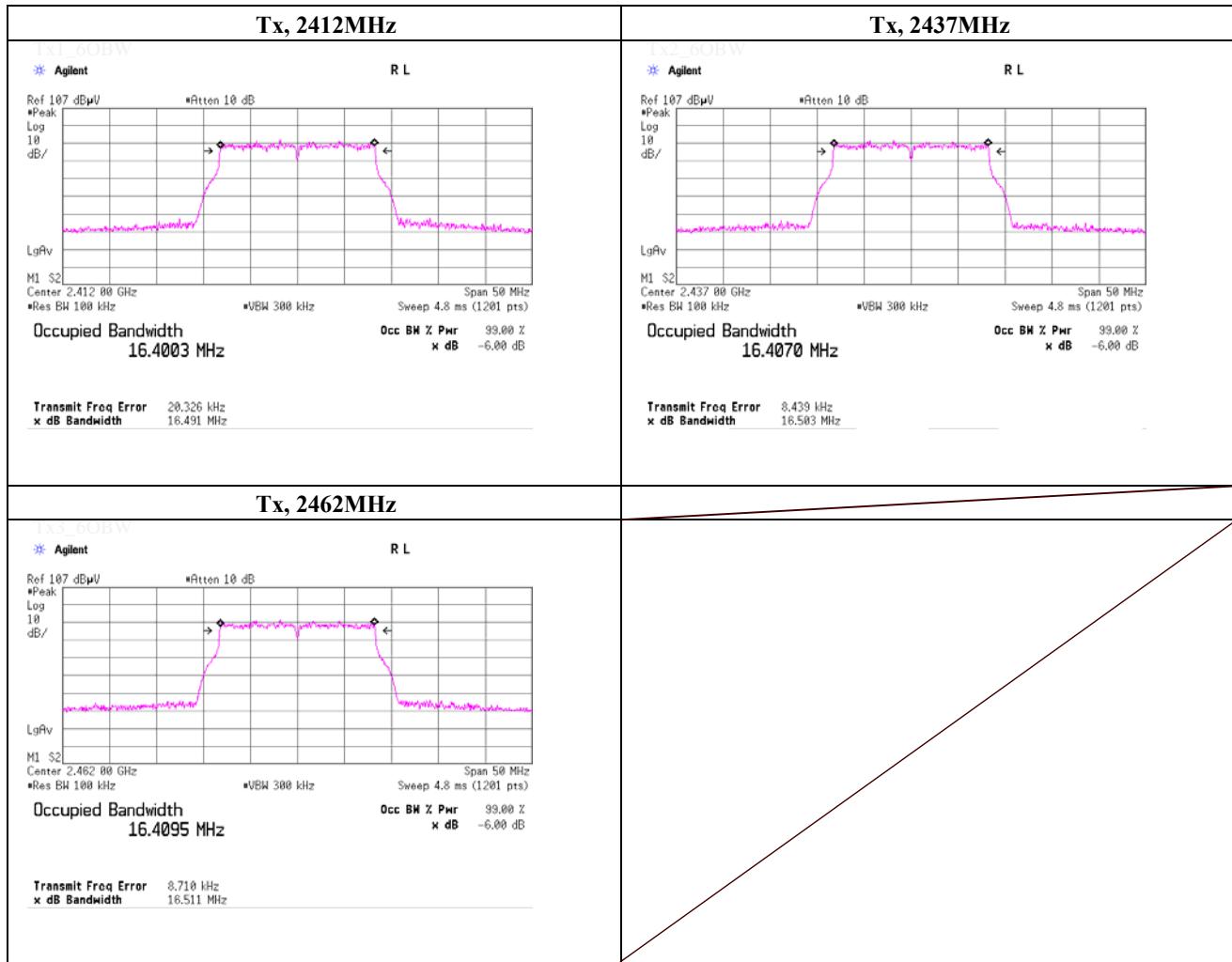
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11g, power setting 4dBm, PN9, worst data mode 48Mbps

Freq. [MHz]	-6dB Bandwidth [MHz]	Limit [MHz]
2412.0000	16.491	> 0.500
2437.0000	16.503	> 0.500
2462.0000	16.511	> 0.500



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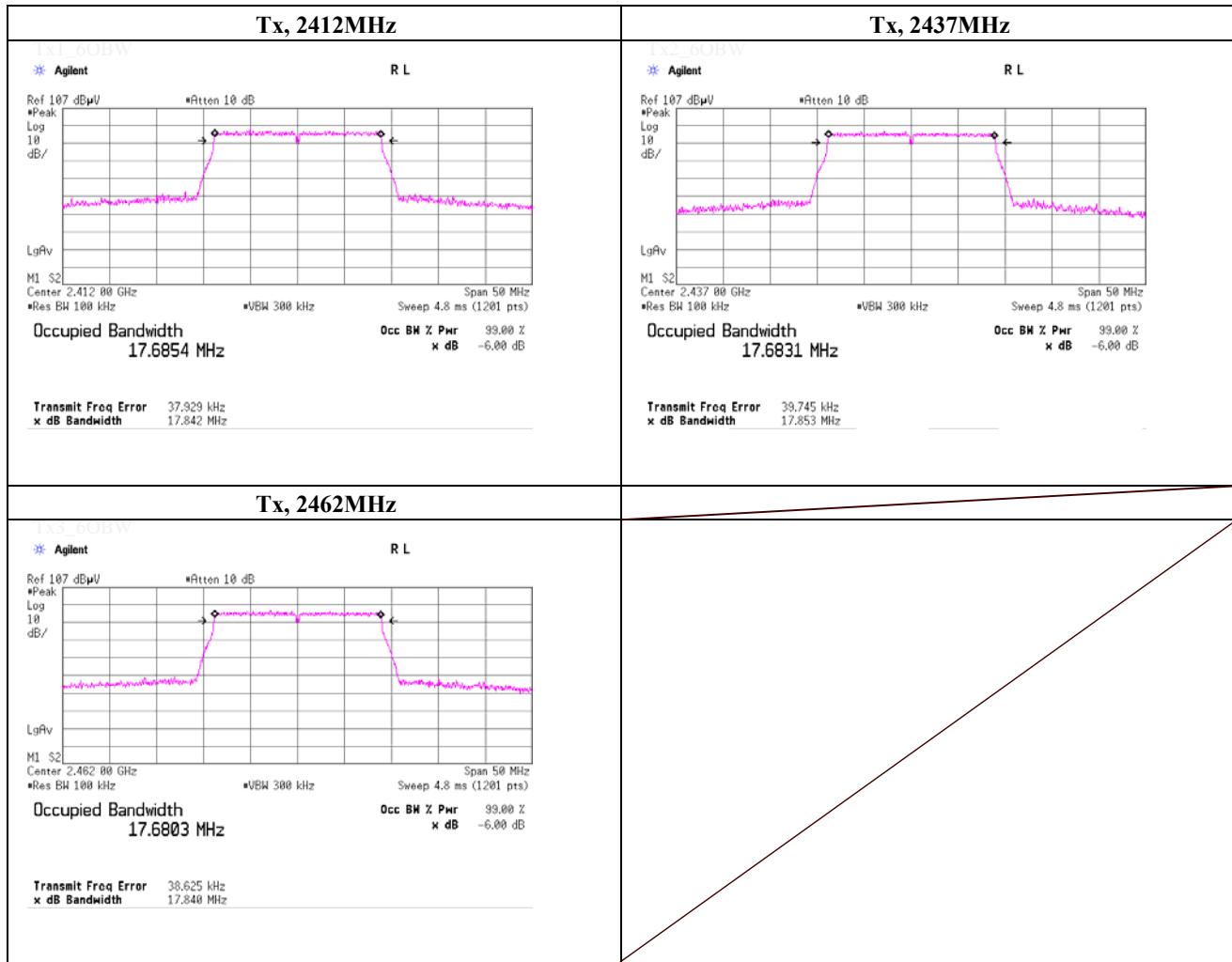
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11n HT20, power setting 12dBm, PN9, worst data mode 5(MCS)

Freq. [MHz]	-6dB Bandwidth [MHz]	Limit [MHz]
2412.0000	17.842	> 0.500
2437.0000	17.853	> 0.500
2462.0000	17.840	> 0.500



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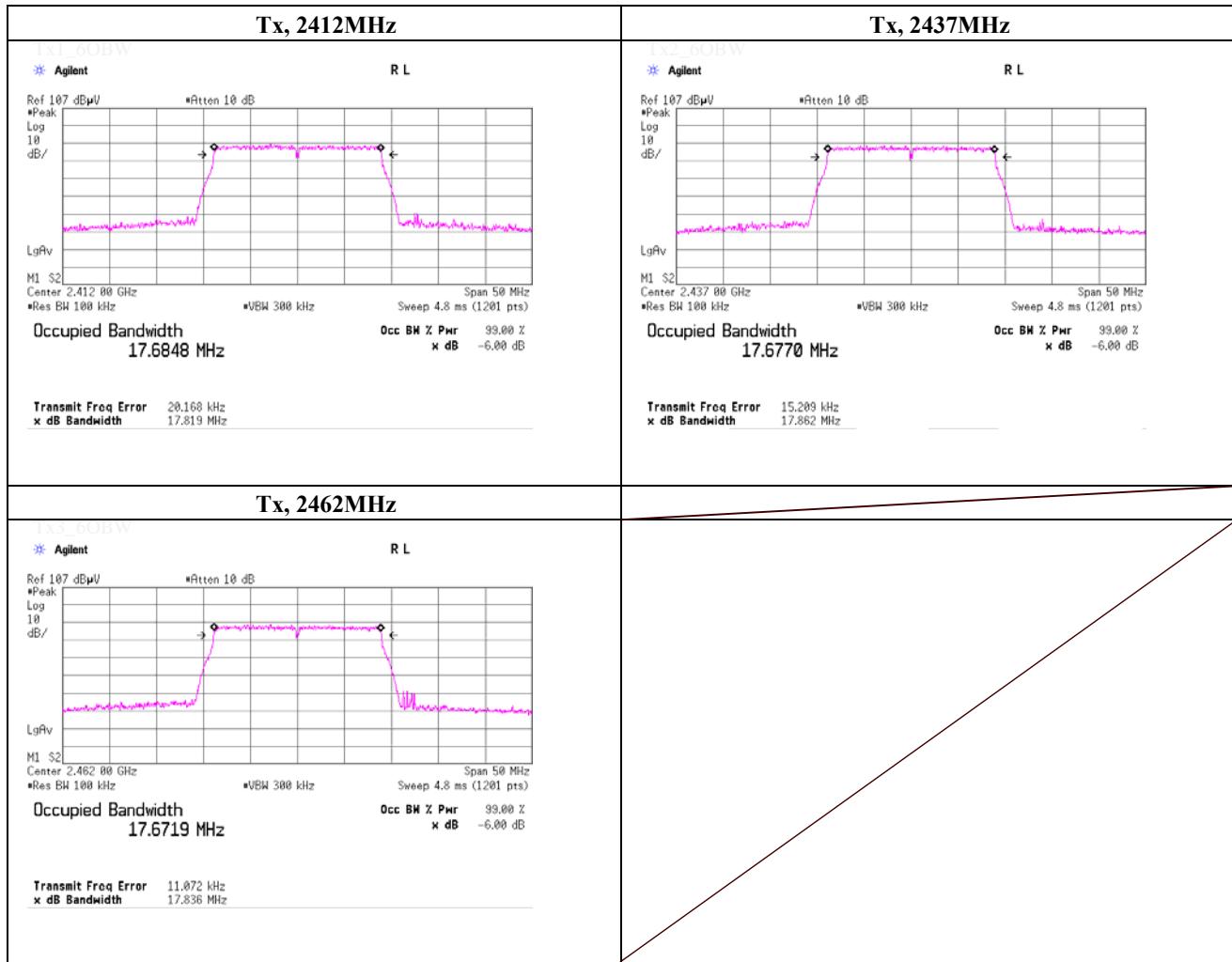
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11n HT20, power setting 4dBm, PN9, worst data mode 5(MCS)

Freq. [MHz]	-6dB Bandwidth [MHz]	Limit [MHz]
2412.0000	17.819	> 0.500
2437.0000	17.862	> 0.500
2462.0000	17.836	> 0.500



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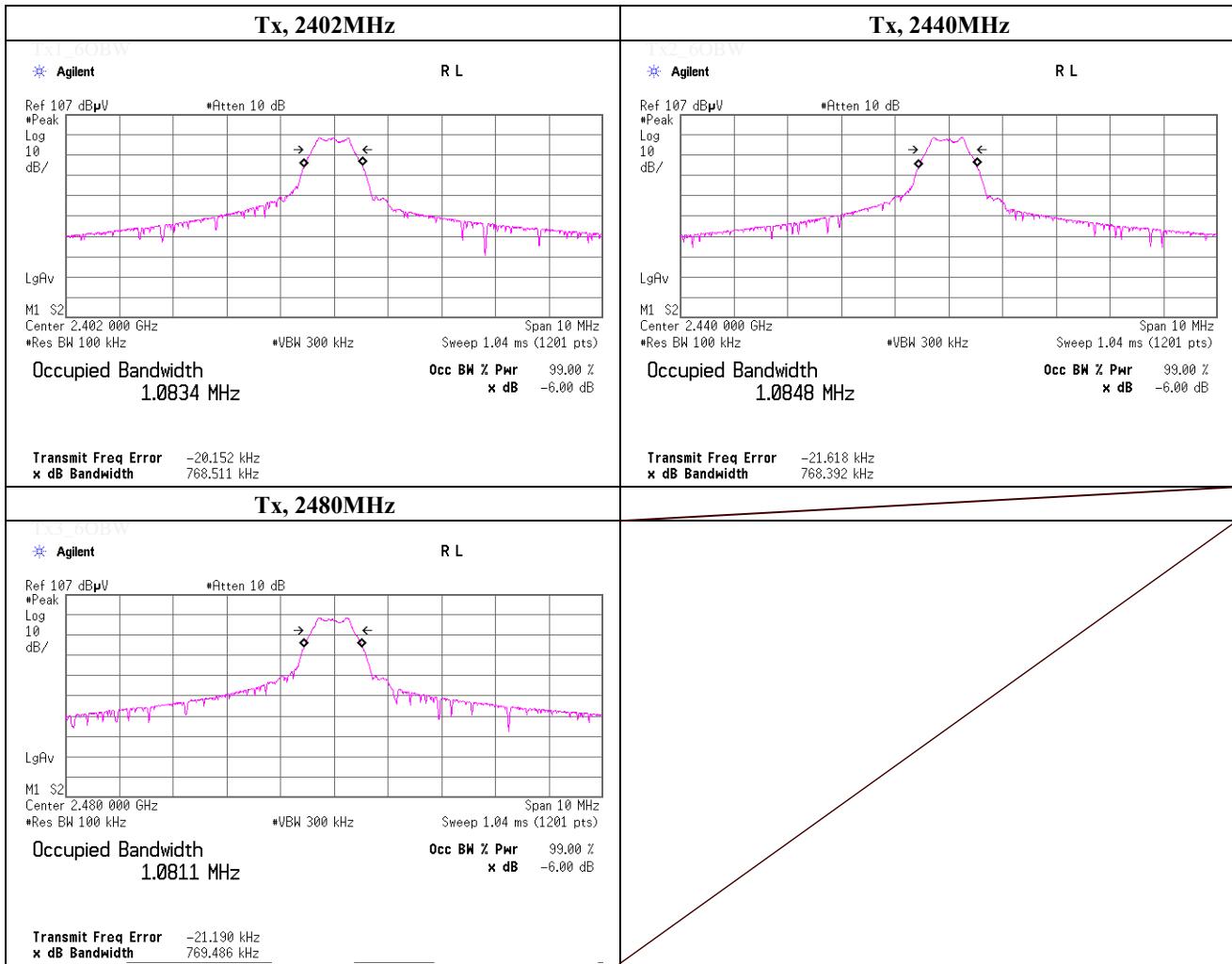
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

-6dB Bandwidth

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room
 Date October 24, 2014
 Temperature / Humidity 24deg.C , 55%RH
 Engineer Tatsuya Arai
 Mode Tx, Bluetooth, Low Energy, PN9

Freq. [MHz]	-6dB Bandwidth [MHz]	Limit [MHz]
2402.0000	0.769	>0.500
2440.0000	0.768	>0.500
2480.0000	0.769	>0.500



UL Japan, Inc.

Shonan EMC Lab.

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Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

Maximum Conducted Output Power(Reference Data)

(AVGPM)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11b, power setting 12dBm, PN9, worst data mode : 1 Mbps

(* P/M: Power Meter with power sensor, AV: Average)

Ch	Freq. [MHz]	P/M (AV) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Duty Factor [dB]	Result	
						[dBm]	[mW]
Low	2412.0	11.18	2.16	0.00	0.00	13.34	21.58
Mid	2437.0	10.48	2.17	0.00	0.00	12.65	18.41
High	2462.0	10.35	2.18	0.00	0.00	12.53	17.91

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss + Duty Factor

[Pre check]

	Data rate [Mbps]	Freq. [MHz]	P/M (AV) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Duty Factor [dB]	Result	
							[dBm]	[mW]
1	2412.0	11.18	2.16	0.00	0.00	13.34	21.58	
2	2412.0	11.17	2.16	0.00	0.00	13.33	21.53	
5.5	2412.0	11.03	2.16	0.00	0.00	13.19	20.84	
11	2412.0	10.83	2.16	0.00	0.00	12.99	19.91	

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss + Duty Factor

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Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN
 Telephone : +81 463 50 6400
 Facsimile : +81 463 50 6401

Maximum Peak Conducted Output Power (PKPM1)

Test place	UL Japan, Inc. Shonan EMC Lab.	No.1 Measurement Room
Date	October 16, 2014	
Temperature / Humidity	25deg.C , 49%RH	
Engineer	Akio Hayashi	
Mode	Tx, IEEE802.11b, power setting 4dBm, PN9,	worst data mode : 2 Mbps

(* P/M: Power Meter with power sensor)

Ch	Freq. [MHz]	P/M (Peak) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
Low	2412.0	6.01	2.16	0.00	8.17	6.56	30.00	1000	21.83
Mid	2437.0	5.24	2.17	0.00	7.41	5.51	30.00	1000	22.59
High	2462.0	5.08	2.18	0.00	7.26	5.32	30.00	1000	22.74

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss

The worst rate is based on power setting 12dBm data

**UL Japan, Inc.
Shonan EMC Lab.**

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Telephone : +81 463 50 6400

Faxsimile : +81 463 50 6401

Maximum Conducted Output Power(Reference data)

(AVGPM)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11b, power setting 4dBm, PN9, worst data mode : 1 Mbps

(* P/M: Power Meter with power sensor, AV: Average)

Ch	Freq. [MHz]	P/M (AV) Reading [dBm]	Cable	Atten.	Duty	Result	
			Loss [dB]	Loss [dB]	Factor [dB]	[dBm]	[mW]
Low	2412.0	3.01	2.16	0.00	0.00	5.17	3.29
Mid	2437.0	2.56	2.17	0.00	0.00	4.73	2.97
High	2462.0	2.36	2.18	0.00	0.00	4.54	2.84

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss + Duty Factor

The worst rate is based on power setting 12dBm data

**UL Japan, Inc.
Shonan EMC Lab.**

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN
 Telephone : +81 463 50 6400
 Facsimile : +81 463 50 6401

Maximum Peak Conducted Output Power

(PKPM1)

Test place	UL Japan, Inc. Shonan EMC Lab.	No.1 Measurement Room
Date	October 16, 2014	
Temperature / Humidity	25deg.C , 49%RH	
Engineer	Akio Hayashi	
Mode	Tx, IEEE802.11g, power setting 12dBm, PN9,	worst data mode : 48 Mbps

(* P/M: Power Meter with power sensor)

Ch	Freq. [MHz]	P/M (Peak) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
Low	2412.0	20.92	2.16	0.00	23.08	203.24	30.00	1000	6.92
Mid	2437.0	20.61	2.17	0.00	22.78	189.67	30.00	1000	7.22
High	2462.0	20.22	2.18	0.00	22.40	173.78	30.00	1000	7.60

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss

[Pre check]

	Data rate [Mbps]	Freq. [MHz]	P/M (Peak) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
						[dBm]	[mW]	[dBm]	[mW]	
Worst	6	2412.0	19.43	2.16	0.00	21.59	144.21	30.00	1000	8.41
	9	2412.0	18.56	2.16	0.00	20.72	118.03	30.00	1000	9.28
	12	2412.0	19.07	2.16	0.00	21.23	132.74	30.00	1000	8.77
	18	2412.0	18.46	2.16	0.00	20.62	115.35	30.00	1000	9.38
	24	2412.0	19.42	2.16	0.00	21.58	143.88	30.00	1000	8.42
	36	2412.0	19.26	2.16	0.00	21.42	138.68	30.00	1000	8.58
	48	2412.0	20.92	2.16	0.00	23.08	203.24	30.00	1000	6.92
	54	2412.0	20.76	2.16	0.00	22.92	195.88	30.00	1000	7.08

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss

**UL Japan, Inc.
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Telephone : +81 463 50 6400

Faxsimile : +81 463 50 6401

Maximum Conducted Output Power(Reference data)

(AVGPM)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11g, power setting 12dBm, PN9, worst data mode : 54 Mbps

(* P/M: Power Meter with power sensor, AV: Average)

Ch	Freq. [MHz]	P/M (AV) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Duty Factor [dB]	Result	
						[dBm]	[mW]
Low	2412.0	11.82	2.16	0.00	0.00	13.98	25.00
Mid	2437.0	11.13	2.17	0.00	0.00	13.30	21.38
High	2462.0	11.01	2.18	0.00	0.00	13.19	20.84

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss + Duty Factor

[Pre check]

	Data rate [Mbps]	Freq. [MHz]	P/M (AV) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Duty Factor [dB]	Result	
							[dBm]	[mW]
6	2412.0	11.47	2.16	0.00	0.00	13.63	23.07	
9	2412.0	11.55	2.16	0.00	0.00	13.71	23.50	
12	2412.0	11.54	2.16	0.00	0.00	13.70	23.44	
18	2412.0	11.45	2.16	0.00	0.00	13.61	22.96	
24	2412.0	11.56	2.16	0.00	0.00	13.72	23.55	
36	2412.0	11.49	2.16	0.00	0.00	13.65	23.17	
48	2412.0	11.77	2.16	0.00	0.00	13.93	24.72	
54	2412.0	11.82	2.16	0.00	0.00	13.98	25.00	

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss + Duty Factor

**UL Japan, Inc.
Shonan EMC Lab.**

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Telephone : +81 463 50 6400

Faxsimile : +81 463 50 6401

Maximum Peak Conducted Output Power

(PKPM1)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11g, power setting 4dBm, PN9, worst data mode : 48 Mbps

(* P/M: Power Meter with power sensor)

Ch	Freq. [MHz]	P/M (Peak) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
Low	2412.0	13.48	2.16	0.00	15.64	36.64	30.00	1000	14.36
Mid	2437.0	13.19	2.17	0.00	15.36	34.36	30.00	1000	14.64
High	2462.0	12.86	2.18	0.00	15.04	31.92	30.00	1000	14.96

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss

The worst rate is based on power setting 12dBm data

UL Japan, Inc.
Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Telephone : +81 463 50 6400

Faxsimile : +81 463 50 6401

Maximum Conducted Output Power(Reference data)

(AVGPM)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
Date October 16, 2014
Temperature / Humidity 25deg.C , 49%RH
Engineer Akio Hayashi
Mode Tx, IEEE802.11g, power setting 4dBm, PN9, worst data mode : 54 Mbps

(* P/M: Power Meter with power sensor, AV: Average)

Ch	Freq. [MHz]	P/M (AV) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Duty Factor [dB]	Result	
						[dBm]	[mW]
Low	2412.0	3.78	2.16	0.00	0.00	5.94	3.93
Mid	2437.0	3.21	2.17	0.00	0.00	5.38	3.45
High	2462.0	3.00	2.18	0.00	0.00	5.18	3.30

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss + Duty Factor

The worst rate is based on power setting 12dBm data

UL Japan, Inc.
Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN
Telephone : +81 463 50 6400
Facsimile : +81 463 50 6401

Maximum Conducted Output Power(Reference data)

(AVGPM)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11n HT20, power setting 12dBm, PN worst data mode : 5 (MCS)

(* P/M: Power Meter with power sensor, AV: Average)

Ch	Freq. [MHz]	P/M (AV) Reading [dBm]	Cable	Atten.	Duty	Result	
			Loss [dB]	Loss [dB]	Factor [dB]	[dBm]	[mW]
Low	2412.0	11.86	2.16	0.00	0.00	14.02	25.23
Mid	2437.0	10.96	2.17	0.00	0.00	13.13	20.56
High	2462.0	10.68	2.18	0.00	0.00	12.86	19.32

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss + Duty Factor

[Pre check]

Mode (MCS)	Freq. [MHz]	P/M (AV) Reading [dBm]	Cable	Atten.	Duty	Result	
			Loss [dB]	Loss [dB]	Factor [dB]	[dBm]	[mW]
0	2412.0	11.55	2.16	0.00	0.00	13.71	23.50
1	2412.0	11.52	2.16	0.00	0.00	13.68	23.33
2	2412.0	11.51	2.16	0.00	0.00	13.67	23.28
3	2412.0	11.51	2.16	0.00	0.00	13.67	23.28
4	2412.0	11.51	2.16	0.00	0.00	13.67	23.28
5	2412.0	11.86	2.16	0.00	0.00	14.02	25.23
6	2412.0	11.81	2.16	0.00	0.00	13.97	24.95
7	2412.0	11.81	2.16	0.00	0.00	13.97	24.95

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss + Duty Factor

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1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Telephone : +81 463 50 6400

Faxsimile : +81 463 50 6401

Maximum Peak Conducted Output Power

(PKPM1)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11n HT20, power setting 4dBm, PN9, worst data mode : 5 (MCS)

(* P/M: Power Meter with power sensor)

Ch	Freq. [MHz]	P/M (Peak) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
Low	2412.0	13.03	2.16	0.00	15.19	33.04	30.00	1000	14.81
Mid	2437.0	12.20	2.17	0.00	14.37	27.35	30.00	1000	15.63
High	2462.0	11.77	2.18	0.00	13.95	24.83	30.00	1000	16.05

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss

The worst rate is based on power setting 12dBm data

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Faxsimile : +81 463 50 6401

Maximum Conducted Output Power(Reference data)

(AVGPM)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11n HT20, power setting 4dBm, PN^c worst data mode : 5 (MCS)

(* P/M: Power Meter with power sensor, AV: Average)

Ch	Freq. [MHz]	P/M (AV) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Duty Factor [dB]	Result	
						[dBm]	[mW]
Low	2412.0	3.73	2.16	0.00	0.00	5.89	3.88
Mid	2437.0	3.14	2.17	0.00	0.00	5.31	3.40
High	2462.0	2.96	2.18	0.00	0.00	5.14	3.27

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss + Duty Factor

The worst rate is based on power setting 12dBm data

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Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN
 Telephone : +81 463 50 6400
 Facsimile : +81 463 50 6401

Maximum Peak Conducted Output Power

(PKPM1)

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room
 Date October 23, 2014
 Temperature / Humidity 25deg.C , 47%RH
 Engineer Akio Hayashi
 Mode Tx, Bluetooth, Low Energy, PN9,

(* P/M: Power Meter with power sensor)

Ch	Freq. [MHz]	P/M (Peak) Reading [dBm]	Cable Loss [dB]	Atten. Loss [dB]	Result		Limit		Margin [dB]
					[dBm]	[mW]	[dBm]	[mW]	
Low	2402.0	-0.28	2.19	0.00	1.91	1.55	30.00	1000	28.09
Mid	2440.0	-0.33	2.20	0.00	1.87	1.54	30.00	1000	28.13
High	2480.0	-0.51	2.21	0.00	1.70	1.48	30.00	1000	28.30

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss

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Shonan EMC Lab.

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Telephone : +81 463 50 6400

Faxsimile : +81 463 50 6401

Maximum Conducted Output Power(Reference)

(AVGPM)

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room
 Date October 23, 2014
 Temperature / Humidity 25deg.C , 47%RH
 Engineer Akio Hayashi
 Mode Tx, Bluetooth, Low Energy, PN9,

(* P/M: Power Meter with power sensor, AV: Average)

Ch	Freq. [MHz]	P/M (AV) Reading [dBm]	Cable	Atten.	Duty	Result	
			Loss [dB]	Loss [dB]	Factor [dB]	[dBm]	[mW]
Low	2402.0	-0.41	2.19	0.00	0.00	1.78	1.51
Mid	2440.0	-0.46	2.20	0.00	0.00	1.74	1.49
High	2480.0	-0.63	2.21	0.00	0.00	1.58	1.44

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss + Duty Factor

E.I.R.P = Result + Antenna Gain

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1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN
 Telephone : +81 463 50 6400
 Facsimile : +81 463 50 6401

Radiated Emission

Test place No.2 & No.3 Semi Anechoic Chamber
 Date October 24, 2014 October 26, 2014
 Temperature / Humidity 24 deg.C, 44 %RH 25 deg.C, 50 %RH
 Engineer Makoto Hosaka Tatsuya Arai
 Mode Tx, 2437 MHz
 Tx, IEEE802.11b

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg]	Remark
Hori.	4874.000	PK	52.1	30.9	6.0	39.7	49.3	73.9	24.6	100	298	
Hori.	7311.000	PK	46.1	36.8	7.1	40.3	49.7	73.9	24.2	100	0	
Hori.	9748.000	PK	47.7	38.6	8.1	40.0	54.4	73.9	19.5	149	265	
Hori.	12185.000	PK	46.4	39.4	9.4	39.8	55.4	73.9	18.5	100	0	
Hori.	4874.000	AV	47.1	30.9	6.0	39.7	44.3	53.9	9.6	100	298	
Hori.	7311.000	AV	36.8	36.8	7.1	40.3	40.4	53.9	13.5	100	0	
Hori.	9748.000	AV	37.8	38.6	8.1	40.0	44.5	53.9	9.4	149	265	
Hori.	12185.000	AV	37.0	39.4	9.4	39.8	46.0	53.9	7.9	100	0	
Vert.	4874.000	PK	51.4	30.9	6.0	39.7	48.6	73.9	25.3	100	256	
Vert.	7311.000	PK	46.5	36.8	7.1	40.3	50.1	73.9	23.8	100	136	
Vert.	9748.000	PK	46.8	38.6	8.1	40.0	53.5	73.9	20.4	123	206	
Vert.	12185.000	PK	46.5	39.4	9.4	39.8	55.5	73.9	18.4	100	0	
Vert.	4874.000	AV	46.5	30.9	6.0	39.7	43.7	53.9	10.2	100	256	
Vert.	7311.000	AV	36.9	36.8	7.1	40.3	40.5	53.9	13.4	100	136	
Vert.	9748.000	AV	37.8	38.6	8.1	40.0	44.5	53.9	9.4	123	206	
Vert.	12185.000	AV	36.8	39.4	9.4	39.8	45.8	53.9	8.1	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor : 15GHz -40GHz : 20log(3.0m/1.0m)= 9.5dB

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Shonan EMC Lab.**

1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Telephone : +81 463 50 6400

Faxsimile : +81 463 50 6401

Radiated Emission

Test place No.2 & No.3 Semi Anechoic Chamber
 Date October 24, 2014 October 26, 2014
 Temperature / Humidity 24 deg.C, 44 %RH 25 deg.C, 50 %RH
 Engineer Makoto Hosaka Tatsuya Arai
 Mode Tx, 2462 MHz
 Tx, IEEE802.11b

(* PK: Peak, AV: Average, QP: Quasi-Peak)

Polarity	Frequency [MHz]	Detector	Reading [dBuV]	Ant.Fac. [dB/m]	Loss [dB]	Gain [dB]	Result [dBuV/m]	Limit [dBuV/m]	Margin [dB]	Height [cm]	Angle [deg]	Remark
Hori.	2483.500	PK	46.7	26.6	13.6	41.1	45.8	73.9	28.1	100	212	
Hori.	4924.000	PK	50.8	31.1	5.9	39.6	48.2	73.9	25.7	100	311	
Hori.	7386.000	PK	46.0	36.9	7.2	40.4	49.7	73.9	24.2	100	0	
Hori.	9848.000	PK	46.9	38.6	8.1	39.9	53.7	73.9	20.2	155	288	
Hori.	12310.000	PK	46.1	39.3	9.4	39.9	54.9	73.9	19.0	100	0	
Hori.	2483.500	AV	38.3	26.6	13.6	41.1	37.4	53.9	16.5	100	212	
Hori.	4924.000	AV	45.2	31.1	5.9	39.6	42.6	53.9	11.3	100	311	
Hori.	7386.000	AV	36.5	36.9	7.2	40.4	40.2	53.9	13.7	100	0	
Hori.	9848.000	AV	37.6	38.6	8.1	39.9	44.4	53.9	9.5	155	288	
Hori.	12310.000	AV	36.1	39.3	9.4	39.9	44.9	53.9	9.0	100	0	
Vert.	2483.500	PK	47.0	26.6	13.6	41.1	46.1	73.9	27.8	100	224	
Vert.	4924.000	PK	51.1	31.1	5.9	39.6	48.5	73.9	25.4	108	252	
Vert.	7386.000	PK	45.2	36.9	7.2	40.4	48.9	73.9	25.0	100	82	
Vert.	9848.000	PK	47.8	38.6	8.1	39.9	54.6	73.9	19.3	162	226	
Vert.	12310.000	PK	45.7	39.3	9.4	39.9	54.5	73.9	19.4	100	0	
Vert.	2483.500	AV	37.8	26.6	13.6	41.1	36.9	53.9	17.0	100	224	
Vert.	4924.000	AV	45.2	31.1	5.9	39.6	42.6	53.9	11.3	108	252	
Vert.	7386.000	AV	36.2	36.9	7.2	40.4	39.9	53.9	14.0	100	82	
Vert.	9848.000	AV	39.1	38.6	8.1	39.9	45.9	53.9	8.0	162	226	
Vert.	12310.000	AV	35.8	39.3	9.4	39.9	44.6	53.9	9.3	100	0	

Result = Reading + Ant.Fac. + Loss (Cable+(Attenuator or Filter)(below 18GHz)-Distance factor(above 15GHz)) - Gain(Amprifier)

Distance factor : 15GHz -40GHz : $20\log(3.0m/1.0m) = 9.5dB$ **UL Japan, Inc.****Shonan EMC Lab.**

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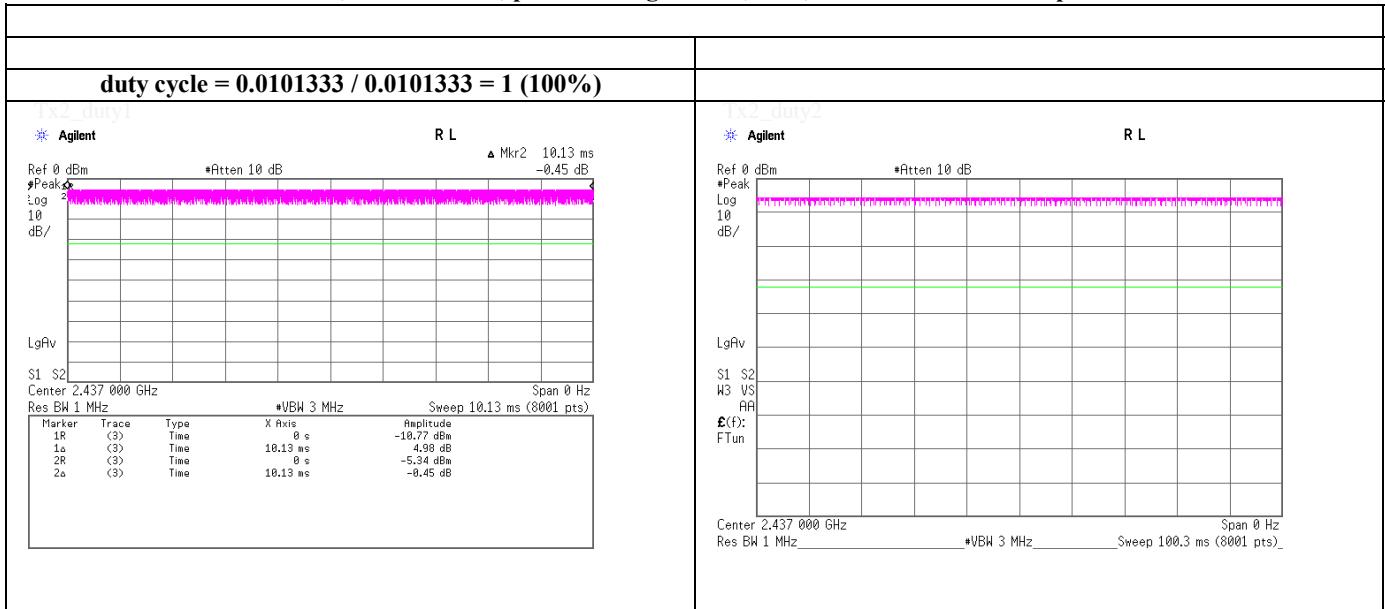
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Burst rate confirmation

Tx, IEEE802.11b, power setting 12dBm, PN9, worst data mode 2Mbps



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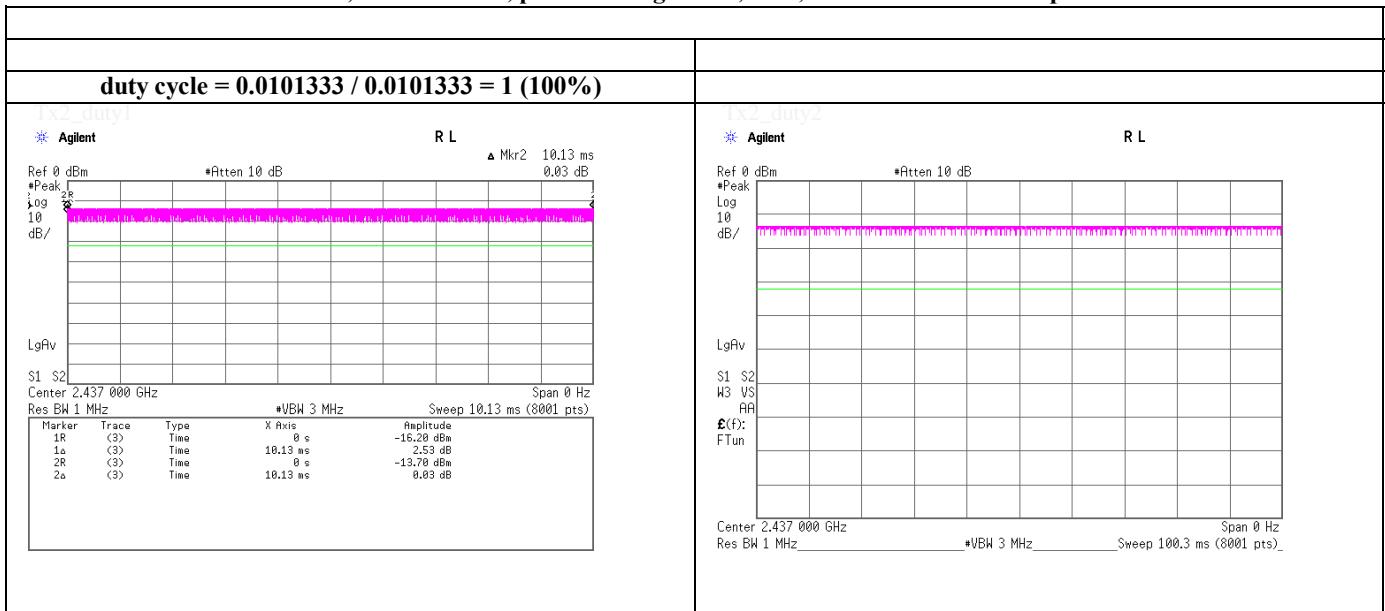
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 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Burst rate confirmation

Tx, IEEE802.11b, power setting 4dBm, PN9, worst data mode 2Mbps



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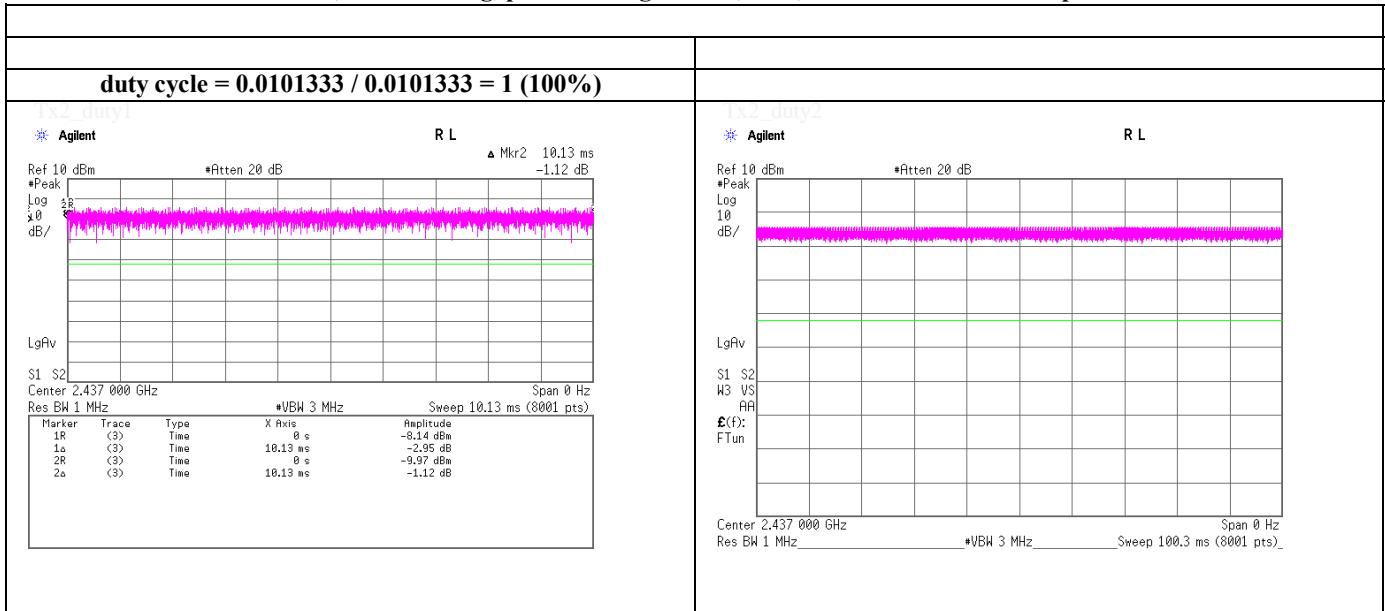
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 Engineer Akio Hayashi

Burst rate confirmation

Tx, IEEE802.11g, power setting 12dBm, PN9, worst data mode 48Mbps



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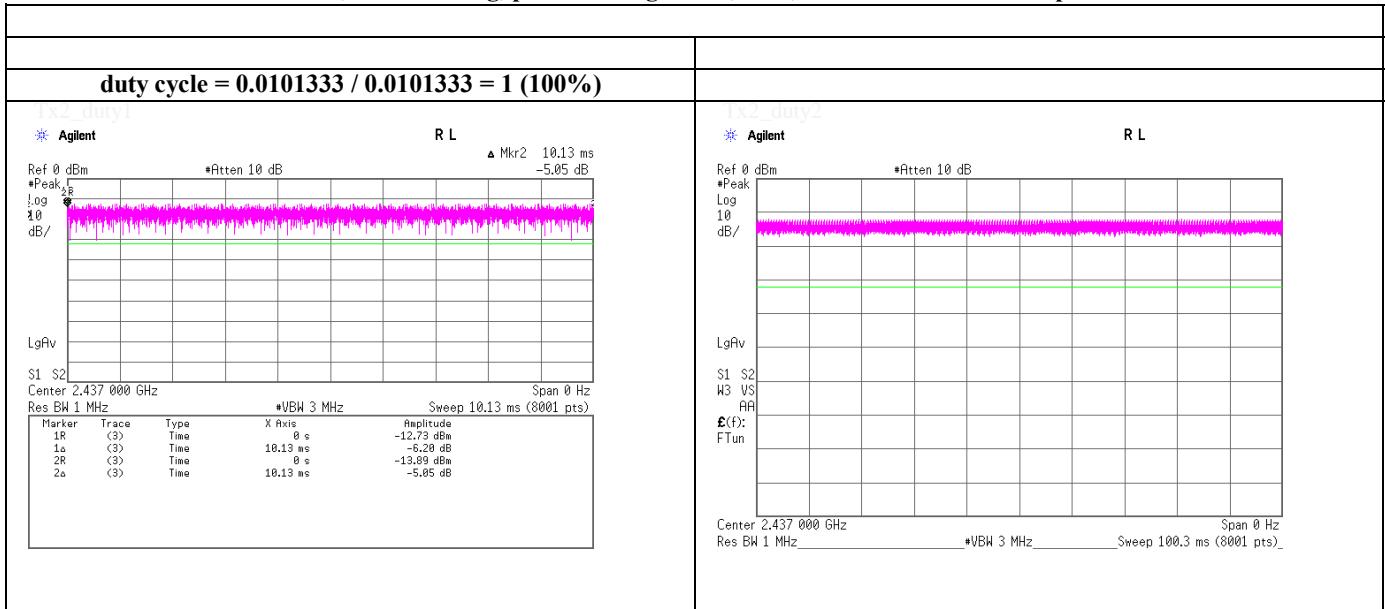
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 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Burst rate confirmation

Tx, IEEE802.11g, power setting 4dBm, PN9, worst data mode 48Mbps



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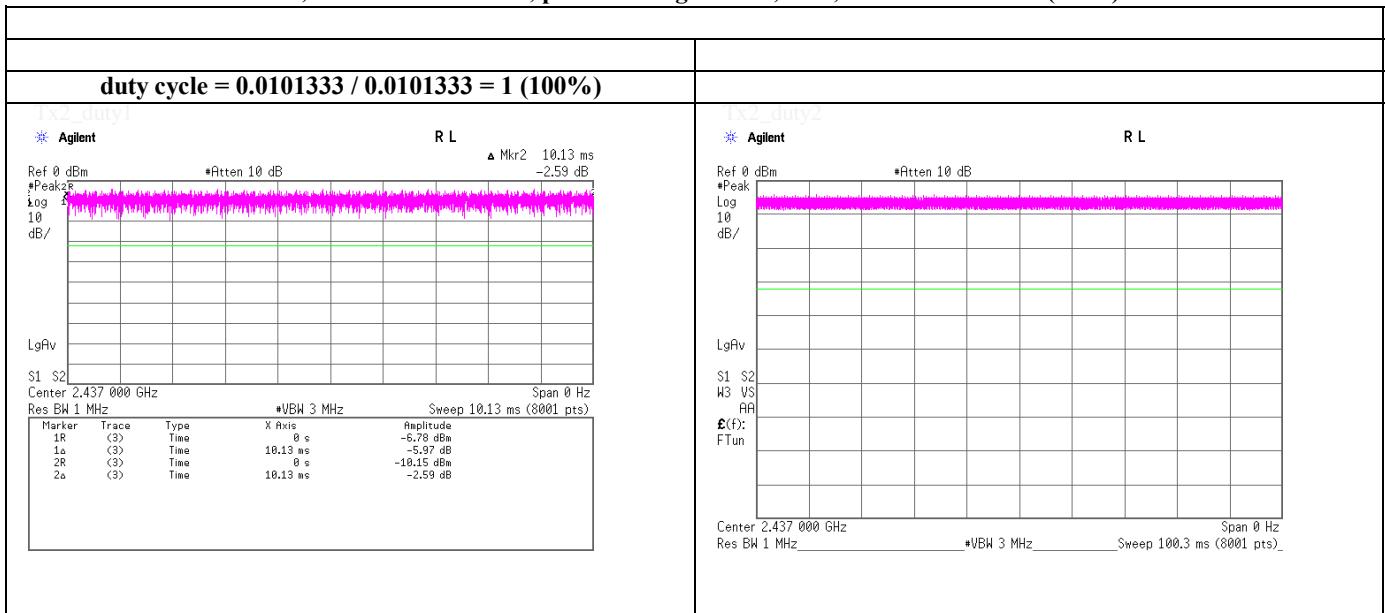
Telephone : +81 463 50 6400

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Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Burst rate confirmation

Tx, IEEE802.11n HT20, power setting 12dBm, PN9, worst data mode 5(MCS)



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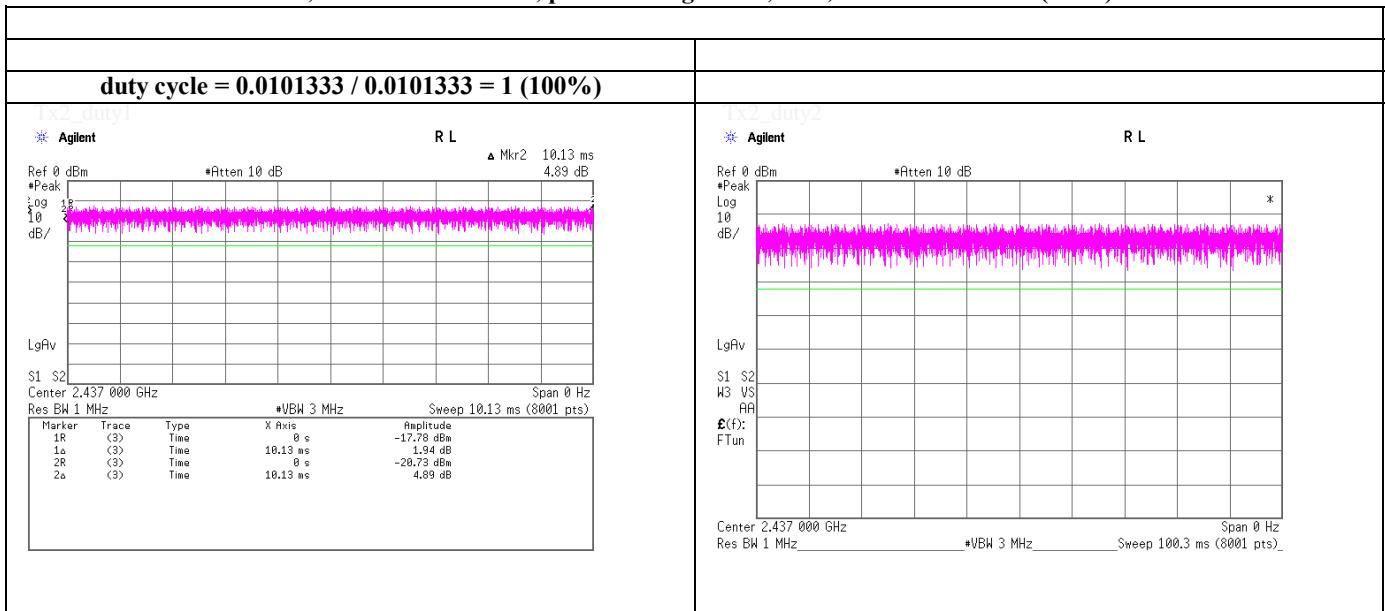
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Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Burst rate confirmation

Tx, IEEE802.11n HT20, power setting 4dBm, PN9, worst data mode 5(MCS)



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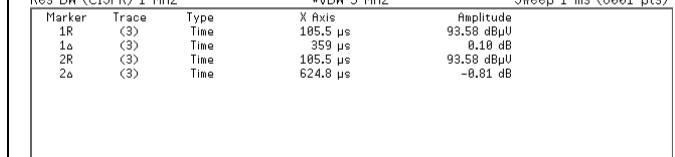
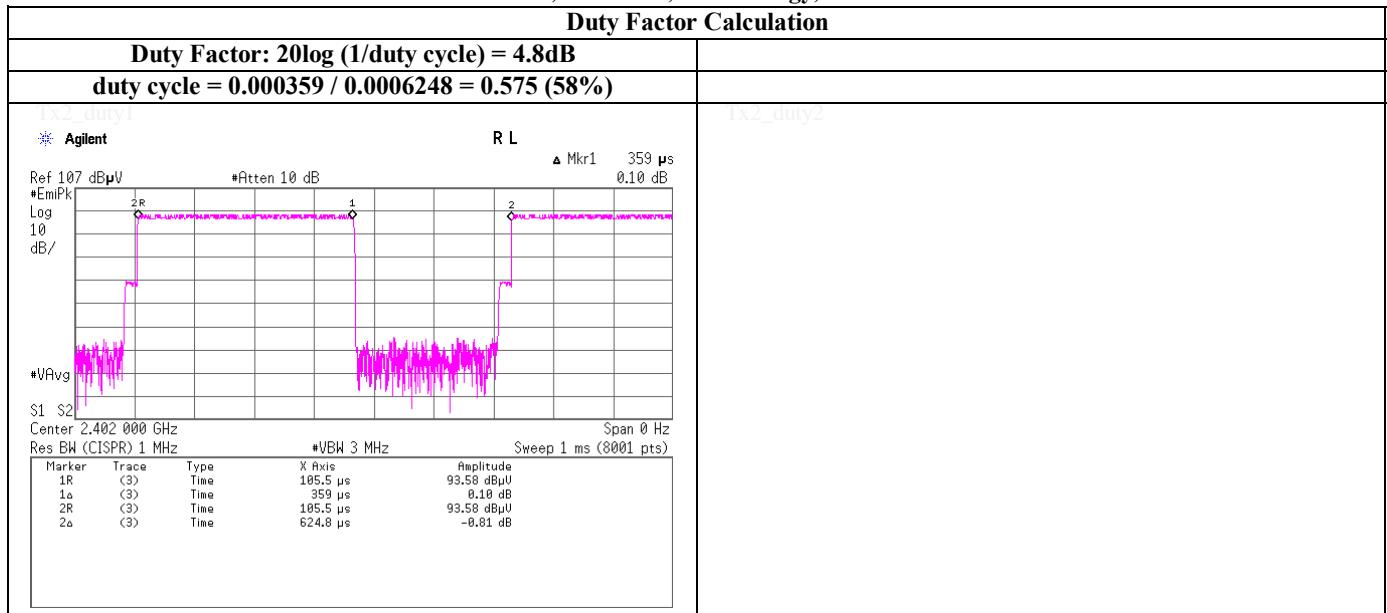
Faxsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room
 Date October 24, 2014
 Temperature / Humidity 24deg.C , 55%RH
 Engineer Tatsuya Arai

Duty Factor Calculation chart

Tx, Bluetooth, Low Energy, PN9

Duty Factor Calculation



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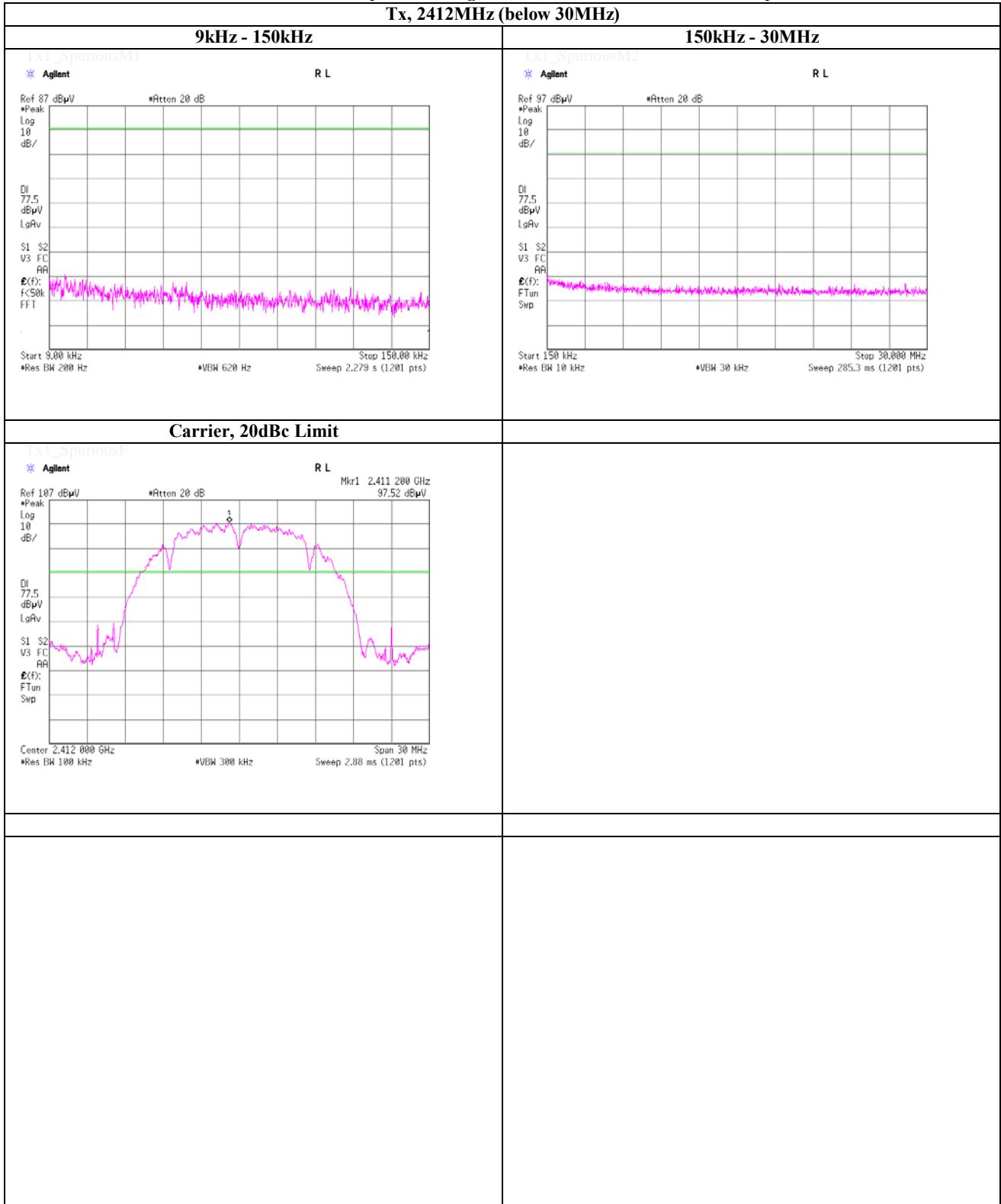
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Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11b, power setting 12dBm, PN9, worst data mode 2Mbps

Tx, 2412MHz (below 30MHz)



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Shonan EMC Lab.

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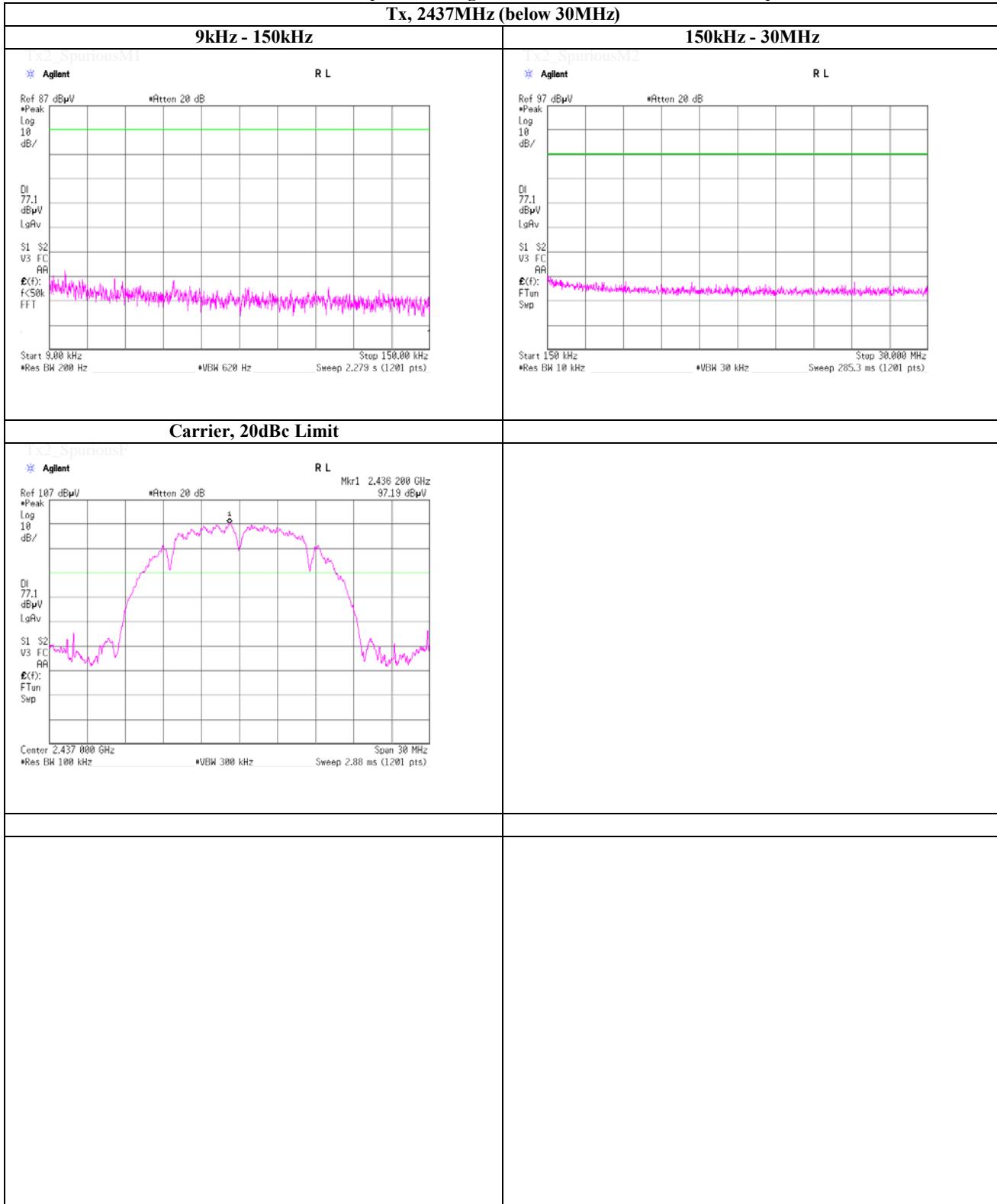
Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11b, power setting 12dBm, PN9, worst data mode 2Mbps

Tx, 2437MHz (below 30MHz)



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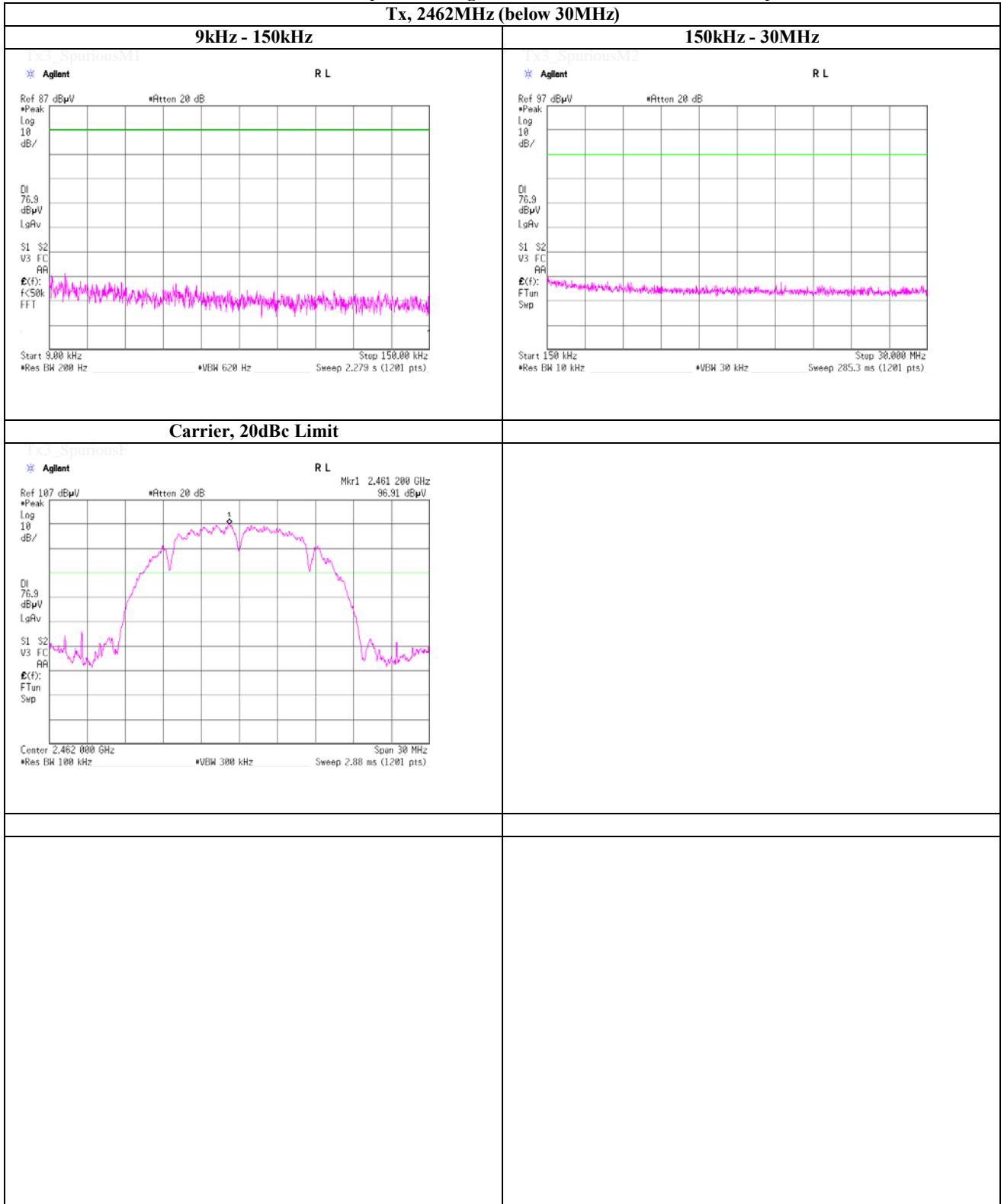
Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11b, power setting 12dBm, PN9, worst data mode 2Mbps

Tx, 2462MHz (below 30MHz)



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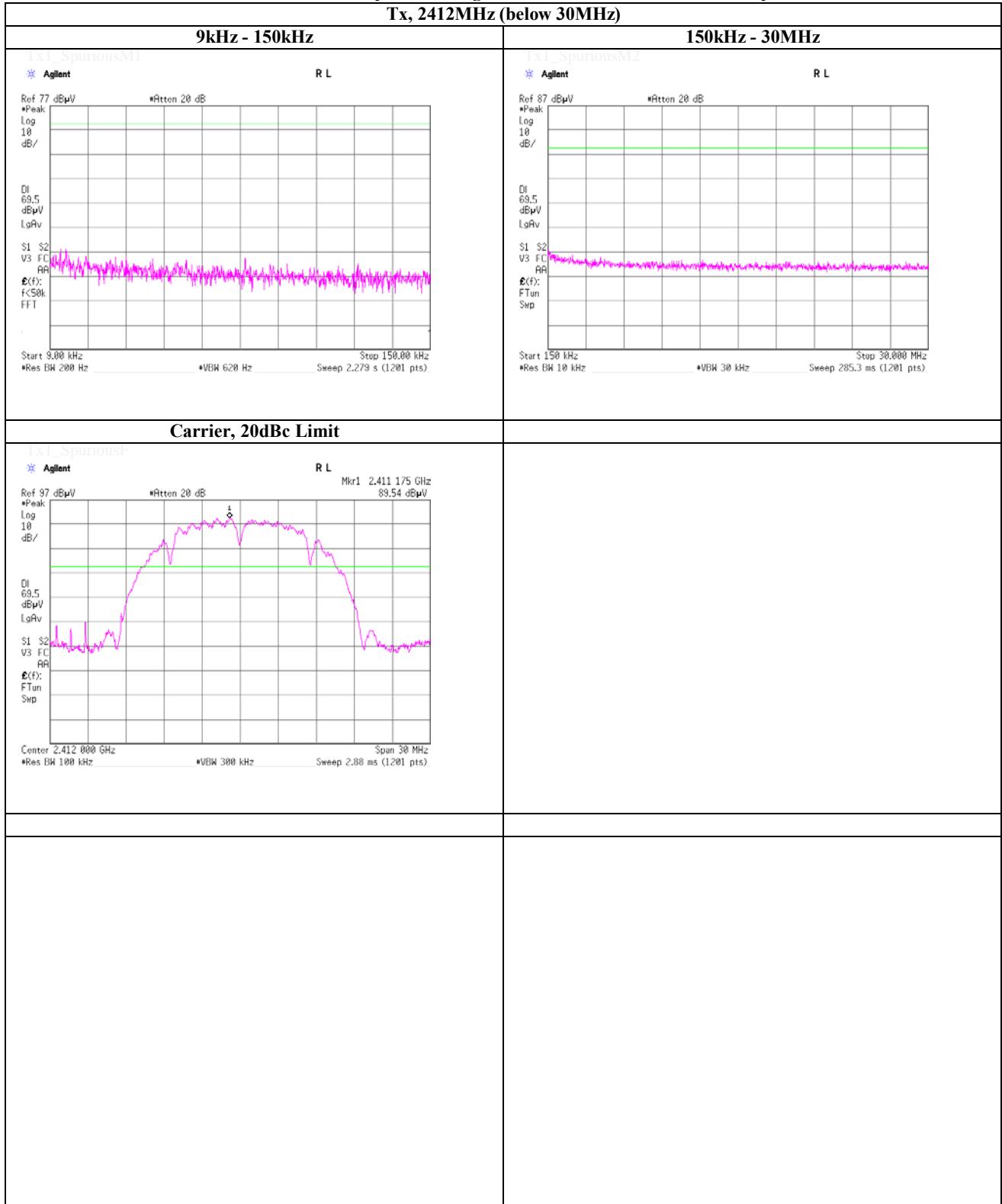
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Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11b, power setting 4dBm, PN9, worst data mode 2Mbps



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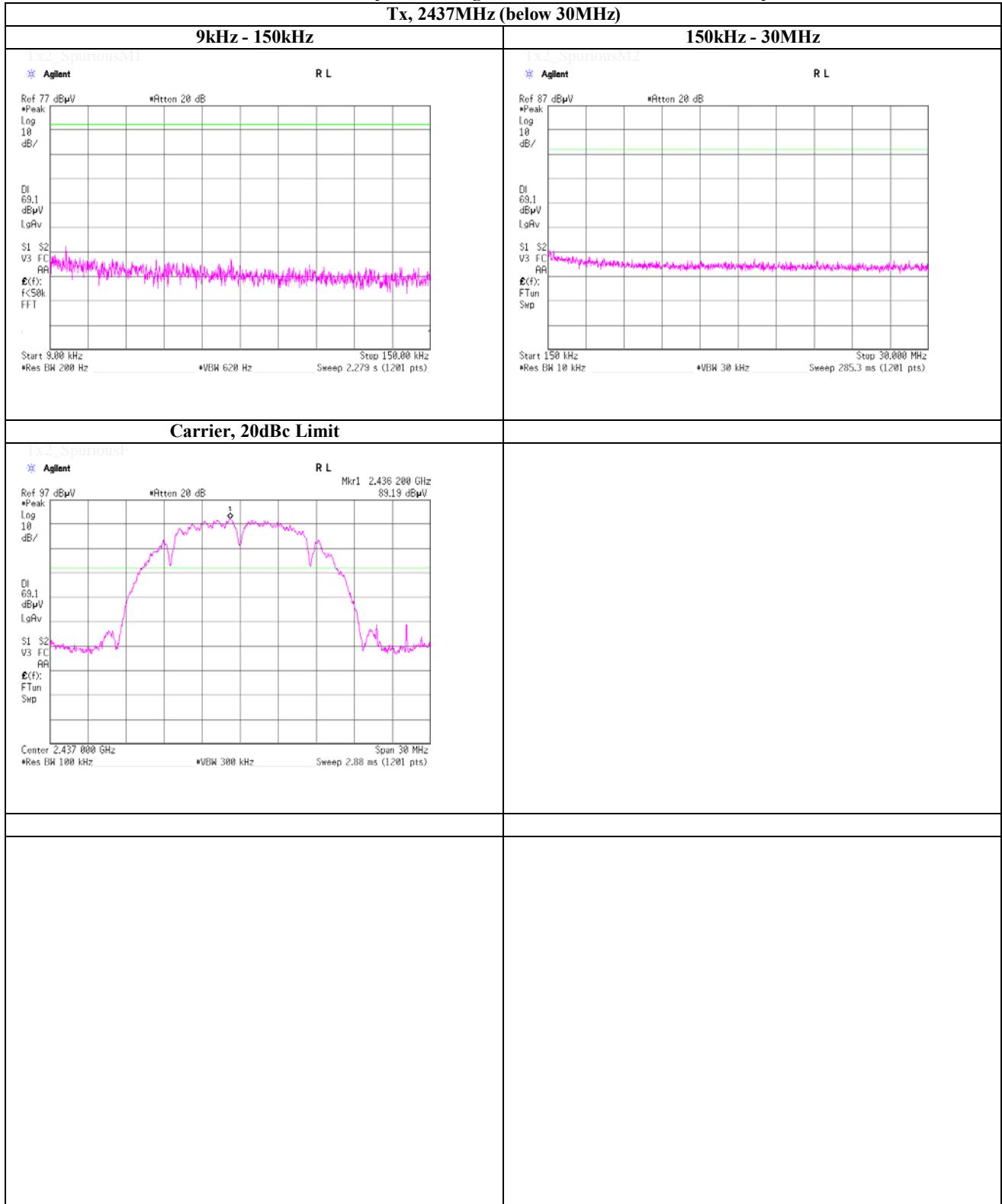
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 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11b, power setting 4dBm, PN9, worst data mode 2Mbps



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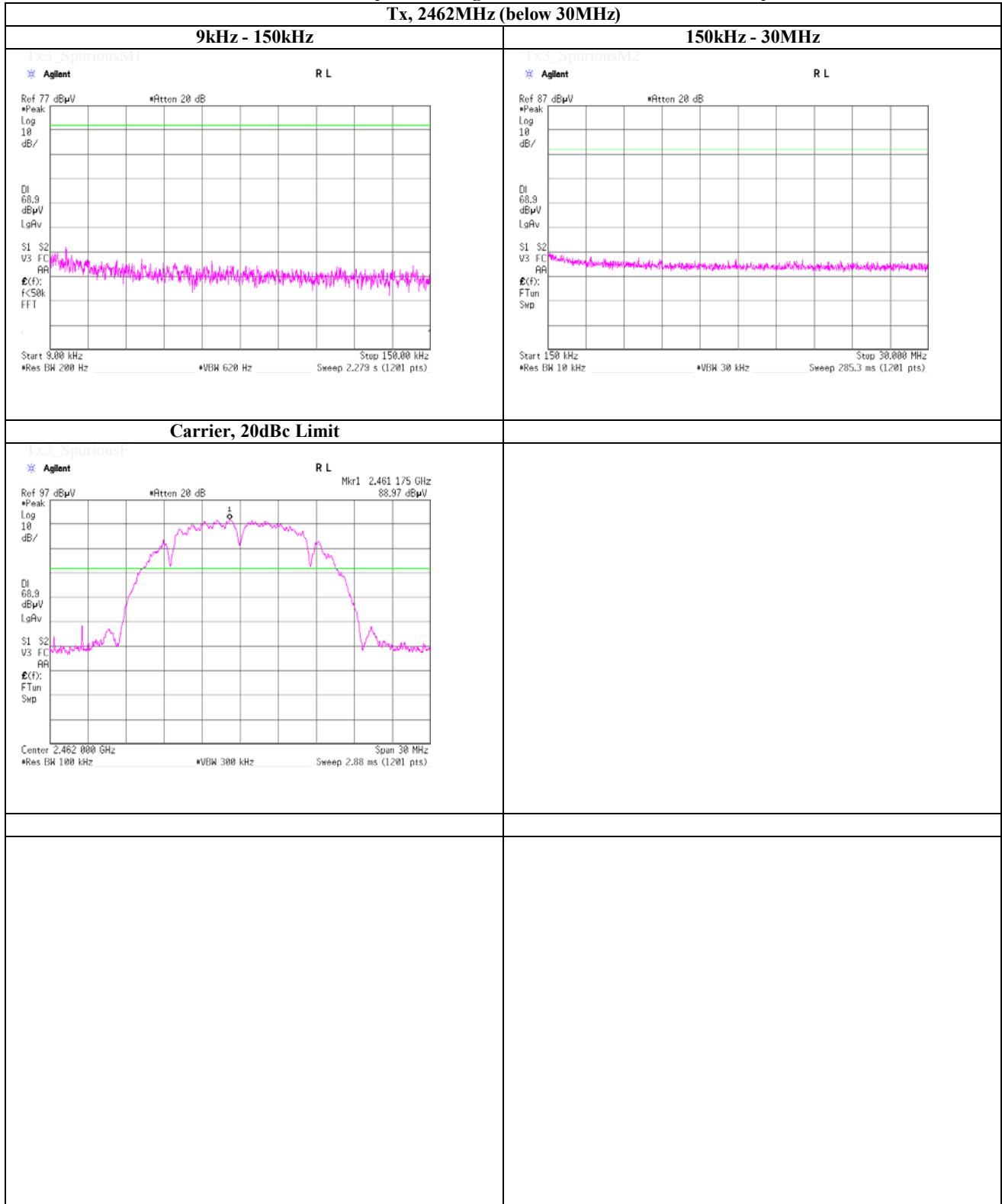
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 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11b, power setting 4dBm, PN9, worst data mode 2Mbps



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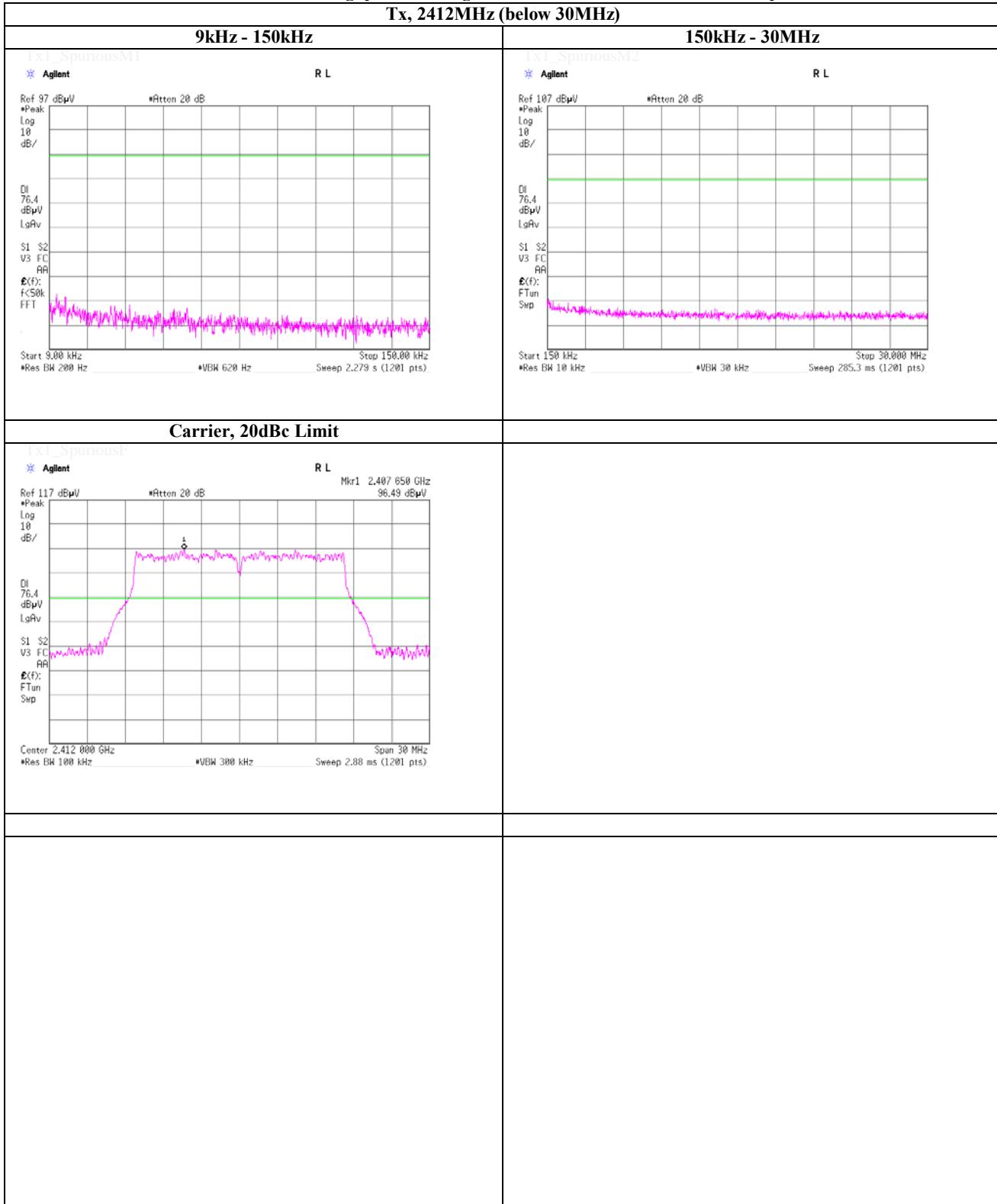
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Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11g, power setting 12dBm, PN9, worst data mode 48Mbps

Tx, 2412MHz (below 30MHz)



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1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

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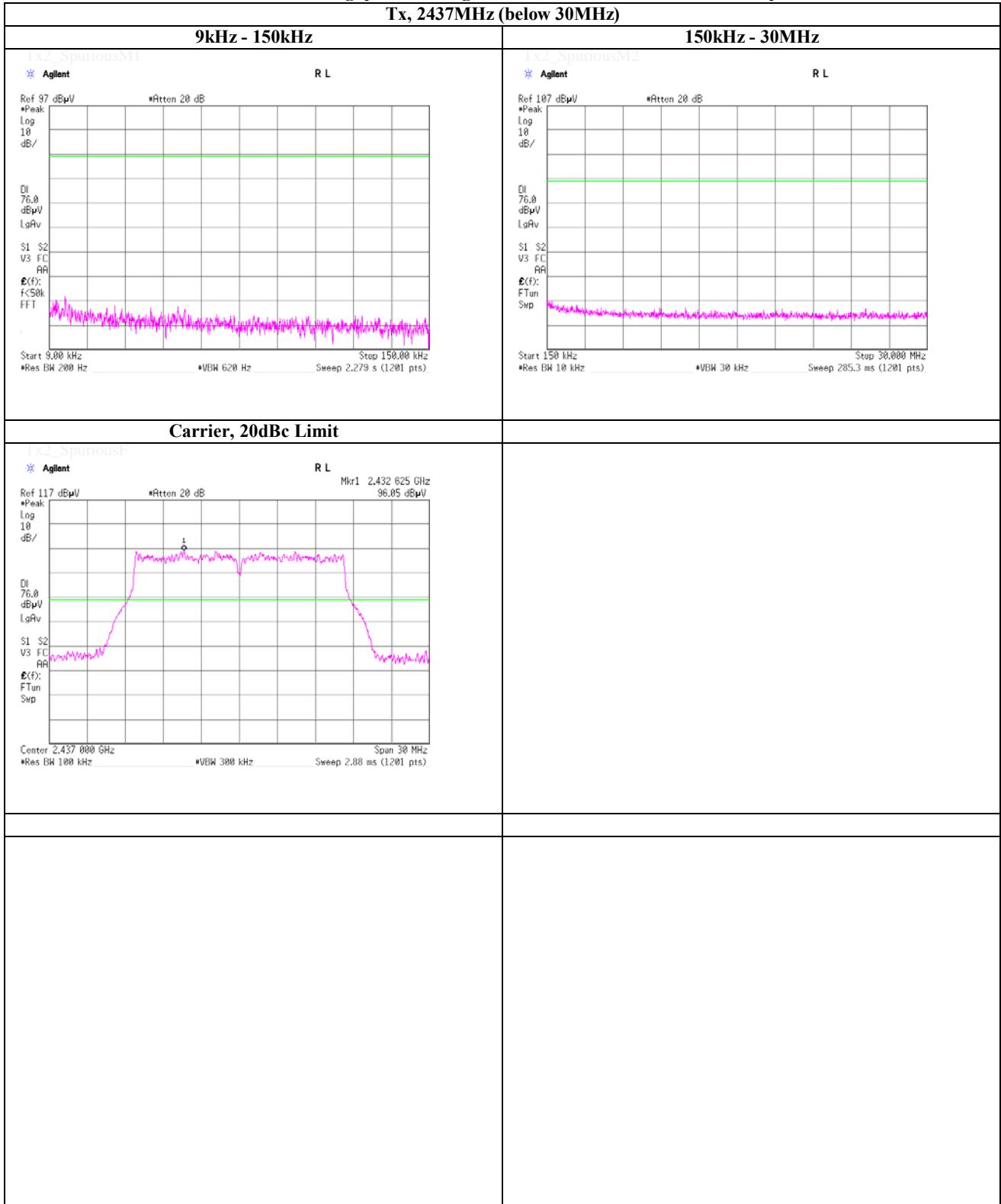
Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11g, power setting 12dBm, PN9, worst data mode 48Mbps

Tx, 2437MHz (below 30MHz)



UL Japan, Inc.

Shonan EMC Lab.

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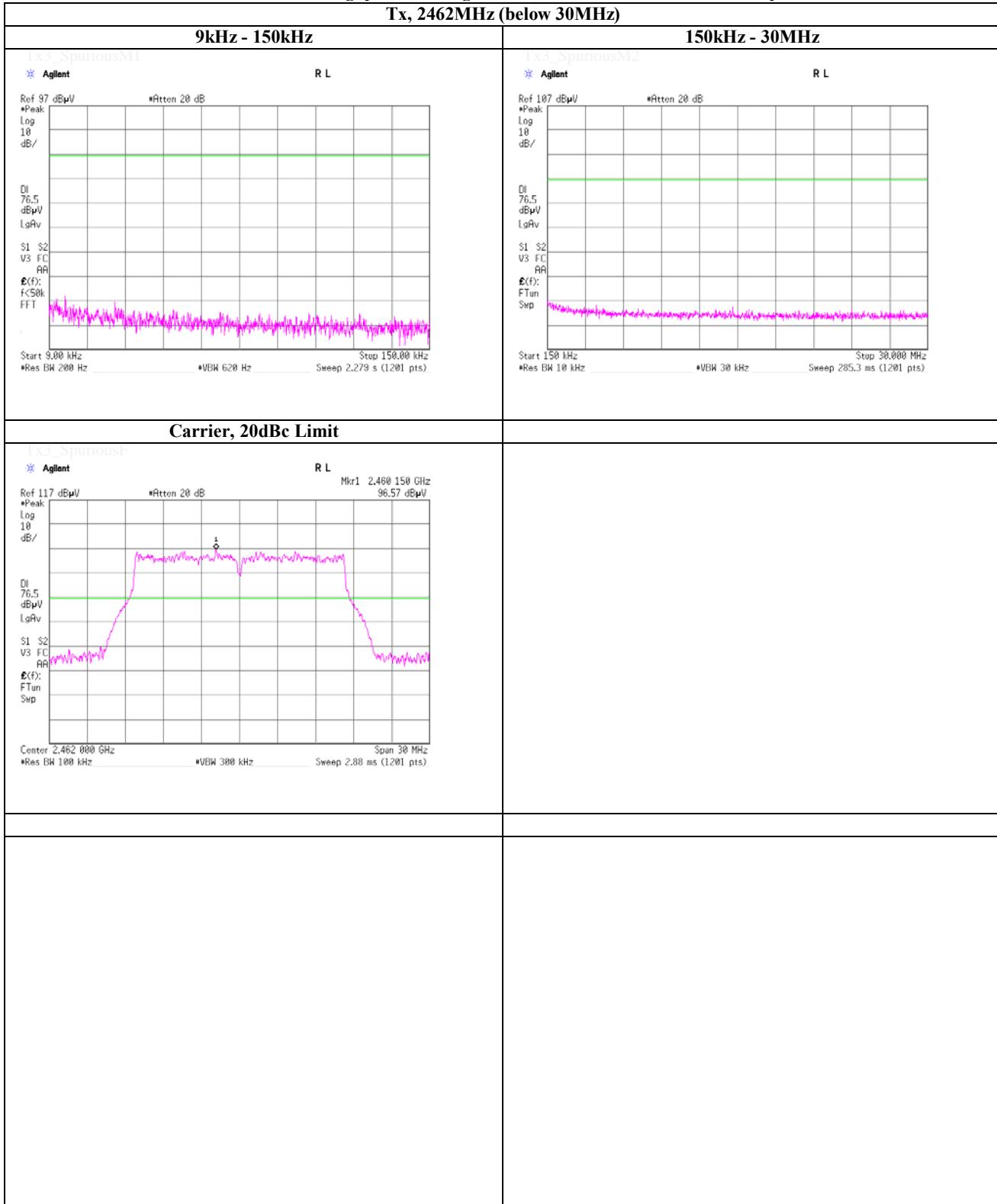
Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11g, power setting 12dBm, PN9, worst data mode 48Mbps

Tx, 2462MHz (below 30MHz)



UL Japan, Inc.

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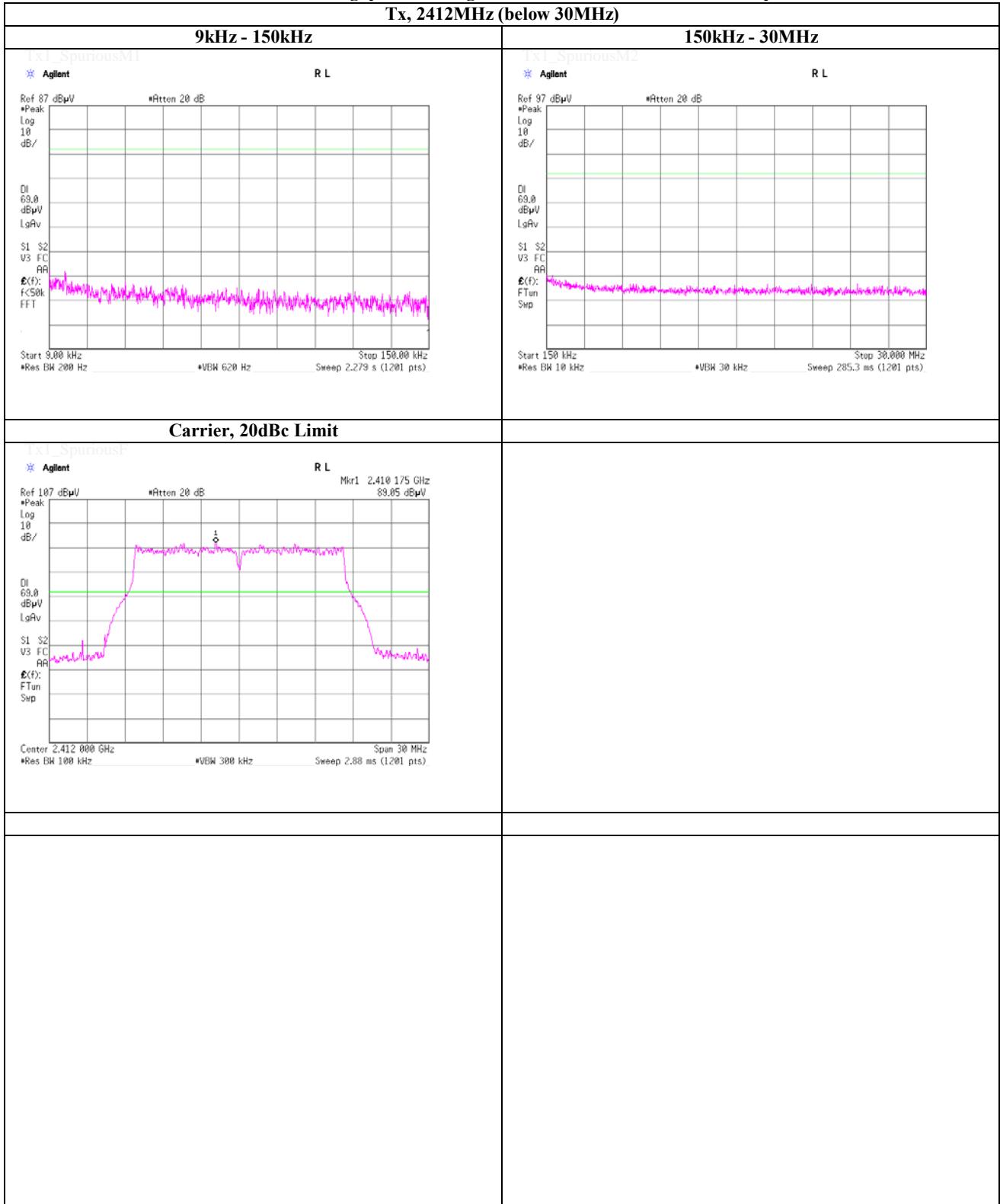
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Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11g, power setting 4dBm, PN9, worst data mode 48Mbps

Tx, 2412MHz (below 30MHz)



UL Japan, Inc.

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1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

Telephone : +81 463 50 6400

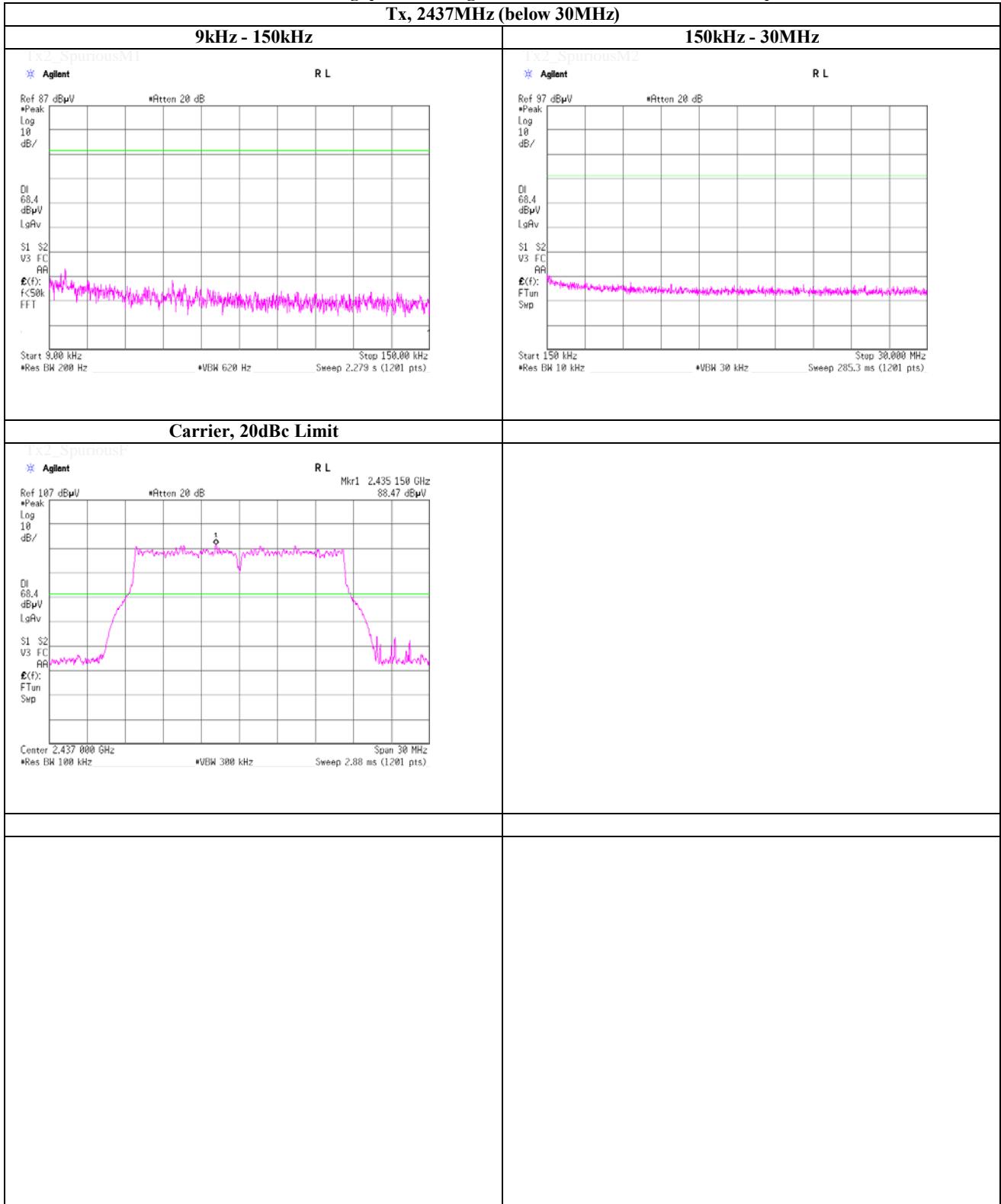
Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11g, power setting 4dBm, PN9, worst data mode 48Mbps

Tx, 2437MHz (below 30MHz)



UL Japan, Inc.

Shonan EMC Lab.

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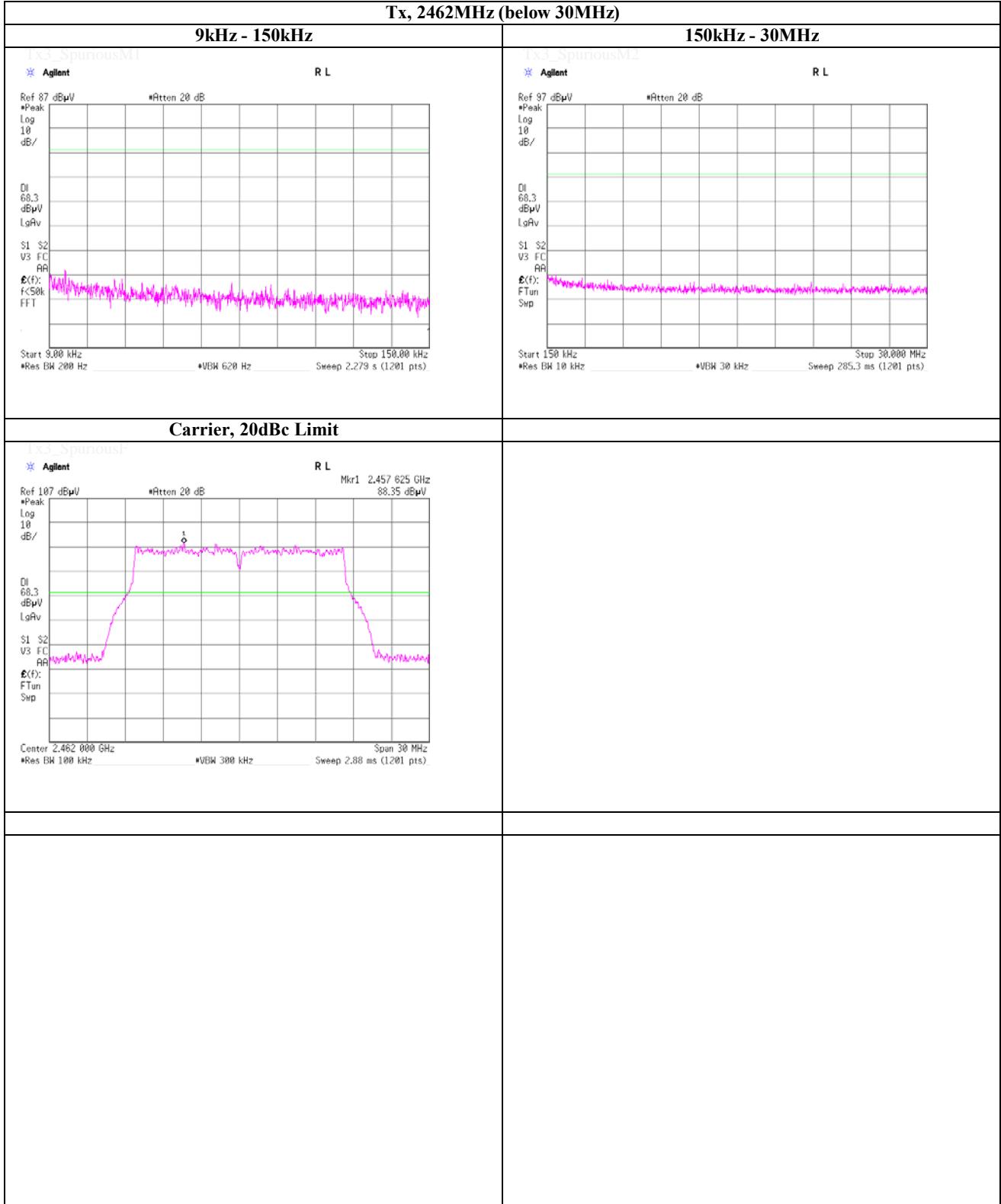
Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11g, power setting 4dBm, PN9, worst data mode 48Mbps

Tx, 2462MHz (below 30MHz)



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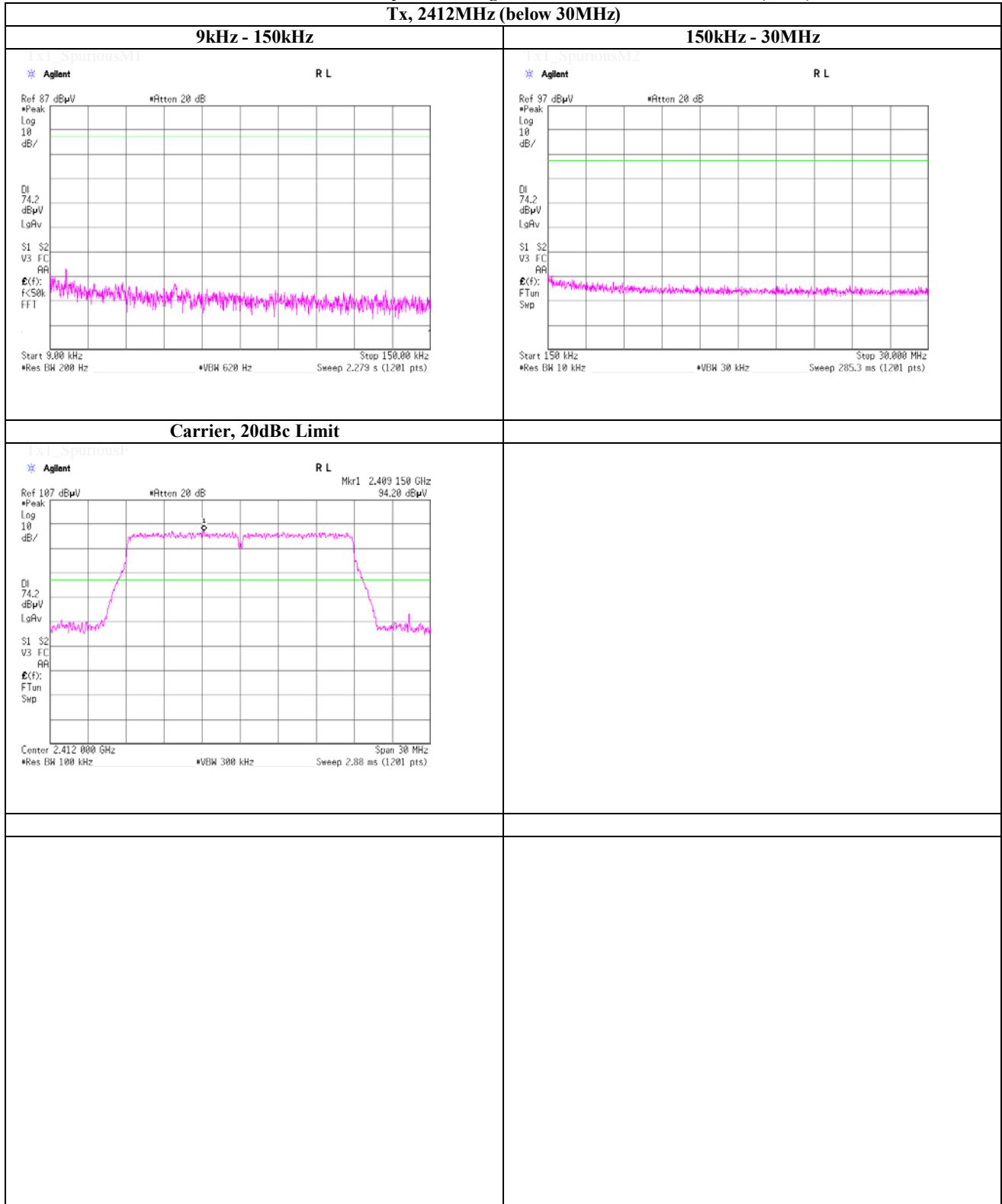
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11n HT20, power setting 12dBm, PN9, worst data mode 5(MCS)



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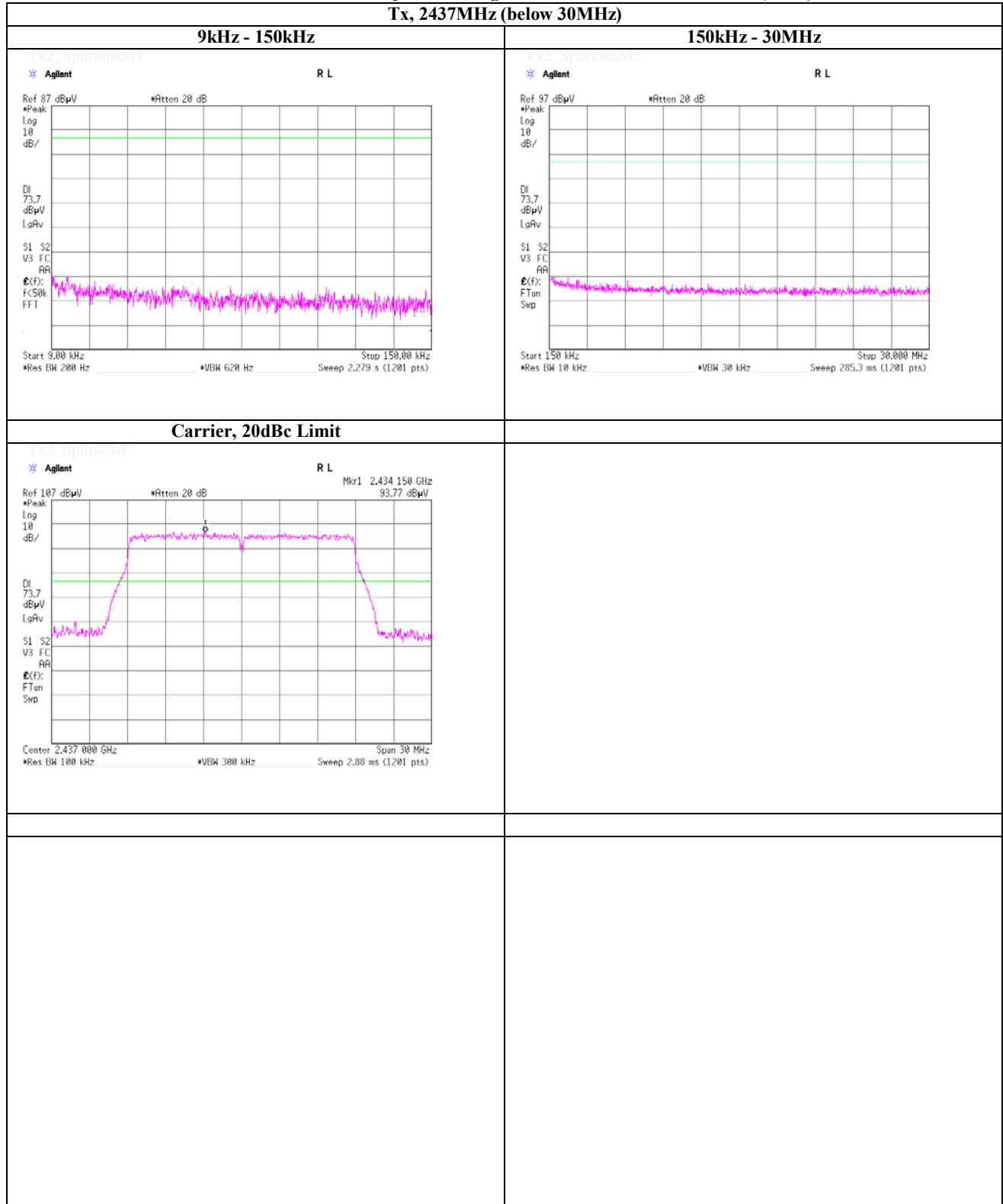
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11n HT20, power setting 12dBm, PN9, worst data mode 5(MCS)



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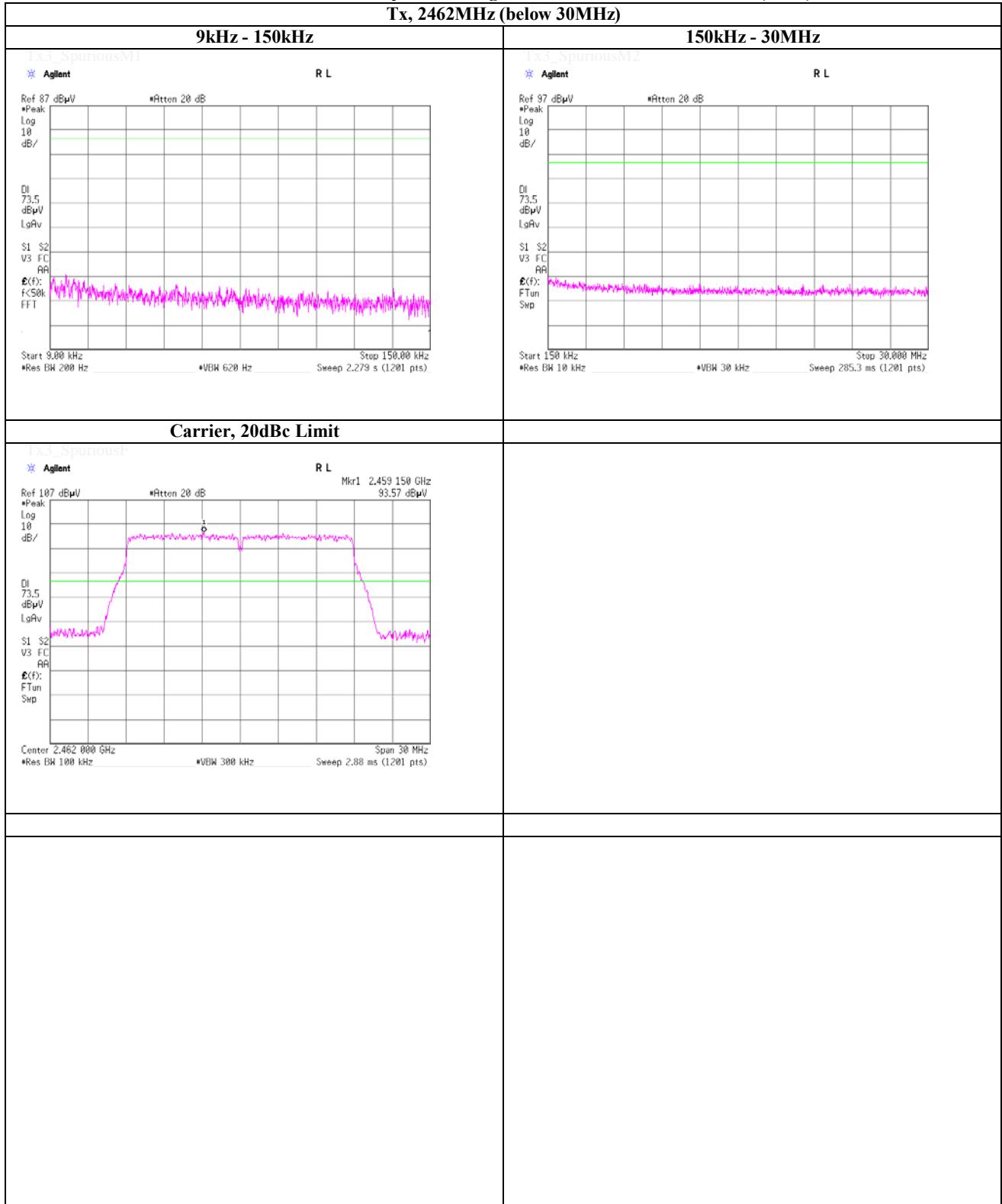
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11n HT20, power setting 12dBm, PN9, worst data mode 5(MCS)



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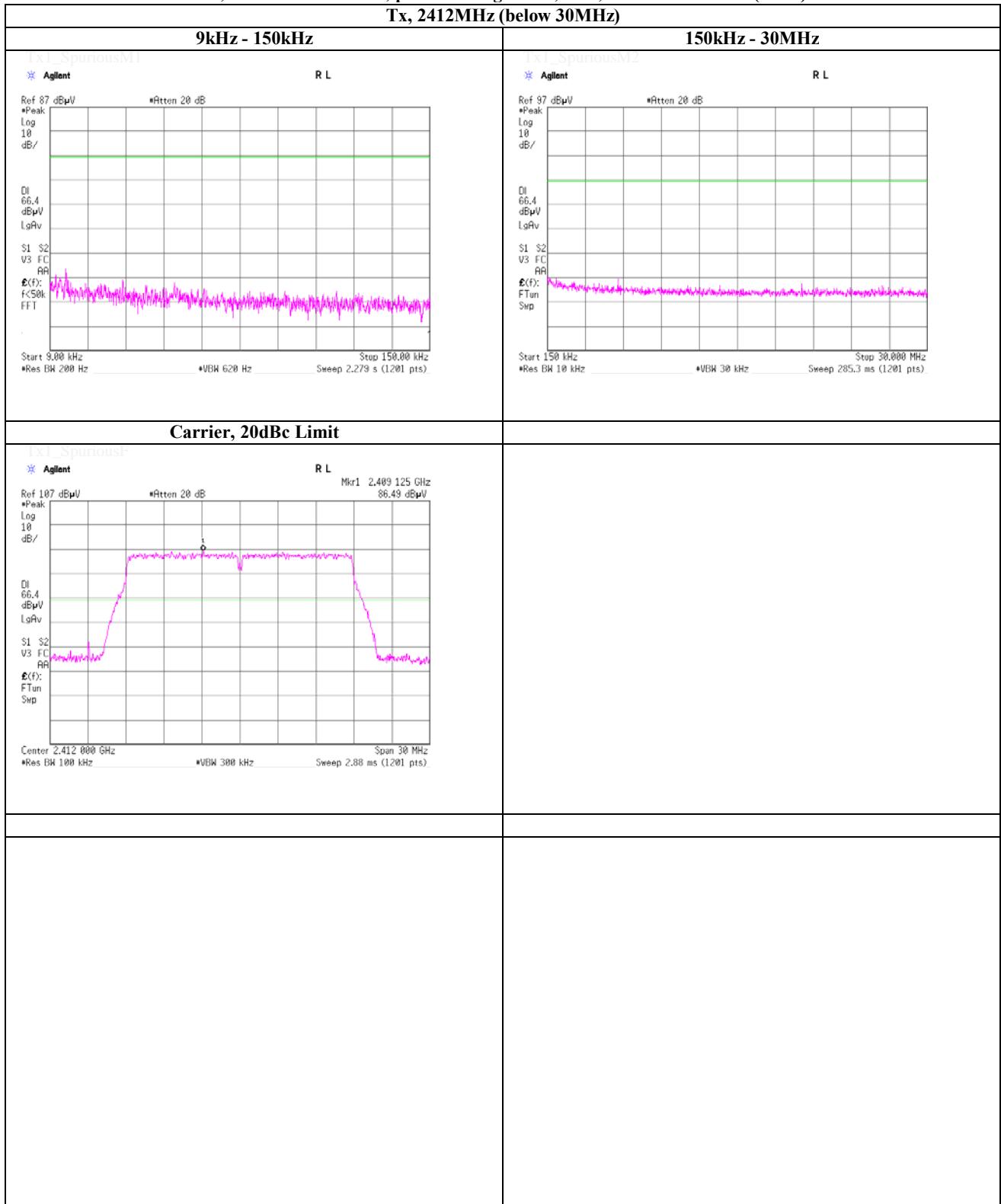
Telephone : +81 463 50 6400

Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11n HT20, power setting 4dBm, PN9, worst data mode 5(MCS)



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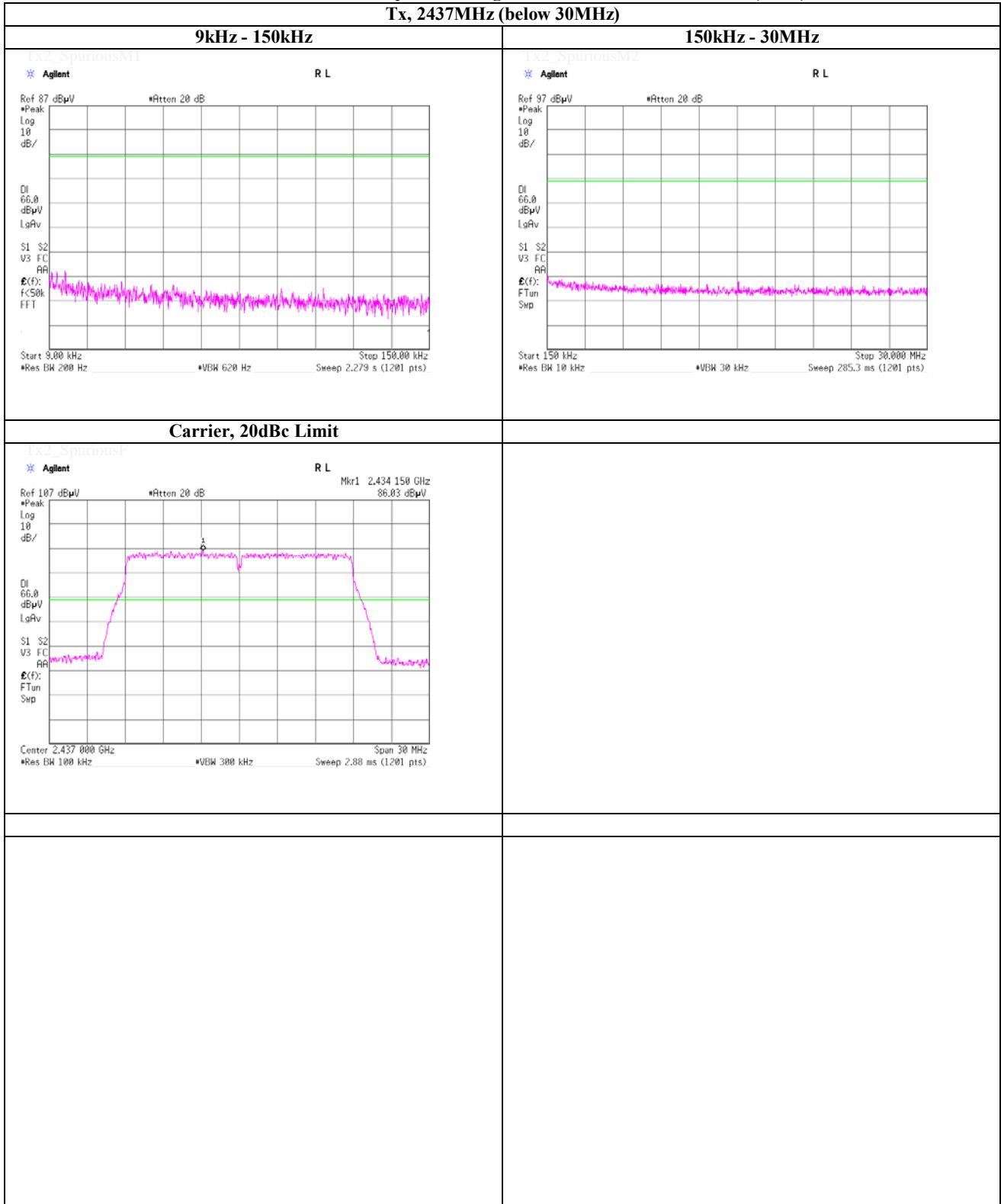
Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11n HT20, power setting 4dBm, PN9, worst data mode 5(MCS)

Tx, 2437MHz (below 30MHz)



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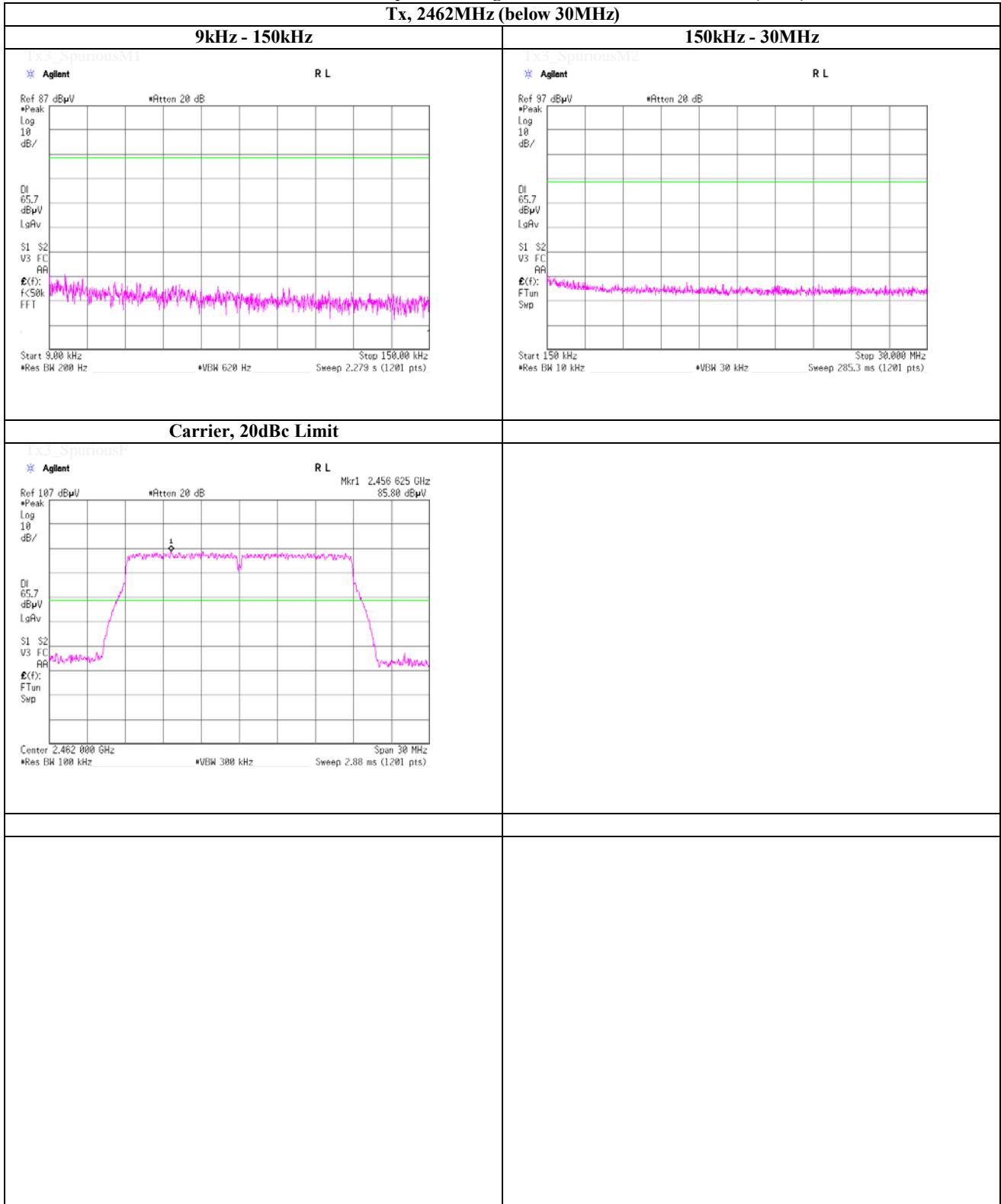
Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

Spurious emission (Conducted)

Tx, IEEE802.11n HT20, power setting 4dBm, PN9, worst data mode 5(MCS)

Tx, 2462MHz (below 30MHz)



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Shonan EMC Lab.

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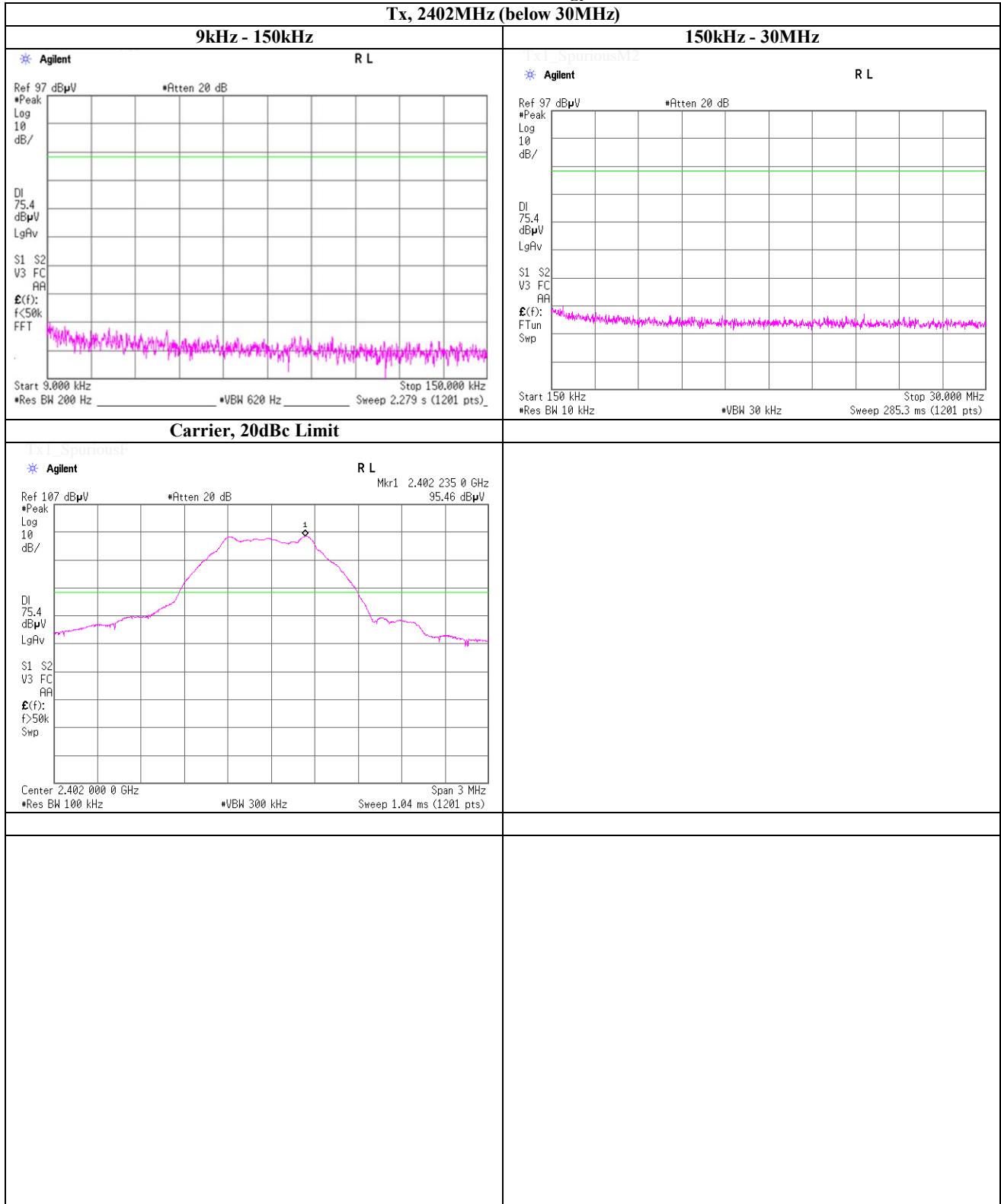
Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room
 Date 'October 24, 2014
 Temperature / Humidity 24deg.C , 55%RH
 Engineer Tatsuya Arai

Spurious emission (Conducted)

Tx, Bluetooth, Low Energy, PN9

Tx, 2402MHz (below 30MHz)



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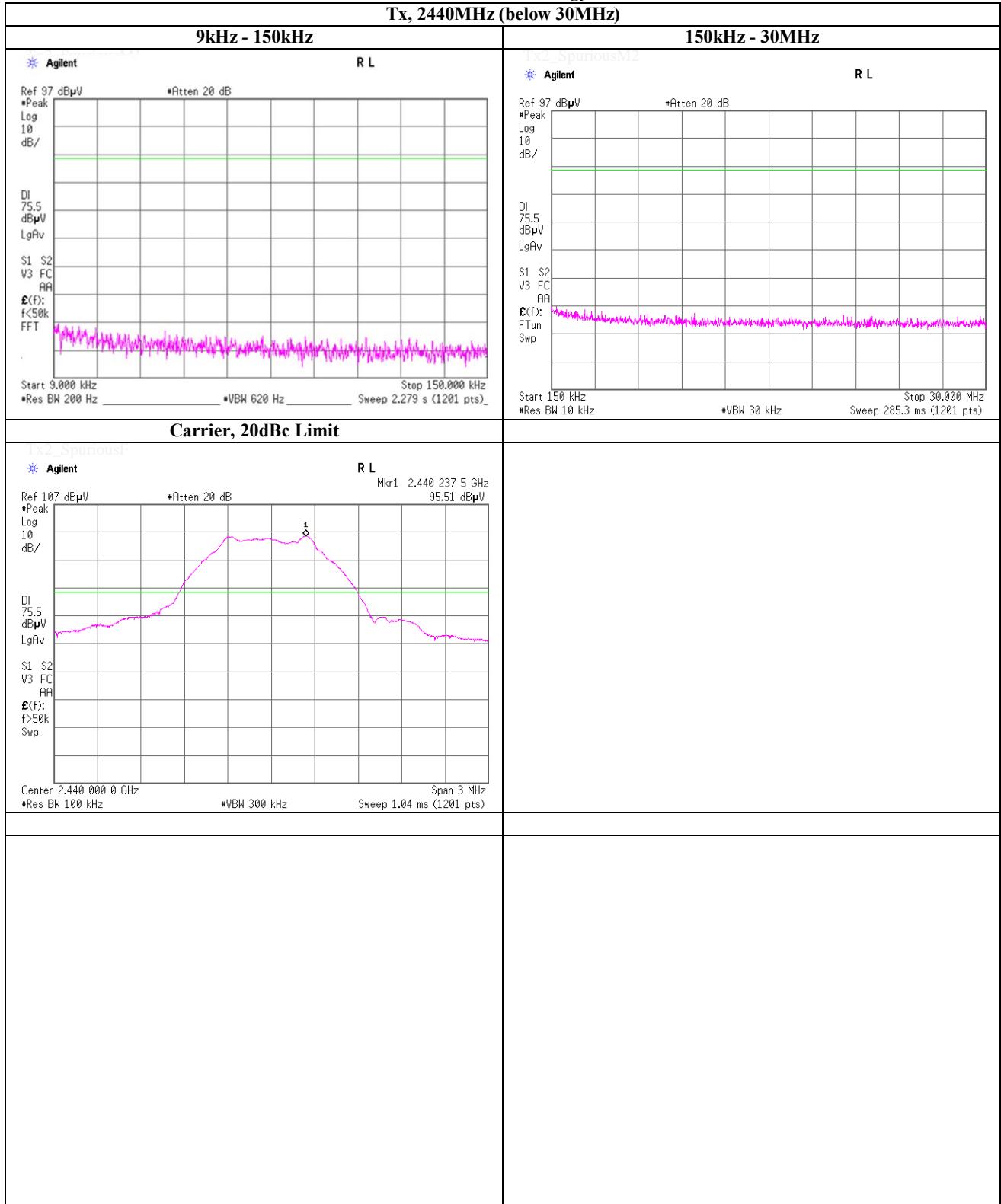
Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room
 Date 'October 24, 2014
 Temperature / Humidity 24deg.C , 55%RH
 Engineer Tatsuya Arai

Spurious emission (Conducted)

Tx, Bluetooth, Low Energy, PN9

Tx, 2440MHz (below 30MHz)



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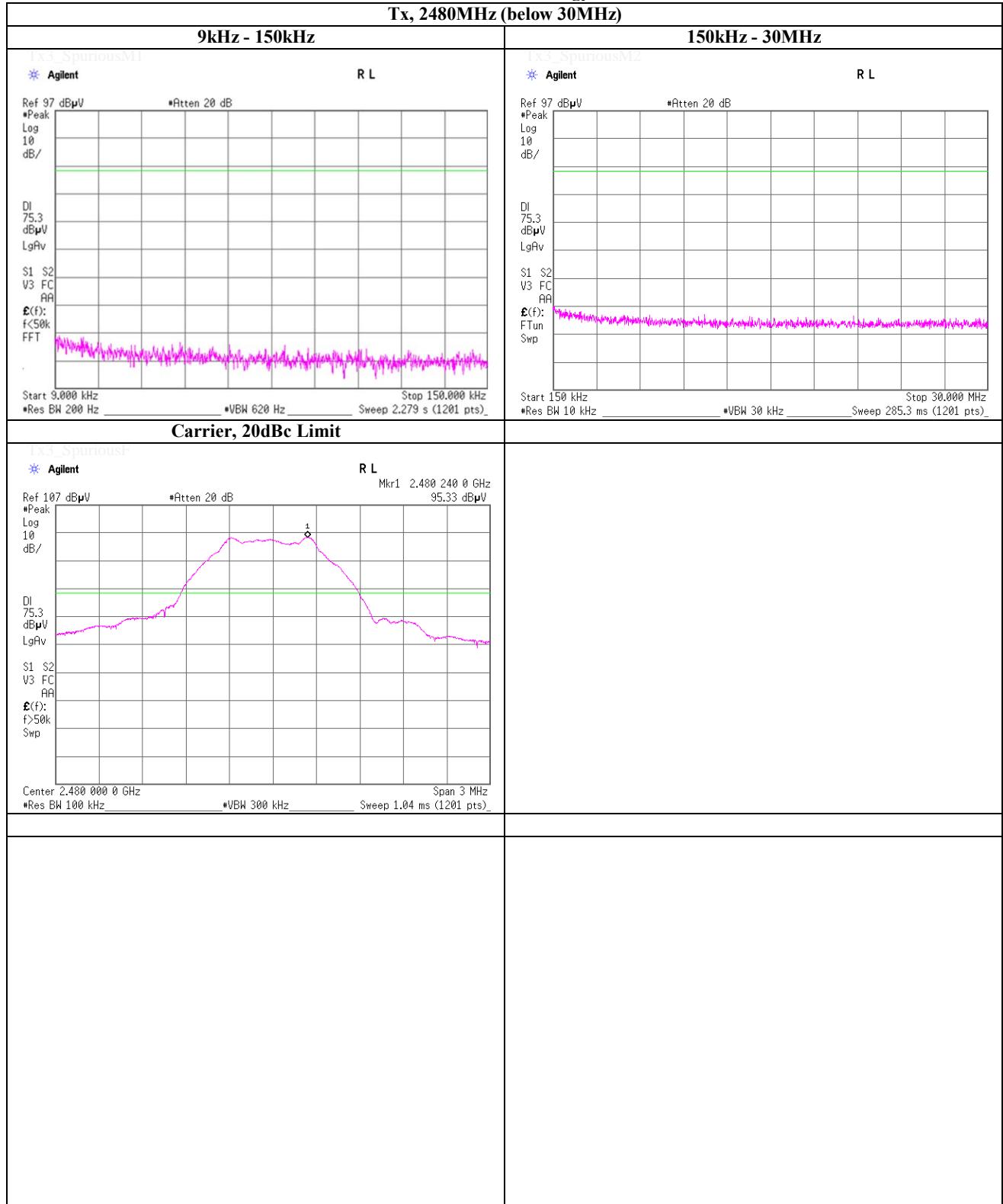
Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room
 Date 'October 24, 2014
 Temperature / Humidity 24deg.C , 55%RH
 Engineer Tatsuya Arai

Spurious emission (Conducted)

Tx, Bluetooth, Low Energy, PN9

Tx, 2480MHz (below 30MHz)



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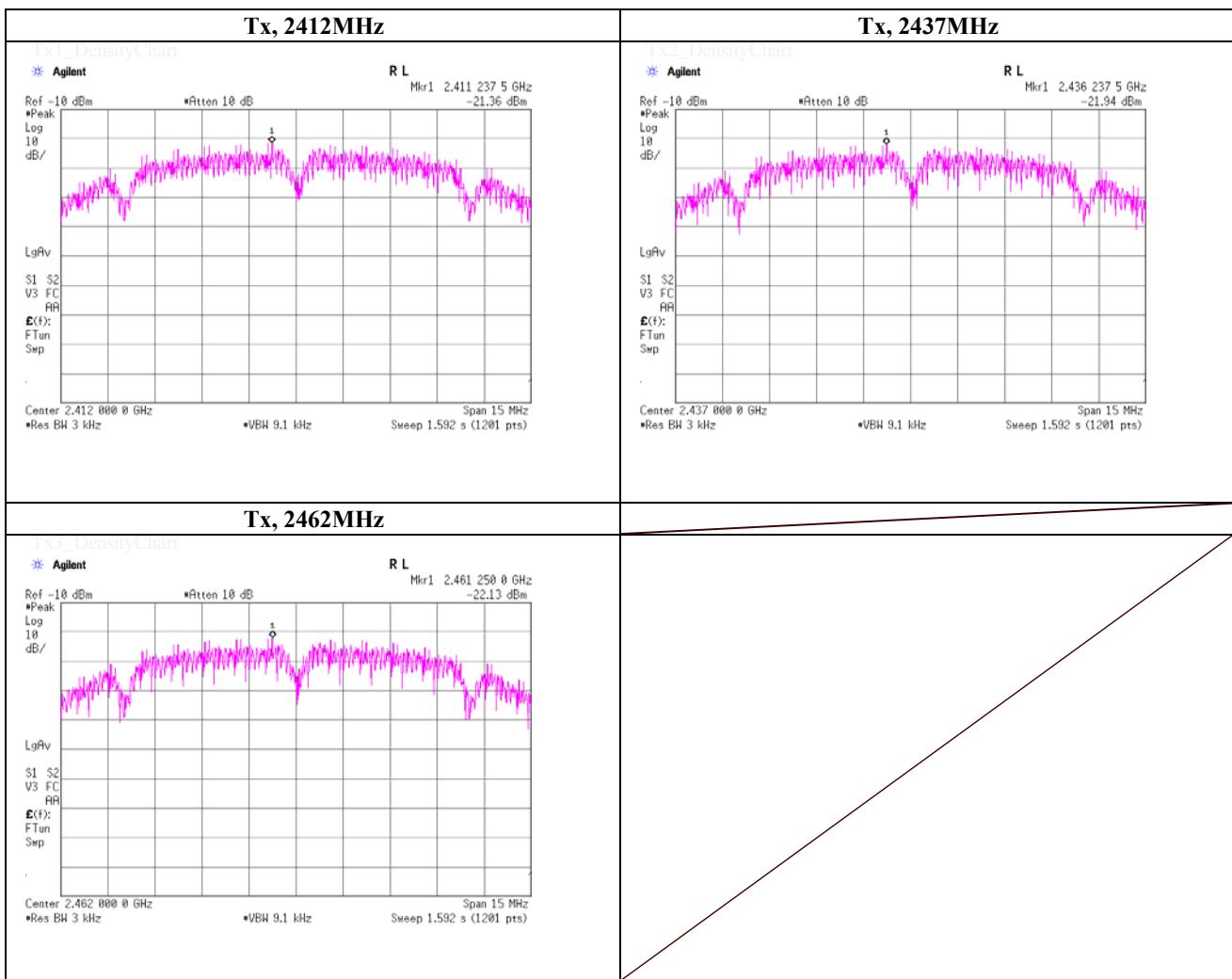
Maximum Power Spectral Density (PKPSD)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11b, power setting 12dBm, PN9, worst data mode 2Mbps

Ch. Freq. [MHz]	Freq. Reading [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
2412.0000	2411.24	-21.36	2.16	9.90	-9.30	8.00	17.30
2437.0000	2436.24	-21.94	2.17	9.90	-9.87	8.00	17.87
2462.0000	2461.25	-22.13	2.18	9.90	-10.05	8.00	18.05

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss

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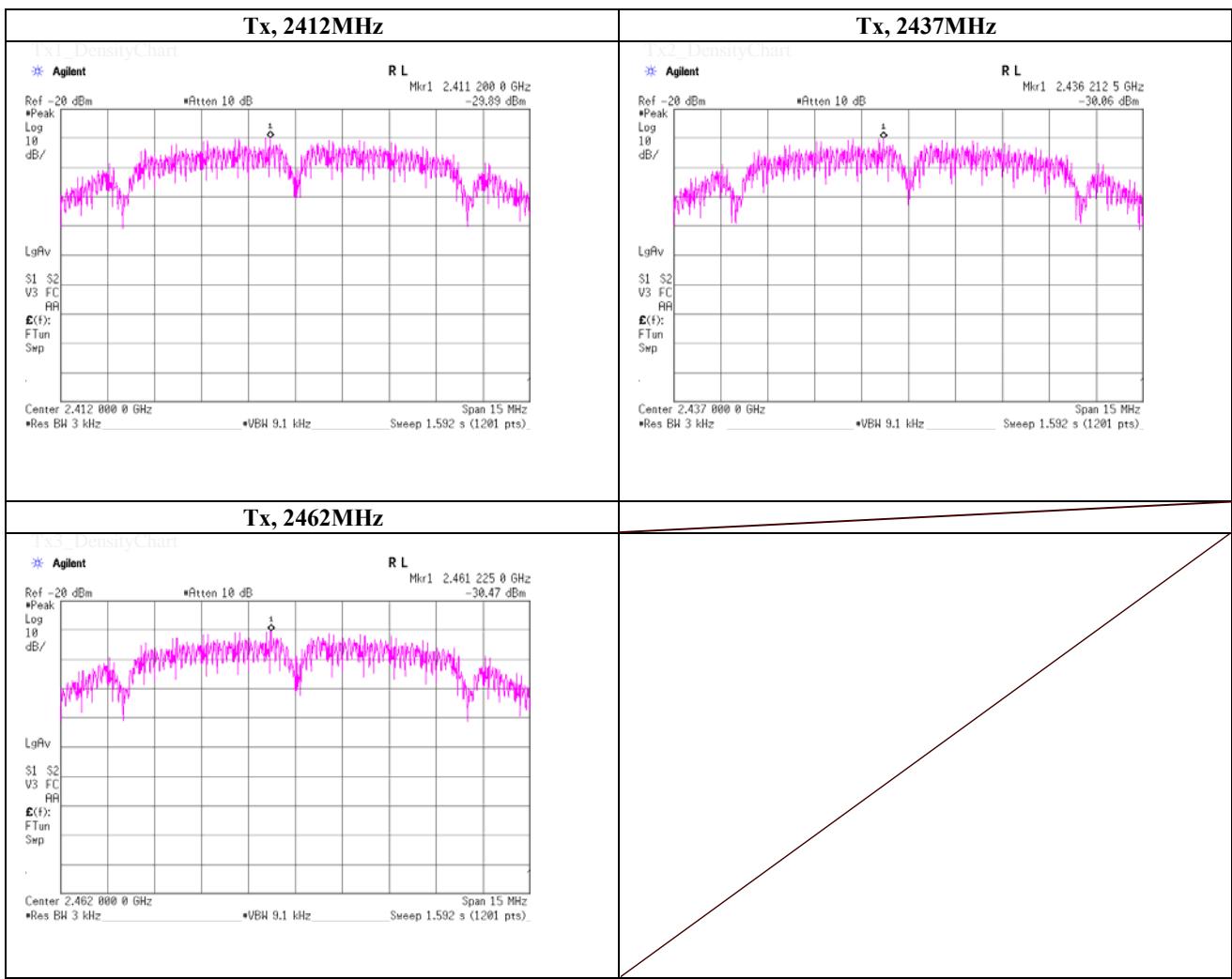
Maximum Power Spectral Density (PKPSD)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11b, power setting 4dBm, PN9, worst data mode 2Mbps

Ch. Freq. [MHz]	Freq. Reading [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
2412.0000	2411.20	-29.89	2.16	9.90	-17.83	8.00	25.83
2437.0000	2436.21	-30.06	2.17	9.90	-17.99	8.00	25.99
2462.0000	2461.23	-30.47	2.18	9.90	-18.39	8.00	26.39

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss



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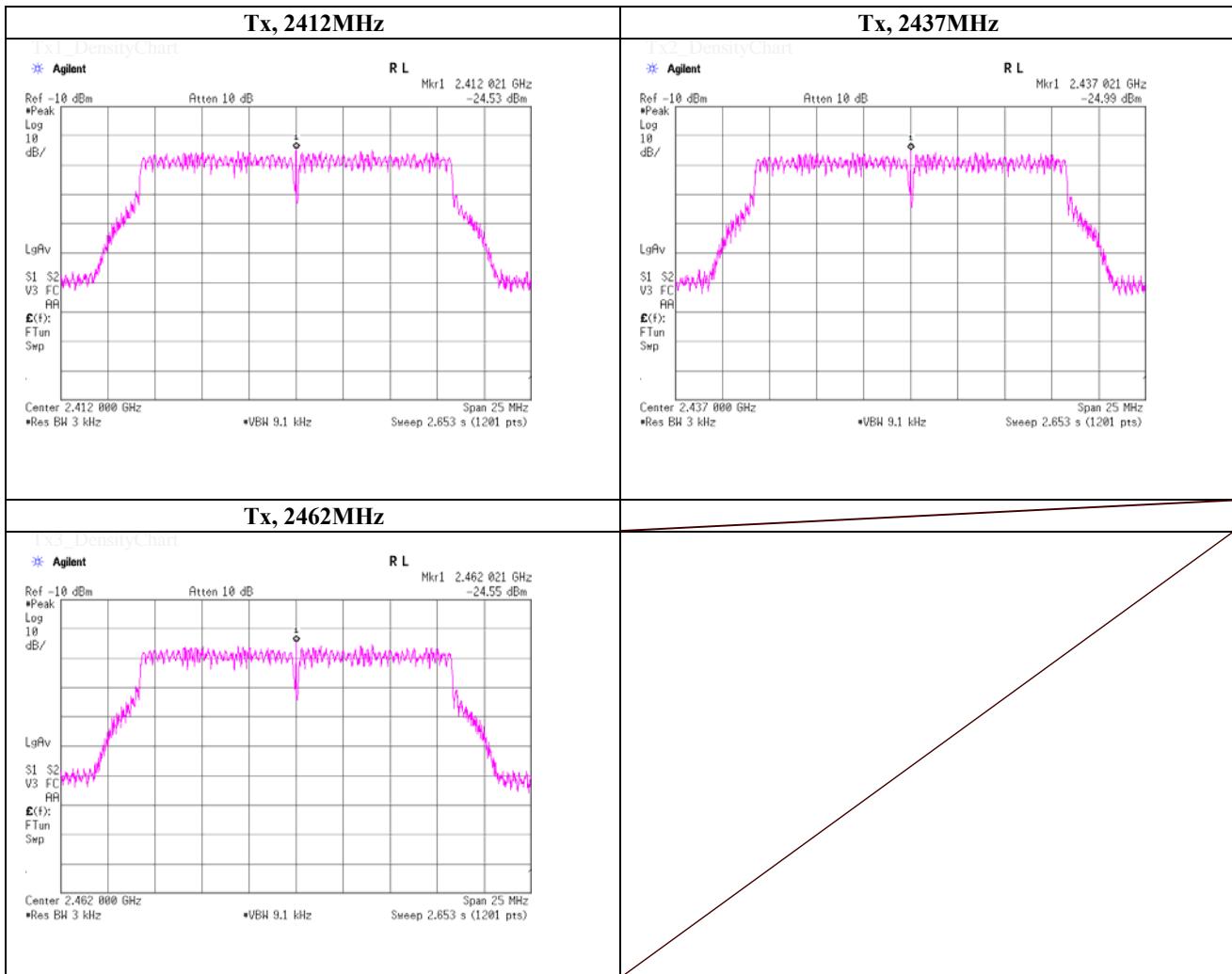
Maximum Power Spectral Density (PKPSD)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11g, power setting 12dBm, PN9, worst data mode 48Mbps

Ch. Freq. [MHz]	Freq. Reading [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
2412.0000	2412.02	-24.53	2.16	9.90	-12.47	8.00	20.47
2437.0000	2437.02	-24.99	2.17	9.90	-12.92	8.00	20.92
2462.0000	2462.04	-24.55	2.18	9.90	-12.47	8.00	20.47

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss



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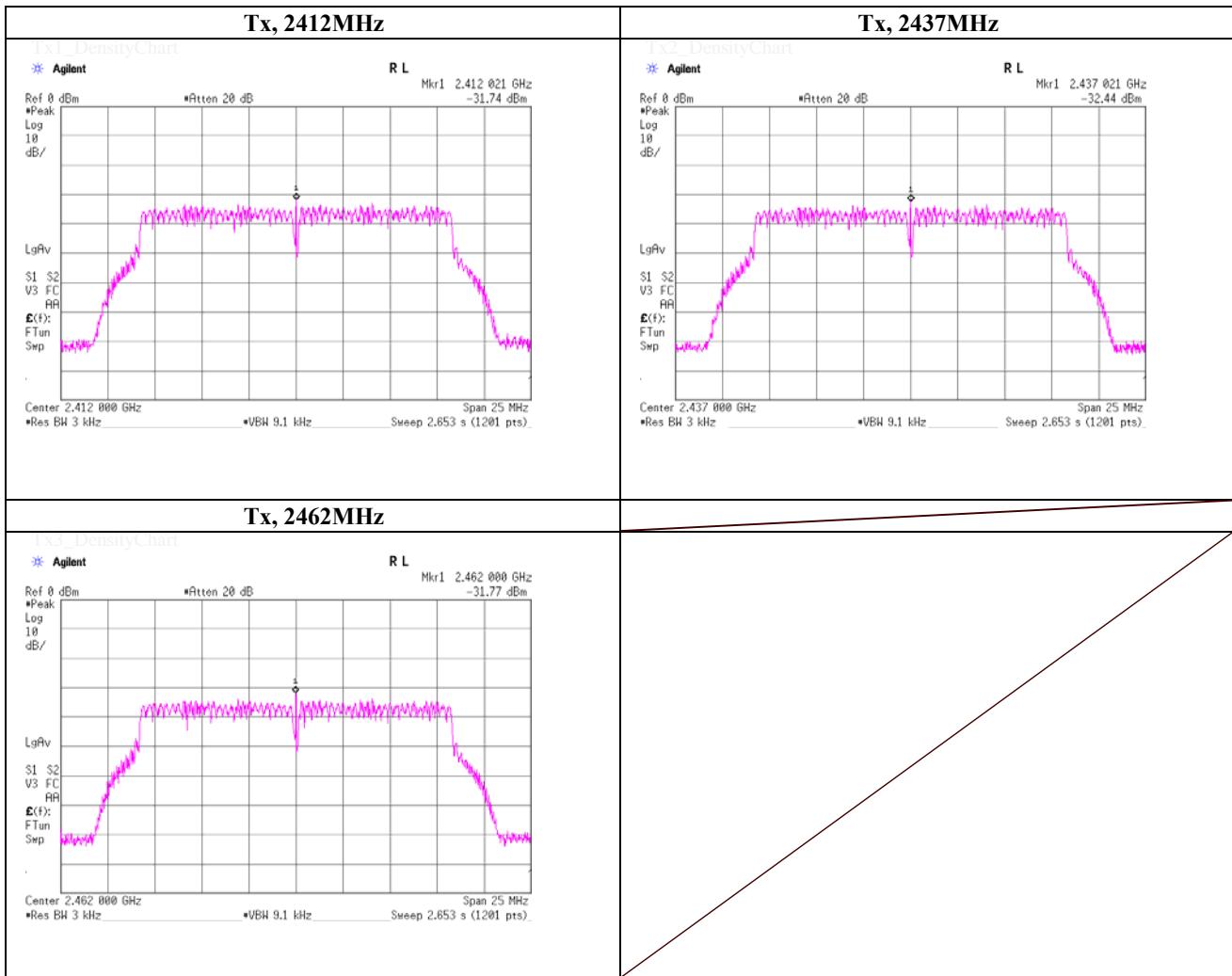
Maximum Power Spectral Density (PKPSD)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11g, power setting 4dBm, PN9, worst data mode 48Mbps

Ch. Freq. [MHz]	Freq. Reading [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
2412.0000	2412.02	-31.74	2.16	9.90	-19.68	8.00	27.68
2437.0000	2437.02	-32.44	2.17	9.90	-20.37	8.00	28.37
2462.0000	2462.00	-31.77	2.18	9.90	-19.69	8.00	27.69

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss

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Facsimile : +81 463 50 6401

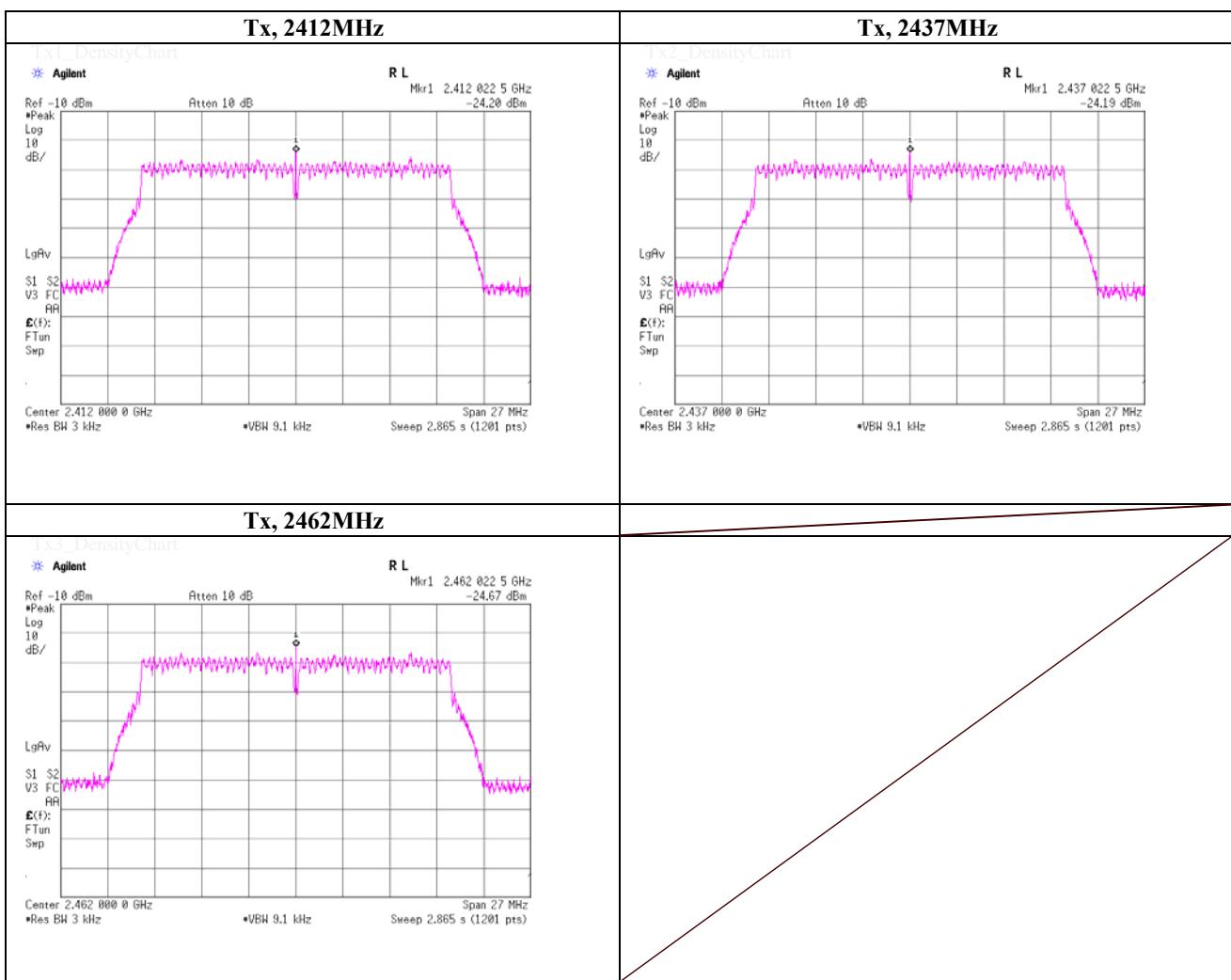
Maximum Power Spectral Density (PKPSD)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11n HT20, power setting 12dBm, PN9, worst data mode 5(MCS)

Ch. Freq. [MHz]	Freq. Reading [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
2412.0000	2412.02	-24.20	2.16	9.90	-12.14	8.00	20.14
2437.0000	2437.02	-24.19	2.17	9.90	-12.12	8.00	20.12
2462.0000	2462.05	-24.67	2.18	9.90	-12.59	8.00	20.59

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss



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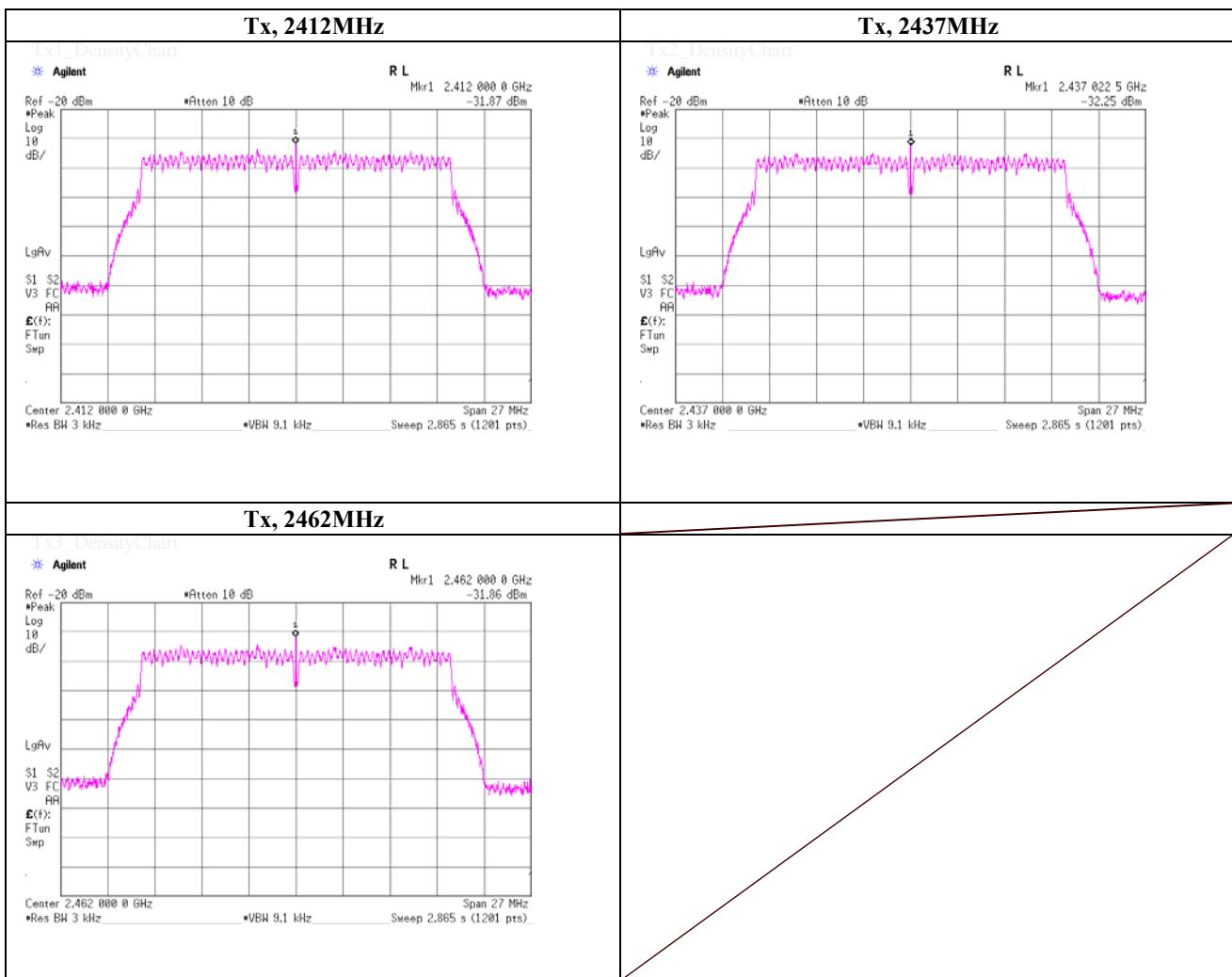
Maximum Power Spectral Density (PKPSD)

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi
 Mode Tx, IEEE802.11n HT20, power setting 4dBm, PN9, worst data mode 5(MCS)

Ch. Freq. [MHz]	Freq. Reading [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
2412.0000	2412.00	-31.87	2.16	9.90	-19.81	8.00	27.81
2437.0000	2437.02	-32.25	2.17	9.90	-20.18	8.00	28.18
2462.0000	2462.00	-31.86	2.18	9.90	-19.78	8.00	27.78

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss

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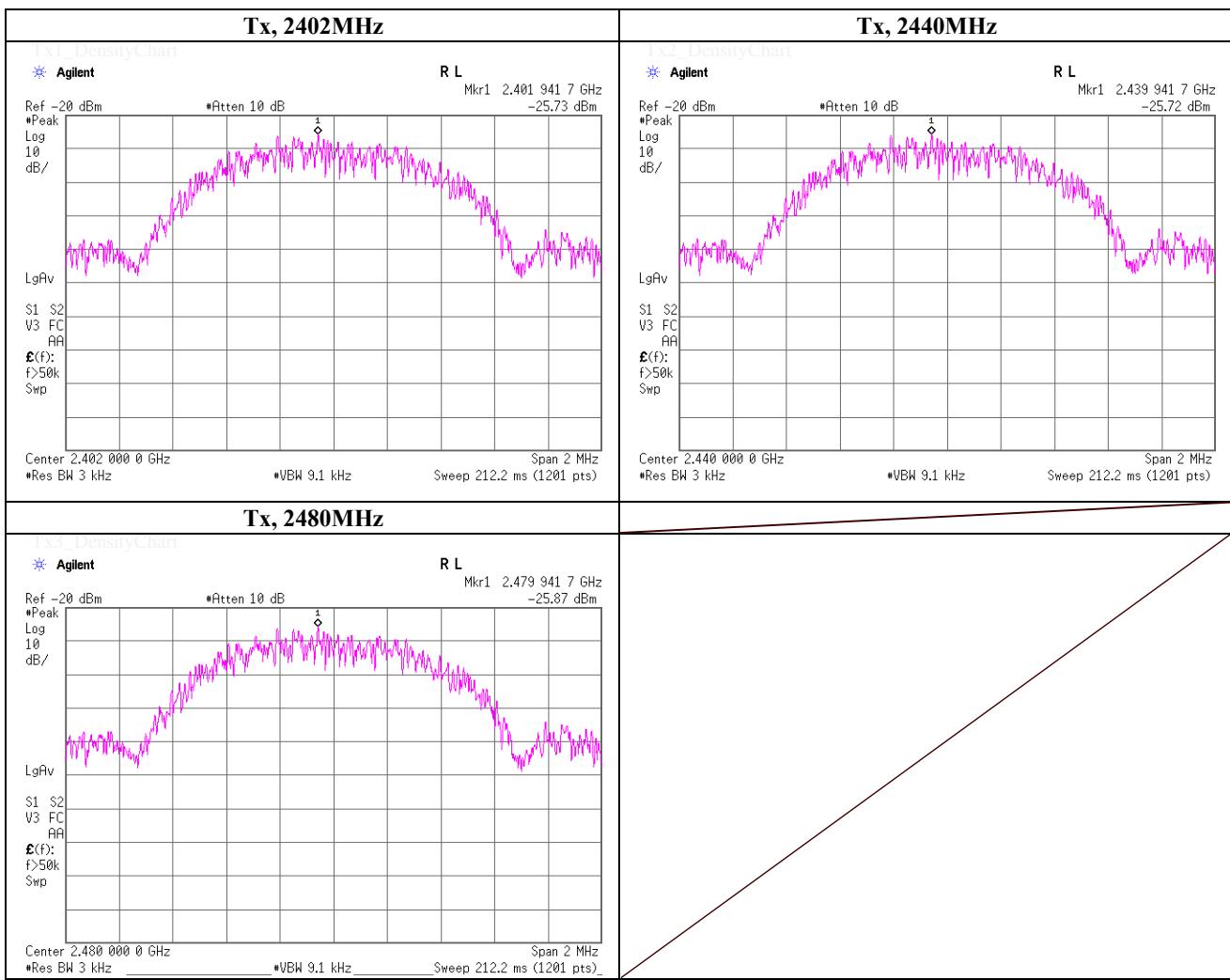
Maximum Power Spectral Density (PKPSD)

Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room
 Date 'October 24, 2014
 Temperature / Humidity 24deg.C , 55%RH
 Engineer Tatsuya Arai
 Mode Tx, Bluetooth, Low Energy, PN9

Ch. Freq. [MHz]	Freq. Reading [MHz]	Reading [dBm]	Cable Loss [dB]	Atten. [dB]	Result [dBm]	Limit [dBm]	Margin [dB]
2402.0000	2401.94	-25.73	2.19	9.90	-13.64	8.00	21.64
2440.0000	2439.94	-25.72	2.20	9.90	-13.62	8.00	21.62
2480.0000	2479.94	-25.87	2.21	9.90	-13.76	8.00	21.76

Sample Calculation:

Result = Reading + Cable Loss (including the cable(s) customer supplied) + Atten. Loss

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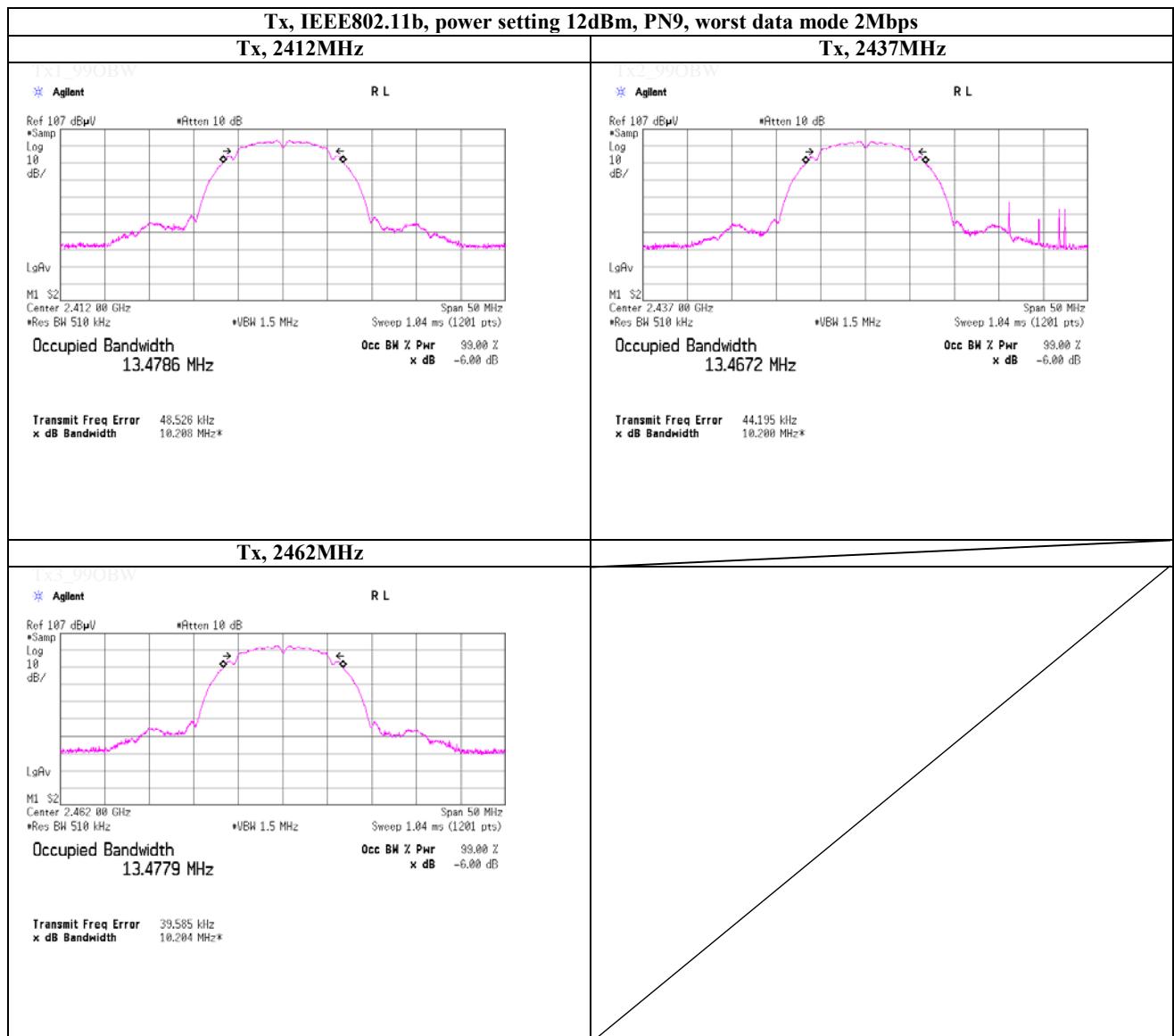
1-22-3 Megumigaoka, Hiratsuka-shi, Kanagawa 259-1220 JAPAN

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Facsimile : +81 463 50 6401

Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

99% Occupied Bandwidth



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Shonan EMC Lab.

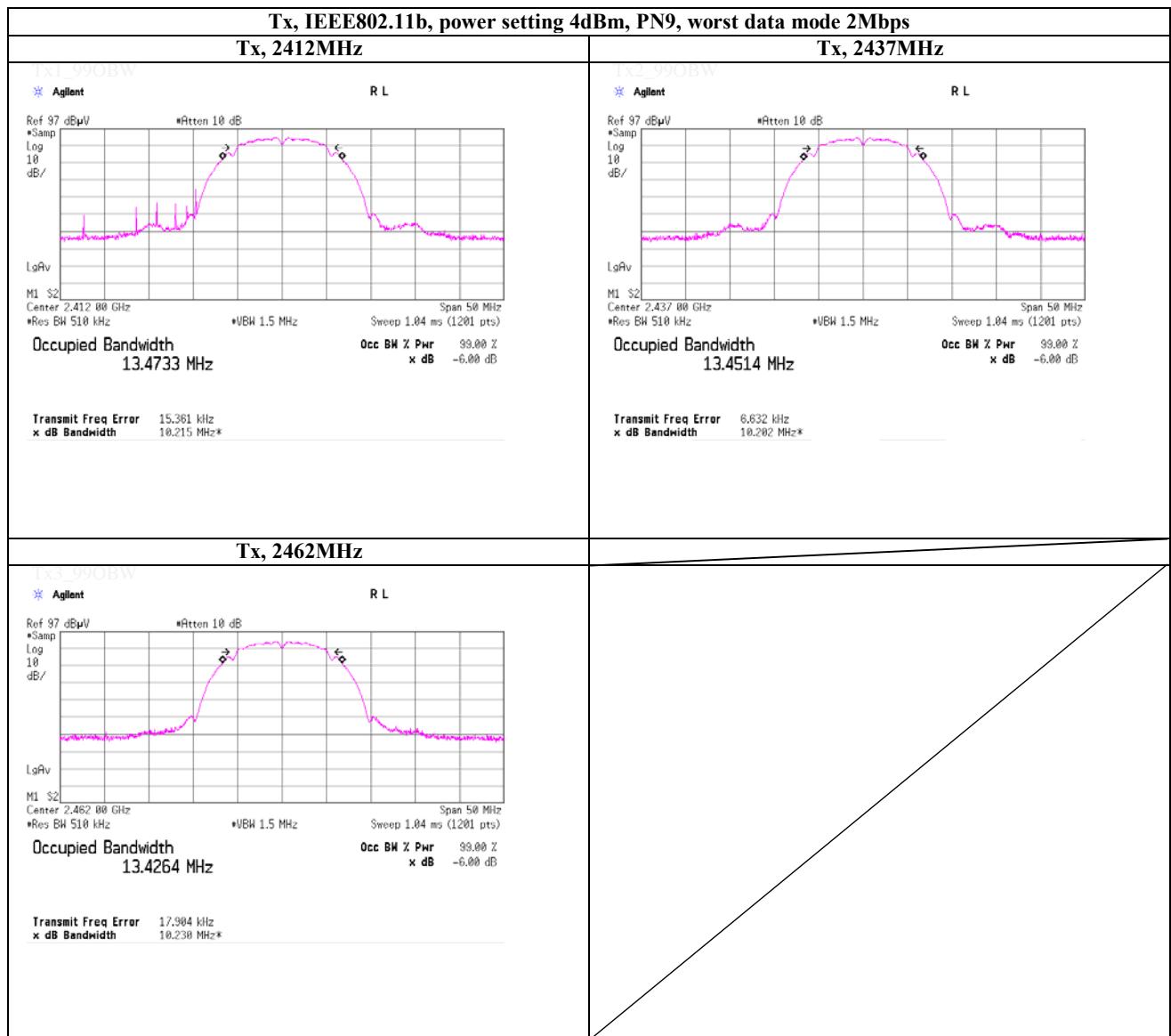
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Test place UL Japan, Inc. Shonan EMC Lab. No.1 Measurement Room
 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
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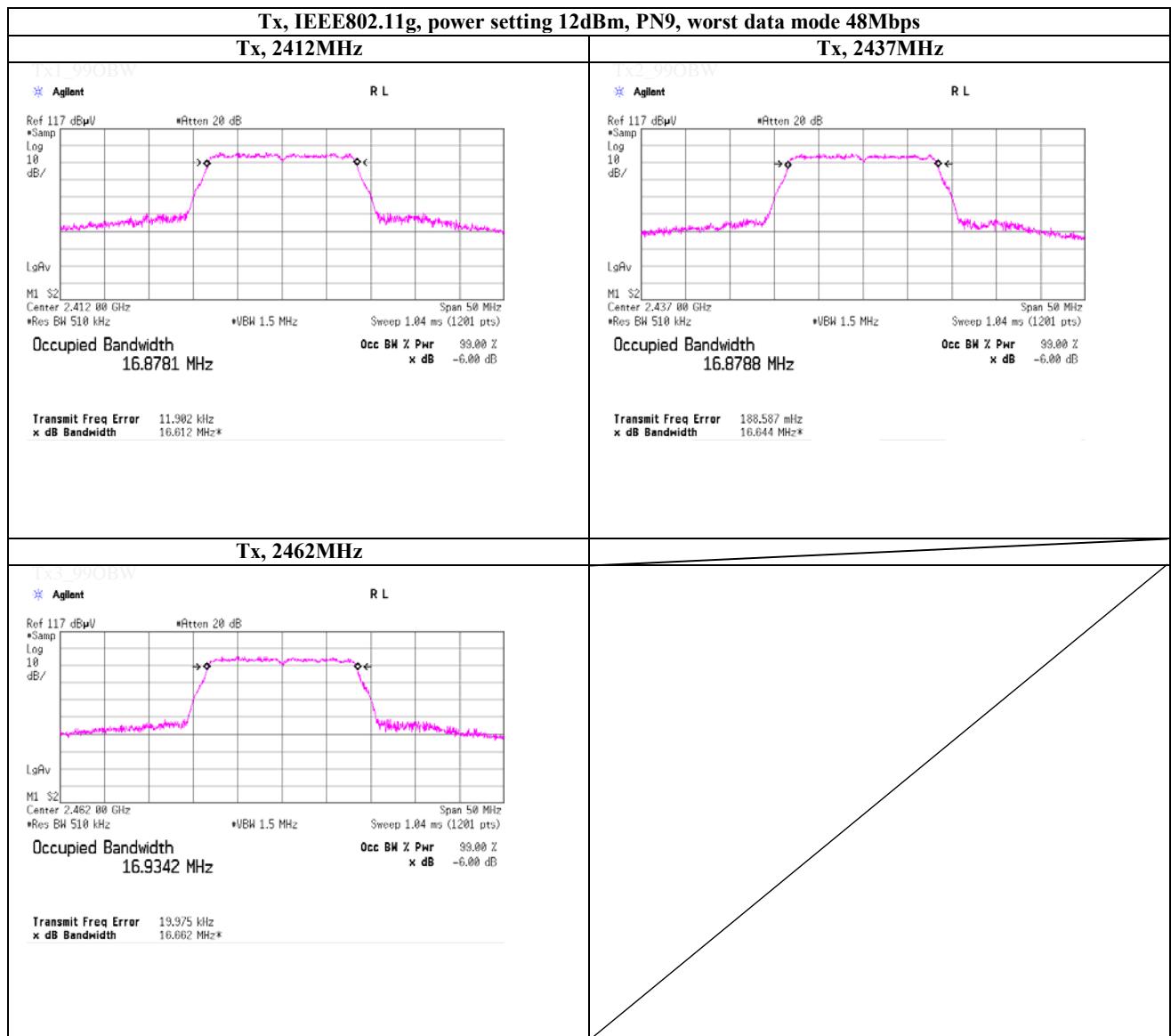
99% Occupied Bandwidth



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 Engineer Akio Hayashi

99% Occupied Bandwidth



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Shonan EMC Lab.

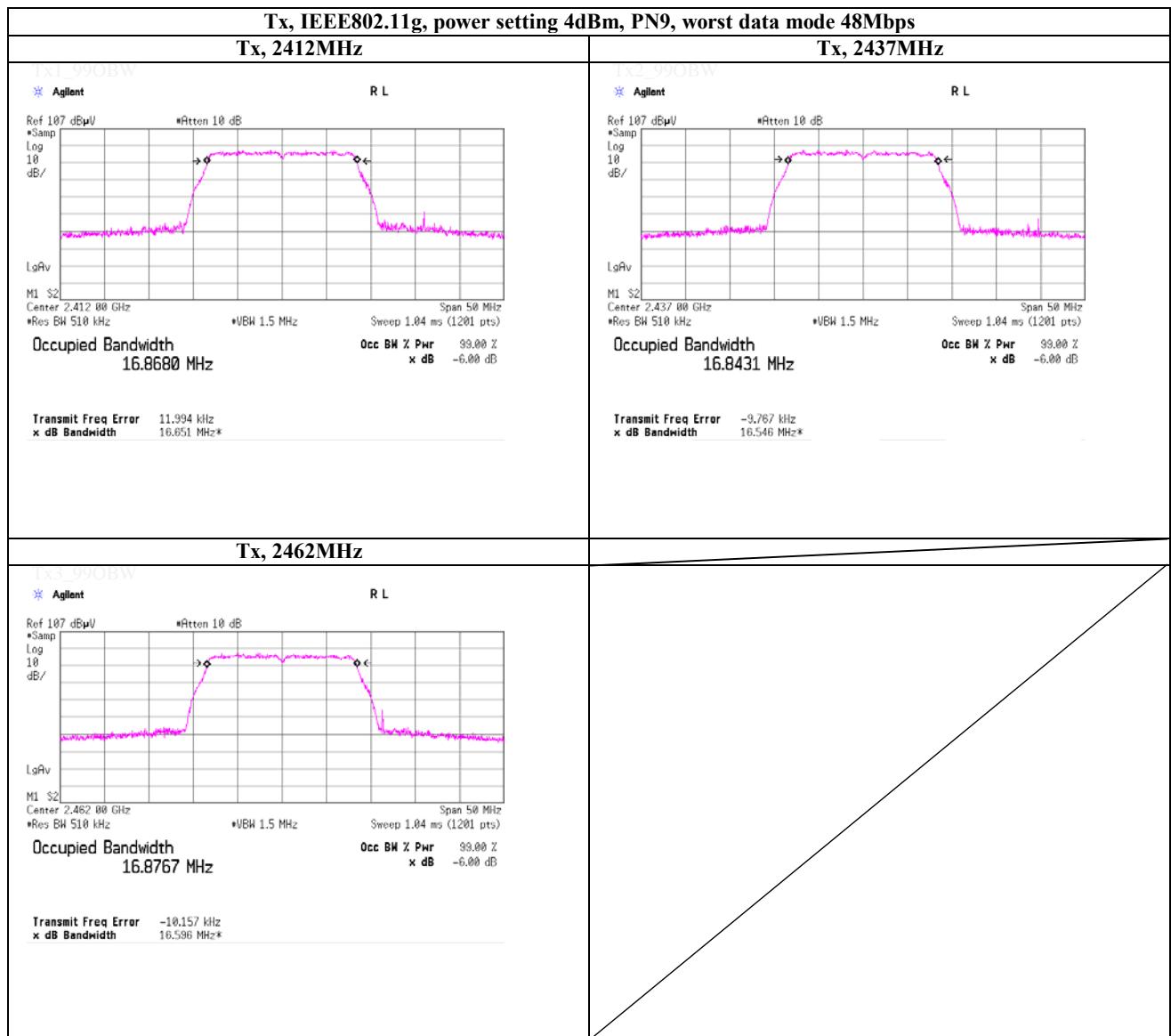
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 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

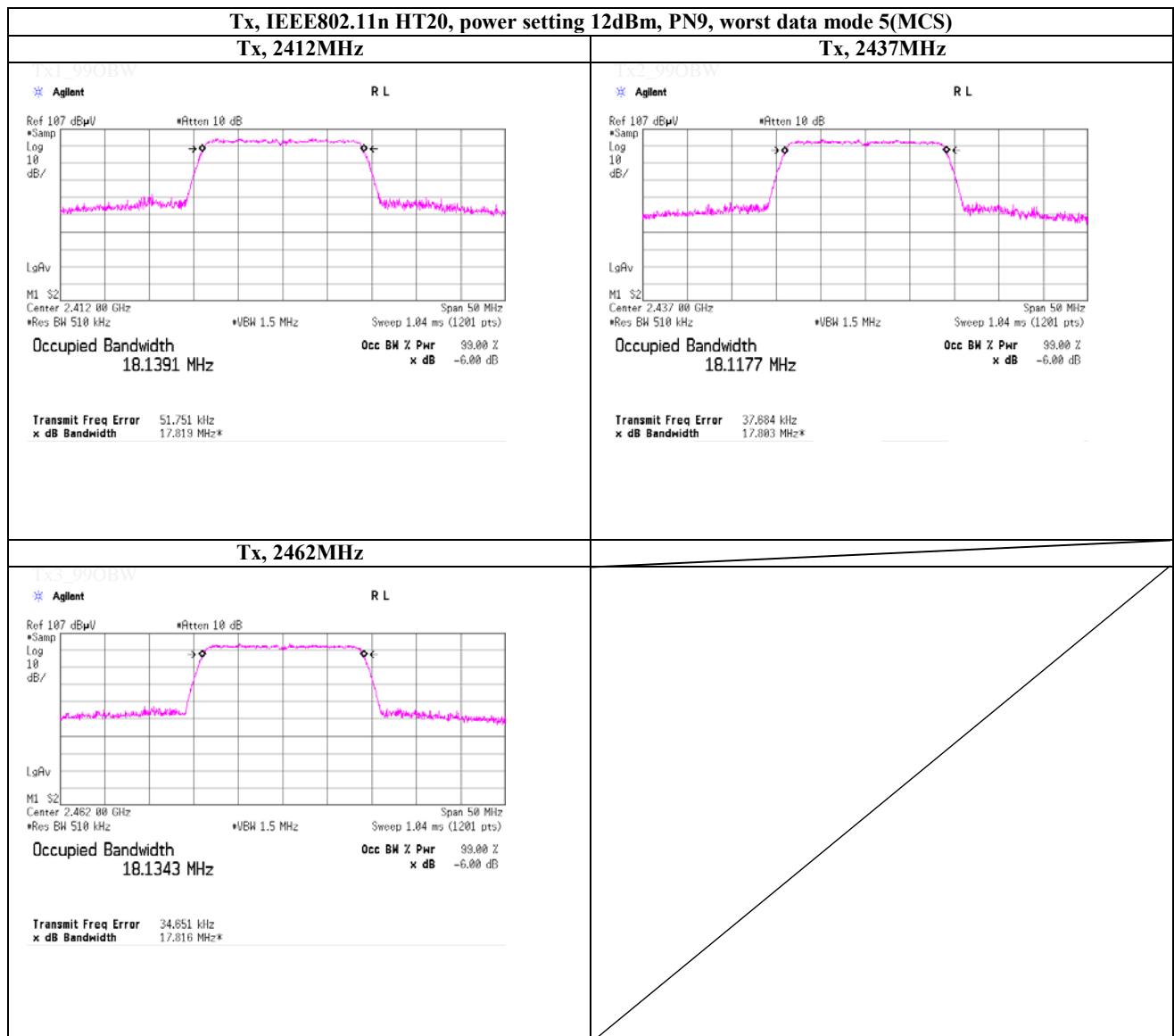
99% Occupied Bandwidth



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 Date October 16, 2014
 Temperature / Humidity 25deg.C , 49%RH
 Engineer Akio Hayashi

99% Occupied Bandwidth



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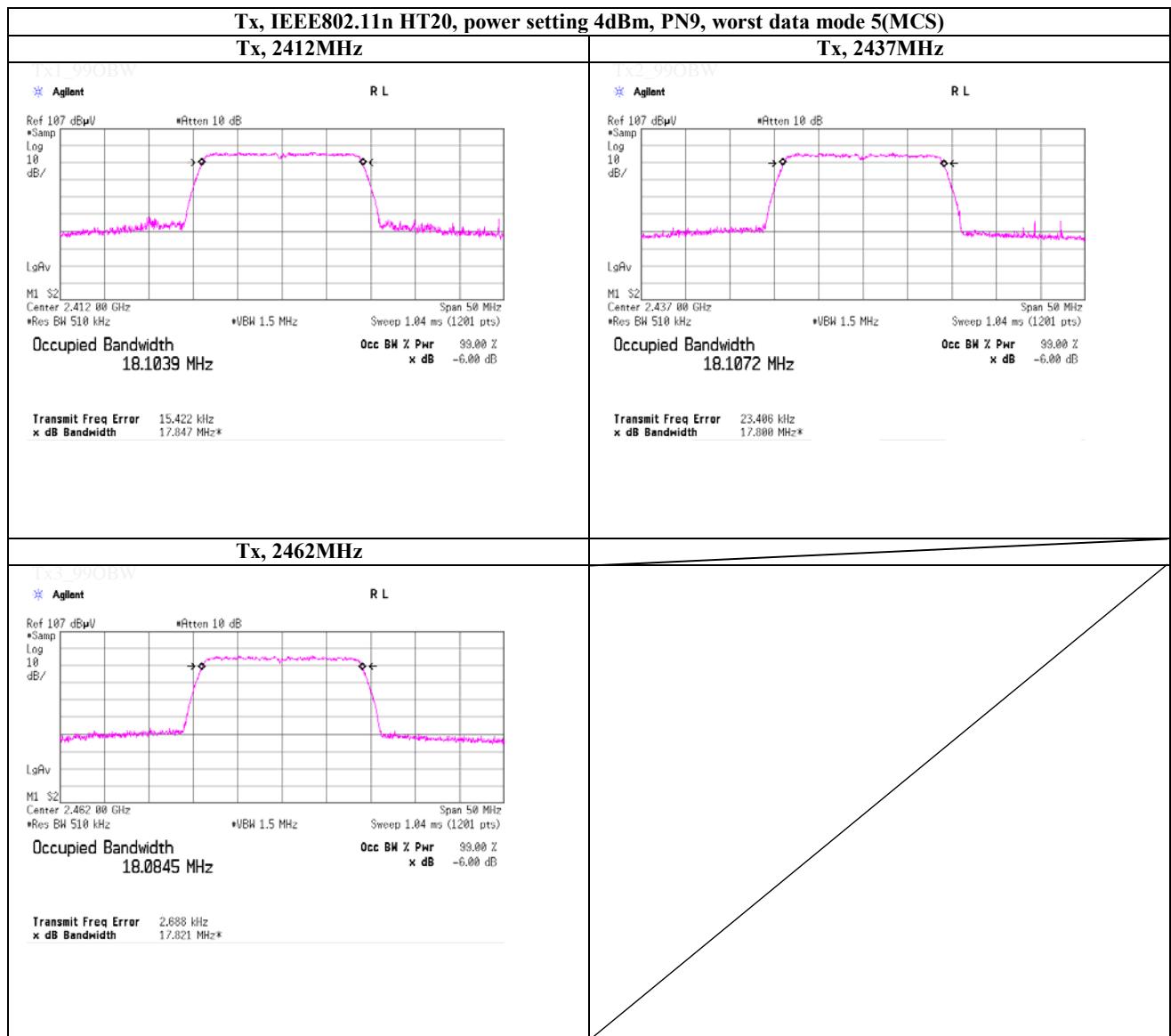
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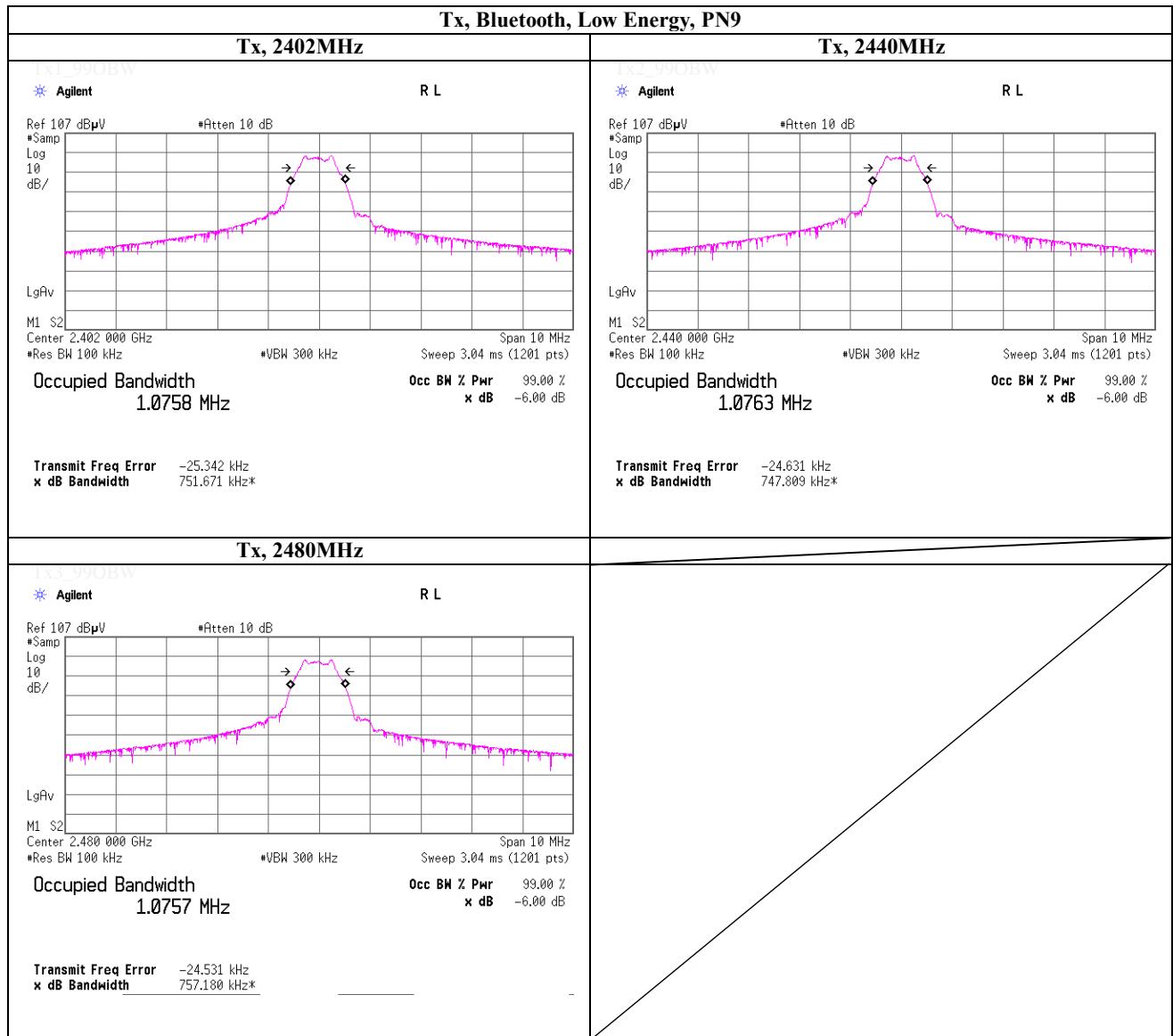
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Test place UL Japan, Inc. Shonan EMC Lab. No.6 Shielded Room
 Date 'October 24, 2014
 Temperature / Humidity 24deg.C , 55%RH
 Engineer Tatsuya Arai

99% Occupied Bandwidth



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Shonan EMC Lab.**

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APPENDIX 2
Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
SSA-03	Spectrum Analyzer	Agilent	E4448A	MY48250152	AT	2014/02/03 * 12
SPM-07	Power Meter	Agilent	8990B	MY5100272	AT	2014/04/04 * 12
SPSS-04	Power sensor	Agilent	N1923A	MY5326009	AT	2014/04/04 * 12
SAT10-10	Attenuator	Weinschel Corp.	54A-10	37584	AT	2014/04/22 * 12
SCC-G14	Coaxial Cable	Suhner	SUCOFLEX 102	31600/2	AT	2014/03/13 * 12
SOS-13	Humidity Indicator	Custom	CTH-202	Q.C.17	AT	2014/04/22 * 12
SAEC-03(NSA)	Semi-Anechoic Chamber	TDK	SAEC-03(NSA)	3	RE	2014/07/14 * 12
SAF-06	Pre Amplifier	TOYO Corporation	TPA0118-36	1440491	RE	2014/05/23 * 12
SCC-G04	Coaxial Cable	Junkosha	J12J102207-00	JUN-12-14-01 8	RE	2014/06/24 * 12
SCC-G23	Coaxial Cable	Suhner	SUCOFLEX 104	297342/4	RE	2014/05/15 * 12
SHA-03	Horn Antenna	Schwarzbeck	BBHA9120D	9120D-739	RE	2014/08/12 * 12
SOS-05	Humidity Indicator	A&D	AD-5681	4062518	RE	2014/02/21 * 12
SSA-01	Spectrum Analyzer	Agilent	N9010A-526	MY48031482	RE	2014/04/07 * 12
SSA-02	Spectrum Analyzer	Agilent	E4448A	MY48250106	RE	2014/03/17 * 12
SJM-15	Measure	ASKUL	-	-	RE	-
COTS-SEMI-1	EMI Software	TSJ	TEPTO-DV(RE,CE, RF,LMF)	-	RE,CE	-
SAT10-06	Attenuator	Agilent	8493C-010	74865	RE	2013/11/22 * 12
SFL-02	Highpass Filter	MICRO-TRONICS	HPM50111	051	RE	2013/11/22 * 12
SHA-04	Horn Antenna	ETS LINDGREN	3160-09	LM3640	RE	2014/03/15 * 12
SAF-08	Pre Amplifier	TOYO Corporation	HAP18-26W	00000019	RE	2014/03/14 * 12
SCC-G15	Coaxial Cable	Suhner	SUCOFLEX 102	32703/2	RE	2014/03/13 * 12
SAEC-02(NSA)	Semi-Anechoic Chamber	TDK	SAEC-02(NSA)	2	RE	2014/07/08 * 12
SBA-02	Biconical Antenna	Schwarzbeck	BBA9106	91032665	RE	2013/11/24 * 12
SAT6-02	Attenuator	JFW	50HF-006N	-	RE	2014/02/17 * 12
SCC-B1/B3/B5/B7/B8/B13/SRSE-02	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhner/Suhner/Suhner/TOYO	8D2W/12DSFA/141PE/141PE/141PE/141PE/NS4906	-/0901-270(RF Selector)	RE	2014/04/25 * 12
SLA-02	Logperiodic Antenna	Schwarzbeck	UHALP9108A	UHALP 9108-A 0893	RE	2013/11/24 * 12
KAT3-11	Attenuator	JFW IND. INC.	50HF-003N	-	RE	2014/08/27 * 12
SCC-B2/B4/B6/B7/B8/B13/SRSE-02	Coaxial Cable&RF Selector	Fujikura/Fujikura/Suhner/Suhner/Suhner/TOYO	8D2W/12DSFA/141PE/141PE/141PE/141PE/NS4906	-/0901-270(RF Selector)	RE	2014/04/25 * 12
SAF-02	Pre Amplifier	SONOMA	310N	290212	RE	2014/02/17 * 12
STR-07	Test Receiver	Rohde & Schwarz	ESU26	100484	RE	2014/09/03 * 12
SOS-03	Humidity Indicator	A&D	AD-5681	4063325	RE	2014/02/21 * 12
SJM-14	Measure	ASKUL	-	-	RE	-
SHA-02	Horn Antenna	Schwarzbeck	BBHA9120D	9120D-726	RE	2014/08/12 * 12
SCC-G02	Coaxial Cable	Suhner	SUCOFLEX 104A	46498/4A	RE	2014/04/22 * 12
SAT10-05	Attenuator(above1GHz)	Agilent	8493C-010	74864	RE	2013/11/22 * 12
SFL-18	Highpass Filter	MICRO-TRONICS	HPM50111	119	RE	2014/04/22 * 12
SAF-05	Pre Amplifier	TOYO Corporation	TPA0118-36	1440490	RE	2013/11/22 * 12
SCC-G22	Coaxial Cable	Suhner	SUCOFLEX 104	296199/4	RE	2014/05/15 * 12

The expiration date of the calibration is the end of the expired month .
As for some calibrations performed after the tested dates , those test equipment have been controlled by means of an unbroken chains of calibrations .

All equipment is calibrated with valid calibrations . Each measurement data is traceable to the national or international standards .

Test Item :

CE: Conducted emission ,

RE: Radiated emission ,

AT: Antenna terminal conducted tests

APPENDIX 2
Test Instruments
EMS test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
SCC-A12/A13 /SRSE-01	Coaxial Cable&RF Selector	Suhner/Suhner/TOYO	RG223U/141PE/N S4906	~0901-269(CE RF Selector)	CE	2014/04/25 * 12
SLS-01	LISN	Rohde & Schwarz	ENV216	100511	CE	2014/02/14 * 12
SAT3-06	Attenuator	JFW	50HF-003N	-	CE	2014/02/17 * 12
SOS-02	Humidity Indicator	A&D	AD-5681	4063343	CE	2014/03/07 * 12
STR-01	Test Receiver	Rohde & Schwarz	ESU40	100093	CE	2013/11/20 * 12
SJM-13	Measure	ASKUL	-	-	CE	-

The expiration date of the calibration is the end of the expired month .

As for some calibrations performed after the tested dates , those test equipment have been controlled by means of an unbroken chains of calibrations .

All equipment is calibrated with valid calibrations . Each measurement data is traceable to the national or international standards .

Test Item :

CE: Conducted emission